

TEST REPORT

FCC LTE B14 Test for SM-S931U
Certification

APPLICANT
SAMSUNG Electronics Co., Ltd.

REPORT NO.
HCT-RF-2410-FC010

DATE OF ISSUE
October 29, 2024

Tested by
Jae Ryang Do



Technical Manager
Jong Seok Lee



HCT CO., LTD.
Bongjai Huh
BongJai Huh / CEO

**HCT CO.,LTD.**

2-6, 73, 74, Seoicheon-ro 578beon-gil, Majang-myeon, Icheon-si, Gyeonggi-do, Republic of Korea
Tel. +82 31 645 6300 Fax. +82 31 645 6401

TEST REPORT

REPORT NO.

HCT-RF-2410-FC010

DATE OF ISSUE

October 29, 2024

Additional Model

SM-S931U1

Applicant**SAMSUNG Electronics Co., Ltd.**

129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Rep. of Korea

Product Name

Mobile Phone

Model Name

SM-S931U

Date of Test

August 21, 2024 ~ October 28, 2024

FCC ID

A3LSMS931U

Location of Test

☒ Permanent Testing Lab ☐ On Site Testing

(Address: 74, Seoicheon-ro 578beon-gil, Majang-myeon, Icheon-si, Gyeonggi-do, Republic of Korea)

FCC Classification:

PCS Licensed Transmitter Held to Ear (PCE)

Test Standard Used

FCC Rule Part: § 90

Test Results

PASS

REVISION HISTORY

The revision history for this test report is shown in table.

Revision No.	Date of Issue	Description
0	October 29, 2024	Initial Release

Notice

Content

The measurements shown in this report were made in accordance with the procedures specified in CFR47 section § 2.947. I assume full responsibility for the accuracy and completeness of these measurements, and for the qualifications of all persons taking them.

HCT CO., LTD. Certifies that no party to this application has subject to a denial of Federal benefits that includes FCC benefits pursuant to section 5301 of the Anti-Drug Abuse Act of 1998, 21 U.S. C. 853(a)

The results shown in this test report only apply to the sample(s), as received, provided by the applicant, unless otherwise stated.

The test results have only been applied with the test methods required by the standard(s).

The laboratory is not accredited for the test results marked *.

Information provided by the applicant is marked **.

Test results provided by external providers are marked ***.

When confirmation of authenticity of this test report is required, please contact www.hct.co.kr

The test results in this test report are not associated with the ((KS Q) ISO/IEC 17025) accreditation by KOLAS (Korea Laboratory Accreditation Scheme) / A2LA (American Association for Laboratory Accreditation) that are under the ILAC (International Laboratory Accreditation Cooperation) Mutual Recognition Agreement (MRA).

CONTENTS

1. GENERAL INFORMATION	6
1.1. MAXIMUM OUTPUT POWER	7
2. INTRODUCTION	8
2.1. DESCRIPTION OF EUT	8
2.2. MEASURING INSTRUMENT CALIBRATION	8
2.3. TEST FACILITY	8
3. DESCRIPTION OF TESTS	9
3.1 TEST PROCEDURE	9
3.2 RADIATED POWER	10
3.3 RADIATED SPURIOUS EMISSIONS	11
3.4 OCCUPIED BANDWIDTH.	12
3.5 SPURIOUS AND HARMONIC EMISSIONS AT ANTENNA TERMINAL	13
3.6 BAND EDGE	14
3.7 FREQUENCY STABILITY / VARIATION OF AMBIENT TEMPERATURE	16
3.8 PEAK- TO- AVERAGE RATIO	17
3.9 WORST CASE(RADIATED TEST)	19
3.10 WORST CASE(CONDUCTED TEST)	20
4. LIST OF TEST EQUIPMENT	21
5. MEASUREMENT UNCERTAINTY	22
6. SUMMARY OF TEST RESULTS	23
7. SAMPLE CALCULATION	24
8. TEST DATA(Main 1 ANT)	26
8.1 EFFECTIVE RADIATED POWER	26
8.2 RADIATED SPURIOUS EMISSIONS	27
8.3 PEAK-TO-AVERAGE RATIO	30
8.4 OCCUPIED BANDWIDTH	31
8.5 CONDUCTED SPURIOUS EMISSIONS	32
8.6 BAND EDGE	32
8.7 FREQUENCY STABILITY / VARIATION OF AMBIENT TEMPERATURE	33
9. TEST DATA(Sub 1 ANT)	37
9.1 EFFECTIVE RADIATED POWER	37
9.2 RADIATED SPURIOUS EMISSIONS	38
9.3 PEAK-TO-AVERAGE RATIO	41
9.4 OCCUPIED BANDWIDTH	42
9.5 CONDUCTED SPURIOUS EMISSIONS	43
9.6 BAND EDGE	43

9.7 FREQUENCY STABILITY / VARIATION OF AMBIENT TEMPERATURE	44
10 TEST PLOTS(Main 1 ANT)	48
11 TEST PLOTS(Sub 1 ANT).....	85
12. ANNEX A_ TEST SETUP PHOTO	122

MEASUREMENT REPORT

1. GENERAL INFORMATION

Applicant Name:	SAMSUNG Electronics Co., Ltd.
Address:	129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Rep. of Korea
FCC ID:	A3LSMS931U
Application Type:	Certification
FCC Classification:	PCS Licensed Transmitter Held to Ear (PCE)
FCC Rule Part(s):	§ 90
EUT Type:	Mobile Phone
Model(s):	SM-S931U
Additional Model(s)	SM-S931U1
Tx Frequency:	790.5 MHz – 795.5 MHz (LTE – BAND 14 (5MHz)) 793.0 MHz (LTE – BAND 14 (10 MHz))
Date(s) of Tests:	August 21, 2024 ~ October 28, 2024
Serial number:	Radiated : R3CXA0930NH Conducted : R3CX80PDM0T

1.1. MAXIMUM OUTPUT POWER

Main 1 ANT

Mode (MHz)	Tx Frequency (MHz)	Emission Designator	Modulation	ERP	
				Max. Power (W)	Max. Power (dBm)
LTE – Band14 (5)	790.5 –795.5	4M51G7D	QPSK	0.065	18.11
		4M52W7D	16QAM	0.055	17.38
		4M51W7D	64QAM	0.042	16.26
		4M53W7D	256QAM	0.020	13.08
LTE – Band14 (10)	793.0	9M03G7D	QPSK	0.062	17.90
		9M02W7D	16QAM	0.051	17.06
		9M01W7D	64QAM	0.040	15.98
		8M98W7D	256QAM	0.019	12.80

Sub 1 ANT

Mode (MHz)	Tx Frequency (MHz)	Emission Designator	Modulation	ERP	
				Max. Power (W)	Max. Power (dBm)
LTE – Band14 (5)	790.5 –795.5	4M52G7D	QPSK	0.089	19.50
		4M54W7D	16QAM	0.078	18.91
		4M53W7D	64QAM	0.060	17.75
		4M50W7D	256QAM	0.027	14.37
LTE – Band14 (10)	793.0	8M99G7D	QPSK	0.087	19.38
		9M02W7D	16QAM	0.072	18.59
		9M00W7D	64QAM	0.056	17.46
		9M00W7D	256QAM	0.027	14.30

2. INTRODUCTION

2.1. DESCRIPTION OF EUT

The EUT was a Mobile Phone with GSM/GPRS/EGPRS/UMTS and LTE, Sub 6, mmWave. It also supports IEEE 802.11 a/b/g/n/ac/ax/be (20/40/80/160/320 MHz), Bluetooth(iPA, ePA), BT LE(iPA, ePA), NFC, WPT, WIFI 6E.

2.2. MEASURING INSTRUMENT CALIBRATION

The measuring equipment, which was utilized in performing the tests documented herein, has been calibrated in accordance with the manufacturer's recommendations for utilizing calibration equipment, which is traceable to recognized national standards.

2.3. TEST FACILITY

The Fully-anechoic chamber and conducted measurement facility used to collect the radiated data are located at the **74, Seoicheon-ro 578beon-gil, Majang-myeon, Icheon-si, Gyeonggi-do, Republic of Korea**

3. DESCRIPTION OF TESTS

3.1 TEST PROCEDURE

Test Description	Test Procedure Used
Occupied Bandwidth	- KDB 971168 D01 v03r01 – Section 4.3 - ANSI C63.26-2015 – Section 5.4.4
Band Edge	- KDB 971168 D01 v03r01 – Section 6.0 - ANSI C63.26-2015 – Section 5.7
Spurious and Harmonic Emissions at Antenna Terminal	- KDB 971168 D01 v03r01 – Section 6.0 - ANSI C63.26-2015 – Section 5.7
Peak- to- Average Ratio	- KDB 971168 D01 v03r01 – Section 5.7 - ANSI C63.26-2015 – Section 5.2.3.4
Conducted Output Power	- N/A (See SAR Report)
Frequency stability	- ANSI C63.26-2015 – Section 5.6
Effective Radiated Power/ Effective Isotropic Radiated Power	- KDB 971168 D01 v03r01 – Section 5.2 & 5.8 - ANSI/TIA-603-E-2016 – Section 2.2.17
Radiated Spurious and Harmonic Emissions	- KDB 971168 D01 v03r01 – Section 6.2 - ANSI/TIA-603-E-2016 – Section 2.2.12

3.2 RADIATED POWER

Test Overview

Radiated tests are performed in the Fully-anechoic chamber.

The equipment under test is placed on a non-conductive table 3-meters away from the receive antenna in accordance with ANSI/TIA-603-E-2016 Clause 2.2.17.

Test Settings

1. Radiated power measurements are performed using the signal analyzer's "channel power" measurement capability for signals with continuous operation.
2. RBW = 1 – 5 % of the expected OBW, not to exceed 1 MHz
3. VBW $\geq$ 3 x RBW
4. Span = 1.5 times the OBW
5. No. of sweep points > 2 x span / RBW
6. Detector = RMS
7. Trigger is set to "free run" for signals with continuous operation with the sweep times set to "auto".
8. The integration bandwidth was roughly set equal to the measured OBW of the signal for signals with continuous operation.
9. Trace mode = trace averaging (RMS) over 100 sweeps
10. The trace was allowed to stabilize

Test Note

1. The turntable is rotated through 360 degrees, and the receiving antenna scans in order to determine the level of the maximized emission.
2. A half wave dipole is then substituted in place of the EUT. For emissions above 1 GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator and the previously recorded signal was duplicated.

The power is calculated by the following formula;

$$P_d \text{ (dBm)} = P_g \text{ (dBm)} - \text{cable loss (dB)} + \text{antenna gain (dB)}$$

Where: P_d is the dipole equivalent power and P_g is the generator output power into the substitution antenna.

3. The maximum value is calculated by adding the forward power to the calibrated source plus its appropriate gain value.
These steps are repeated with the receiving antenna in both vertical and horizontal polarization. the difference between the gain of the horn and an isotropic antenna are taken into consideration
4. The EUT was tested in three orthogonal planes(X, Y, Z) and in all possible test configurations and positioning.
5. All measurements are performed as RMS average measurements while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies.

3.3 RADIATED SPURIOUS EMISSIONS

Test Overview

Radiated tests are performed in the Fully-anechoic chamber.

Radiated Spurious Emission Measurements at 3 meters by Substitution Method according to ANSI/TIA-603-E-2016.

Test Settings

1. RBW = 100 kHz for emissions below 1 GHz and 1 MHz for emissions above 1 GHz
2. VBW $\geq 3 \times$ RBW
3. Span = 1.5 times the OBW
4. No. of sweep points $> 2 \times$ span / RBW
5. Detector = Peak
6. Trace mode = Max Hold
7. The trace was allowed to stabilize
8. Test channel : Low/ Middle/ High
9. Frequency range : We are performed all frequency to 10th harmonics from 9 kHz.

Test Note

1. Measurements value show only up to 3 maximum emissions noted, or would be lesser if no specific emissions from the EUT are recorded (ie: margin > 20 dB from the applicable limit) and considered that's already beyond the background noise floor.
2. The EUT was tested in three orthogonal planes(X, Y, Z) and in all possible test configurations and positioning. The worst case emissions are reported with the EUT positioning, modulations, RB sizes and offsets, and channel bandwidth configurations shown in the test data
3. For spurious emissions above 1 GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator and the previously recorded signal was duplicated. The spurious emissions is calculated by the following formula;

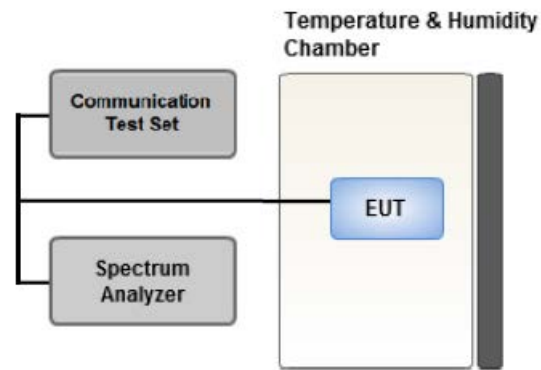
$$\text{Result}_{(\text{dBm})} = P_g_{(\text{dBm})} - \text{cable loss}_{(\text{dB})} + \text{antenna gain}_{(\text{dBi})}$$

Where: P_g is the generator output power into the substitution antenna.

If the fundamental frequency is below 1 GHz, RF output power has been converted to EIRP.

$$\text{EIRP}_{(\text{dBm})} = \text{ERP}_{(\text{dBm})} + 2.15$$

3.4 OCCUPIED BANDWIDTH.



Test setup

The width of a frequency band such that, below the lower and above the upper frequency limits, the mean powers emitted are each equal to a specified percentage 0.5 % of the total mean power of a given emission.

The EUT makes a call to the communication simulator.

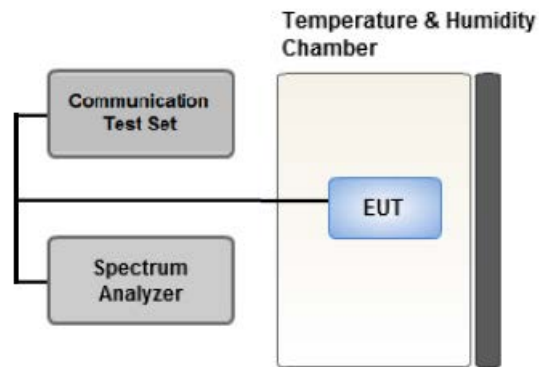
The conducted occupied bandwidth used the power splitter via EUT RF power connector between simulation base station and spectrum analyzer.

The communication simulator station system controlled a EUT to export maximum output power under transmission mode and specific channel frequency. Use OBW measurement function of Spectrum analyzer to measure 99 % occupied bandwidth

Test Settings

1. The signal analyzer's automatic bandwidth measurement capability was used to perform the 99 % occupied bandwidth and the 26 dB bandwidth. The bandwidth measurement was not influenced by any intermediate power nulls in the fundamental emission.
2. RBW = 1 – 5 % of the expected OBW
3. VBW $\geq 3 \times$ RBW
4. Detector = Peak
5. Trace mode = max hold
6. Sweep = auto couple
7. The trace was allowed to stabilize
8. If necessary, steps 2 – 7 were repeated after changing the RBW such that it would be within 1 – 5 % of the 99 % occupied bandwidth observed in Step 7

3.5 SPURIOUS AND HARMONIC EMISSIONS AT ANTENNA TERMINAL



Test setup

Test Overview

The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic.

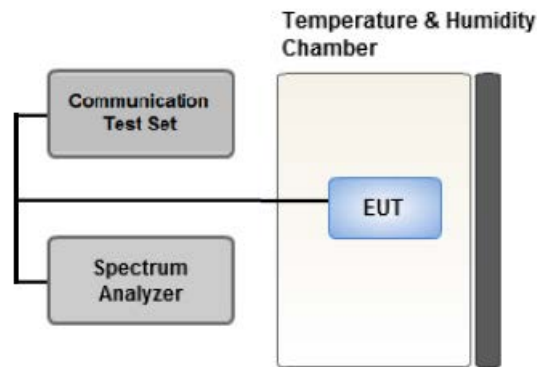
All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies.

All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

Test Settings

1. RBW = 1 MHz
2. VBW $\geq$ 3 MHz
3. Detector = RMS
4. Trace Mode = trace average
5. Sweep time = auto
6. Number of points in sweep $\geq$ 2 x Span / RBW

3.6 BAND EDGE



Test setup

Test Overview

All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

Test Settings

1. Start and stop frequency were set such that the band edge would be placed in the center of the plot
2. Span was set large enough so as to capture all out of band emissions near the band edge
3. RBW > 1 % of the emission bandwidth
4. VBW > 3 x RBW
5. Detector = RMS
6. Number of sweep points $\geq 2 \times \text{Span/RBW}$
7. Trace mode = trace average
8. Sweep time = auto couple
9. The trace was allowed to stabilize

Test Notes

§ 90.543(e)

1. On all frequencies between 769-775 MHz and 799-805 MHz, by a factor not less than $76 + 10 \log (P)$ dB in a 6.25 kHz band segment, for base and fixed stations.
2. On all frequencies between 769-775 MHz and 799-805 MHz, by a factor not less than $65 + 10 \log (P)$ dB in a 6.25 kHz band segment, for mobile and portable stations.
3. On any frequency between 775-788 MHz, above 805 MHz, and below 758 MHz, by at least $43 + 10 \log (P)$ dB.
4. Compliance with the provisions of paragraphs (e)(1) and (2) of this section is based on the use of measurement instrumentation such that the reading taken with any resolution bandwidth setting should be adjusted to indicate spectral energy in a 6.25 kHz segment.
5. Compliance with the provisions of paragraph (e)(3) of this section is based on the use of measurement instrumentation employing a resolution bandwidth of 100 kHz or greater.
However, in the 100 kHz bands immediately outside and adjacent to the frequency block, a resolution bandwidth of 30 kHz may be employed.

Test Notes

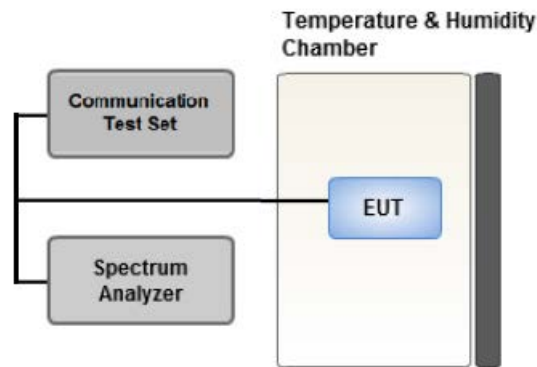
According to FCC 22.917, 24.238, 27.53 specified that power of any emission outside of The authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least $43 + 10 \log (P)$ dB. In the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed.

All measurements were done at 2 channels(low and high operational frequency range.)

The band edge measurement used the power splitter via EUT RF power connector between simulation base station and spectrum analyzer.

Where Margin < 1 dB the emission level is either corrected by $10 \log (1 \text{ MHz} / \text{RB})$ or the emission is integrated over a 1 MHz bandwidth to determine the final result. When using the integration method the integration window is either centered on the emission or, for emissions at the band edge, centered by an offset of 500 kHz from the block edge so that the integration window is the 1 MHz adjacent to the block edge.

3.7 FREQUENCY STABILITY / VARIATION OF AMBIENT TEMPERATURE



Test setup

Test Overview

Frequency stability testing is performed in accordance with the guidelines of ANSI C63.26-2015.

The frequency stability of the transmitter is measured by:

1. Temperature:

The temperature is varied from -30 °C to +50 °C in 10 °C increments using an environmental chamber.

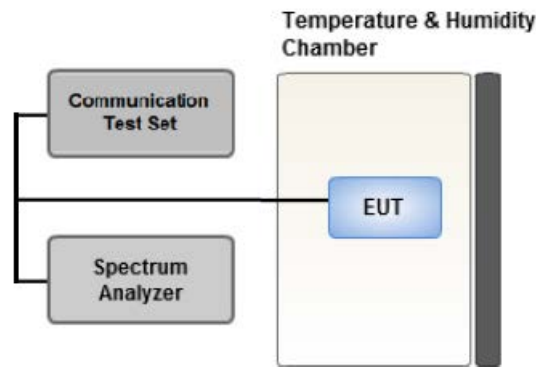
2. Primary Supply Voltage:

- .- Unless otherwise specified, vary primary supply voltage from 85 % to 115 % of the nominal value for other than hand carried battery equipment.
- .- For hand carried, battery powered equipment, reduce the primary ac or dc supply voltage to the battery operating end point, which shall be specified by the manufacturer.

Test Settings

1. The carrier frequency of the transmitter is measured at room temperature (20 °C to provide a reference).
2. The equipment is turned on in a “standby” condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
3. Frequency measurements are made at 10 °C intervals ranging from -30 °C to +50 °C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

3.8 PEAK- TO- AVERAGE RATIO



Test setup

① CCDF Procedure for PAPR

Test Settings

1. Set resolution/measurement bandwidth $\geq$ signal's occupied bandwidth;
2. Set the number of counts to a value that stabilizes the measured CCDF curve;
3. Set the measurement interval as follows:
 - .- for continuous transmissions, set to 1 ms,
 - .- or burst transmissions, employ an external trigger that is synchronized with the EUT burst timing sequence, or use the internal burst trigger with a trigger level that allows the burst to stabilize and set the measurement interval to a time that is less than or equal to the burst duration.
4. Record the maximum PAPR level associated with a probability of 0.1 %.

② Alternate Procedure for PAPR

Use one of the procedures presented in 5.2(ANSI C63.26-2015) to measure the total peak power and record as P_{Pk} .

Use one of the applicable procedures presented 5.2(ANSI C63.26-2015) to measure the total average power and record as P_{Avg} . Determine the P.A.R. from:

$$P.A.R. (dB) = P_{Pk} (dBm) - P_{Avg} (dBm) \quad (P_{Avg} = \text{Average Power} + \text{Duty cycle Factor})$$

Test Settings(Peak Power)

The measurement instrument must have a RBW that is greater than or equal to the OBW of the signal to be measured and a VBW $\geq 3 \times$ RBW.

1. Set the RBW $\geq$ OBW.
2. Set VBW $\geq 3 \times$ RBW.
3. Set span $\geq 2 \times$ OBW.
4. Sweep time $\geq 10 \times$ (number of points in sweep) $\times$ (transmission symbol period).
5. Detector = peak.
6. Trace mode = max hold.
7. Allow trace to fully stabilize.
8. Use the peak marker function to determine the peak amplitude level.

Test Settings(Average Power)

1. Set span to $2 \times$ to $3 \times$ the OBW.
2. Set RBW $\geq$ OBW.
3. Set VBW $\geq 3 \times$ RBW.
4. Set number of measurement points in sweep $\geq 2 \times$ span / RBW.
5. Sweep time:
Set $\geq [10 \times (\text{number of points in sweep}) \times (\text{transmission period})]$ for single sweep (automation-compatible) measurement. The transmission period is the (on + off) time.
6. Detector = power averaging (rms).
7. Set sweep trigger to "free run."
8. Trace average at least 100 traces in power averaging (rms) mode if sweep is set to auto-couple. (To accurately determine the average power over the on and off period of the transmitter, it can be necessary to increase the number of traces to be averaged above 100 or, if using a manually configured sweep time, increase the sweep time.)
9. Use the peak marker function to determine the maximum amplitude level.
10. Add $[10 \log (1/\text{duty cycle})]$ to the measured maximum power level to compute the average power during continuous transmission. For example, add $[10 \log (1/0.25)] = 6 \text{ dB}$ if the duty cycle is a constant 25 %.

3.9 WORST CASE(RADIATED TEST)

- The EUT was tested in three orthogonal planes(X, Y, Z) and in all possible test configurations and positioning.
- All modes of operation were investigated and the worst case configuration results are reported.
Mode : Stand alone, Stand alone + External accessories (Earphone, AC adapter, etc)
Worst case : Stand alone
- All simultaneous transmission scenarios of operation were investigated, and the test results showed no additional significant emissions relative to the least restrictive limit were observed.
Therefore, only the worst case(stand-alone) results were reported.
- The worst case is reported with the EUT positioning, modulations, and paging service configurations shown in the test data
- Please refer to the table below.
- SM-S931U & additional models were tested and the worst case results are reported.
(Worst case : SM-S931U)

[Main 1 ANT Worst case]

Test Description	Modulation	RB size	RB offset	Axis
Effective Radiated Power	QPSK, 16QAM, 64QAM, 256QAM	See Section 8.1		X
Radiated Spurious and Harmonic Emissions	QPSK	See Section 8.2		Y

[Sub 1 ANT Worst case]

Test Description	Modulation	RB size	RB offset	Axis
Effective Radiated Power	QPSK, 16QAM, 64QAM, 256QAM	See Section 9.1		Y
Radiated Spurious and Harmonic Emissions	QPSK	See Section 9.2		Z

3.10 WORST CASE(CONDUCTED TEST)

- All modes of operation were investigated and the worst case configuration results are reported.
 - SM-S931U & additional models were tested and the worst case results are reported.
- (Worst case : SM-S931U)

[Worst case]

Test Description	Modulation	Bandwidth (MHz)	Frequency	RB size	RB offset
Occupied Bandwidth	QPSK, 16QAM, 64QAM, 256QAM	5, 10	Mid	Full RB	0
PEAK- TO- AVERAGE RATIO	QPSK, 16QAM, 64QAM, 256QAM	5, 10	Mid	Full RB	0
Band Edge	QPSK	5	Low	1	0
			High	1	24
		10	Mid	1	0
				1	49
		5	Low, High	Full RB	0
		10	Mid	Full RB	0
Spurious and Harmonic Emissions at Antenna Terminal	QPSK	5	Low, Mid, High	1	0
		10	Mid	1	0

4. LIST OF TEST EQUIPMENT

Equipment	Model	Manufacture	Serial No.	Due to Calibration	Calibration Interval
RF Switching System	Switch box(1.2 G HPF+LNA)	HCT CO., LTD.,	F1L1	08/21/2025	Annual
RF Switching System	Switch box(3.3 G HPF+LNA)	HCT CO., LTD.,	F1L2	08/21/2025	Annual
RF Switching System	Switch box(LNA)	HCT CO., LTD.,	F1L4	08/21/2025	Annual
RF Switching System	Switch box(6 G HPF+LNA)	HCT CO., LTD.,	F1L7	08/21/2025	Annual
Power Splitter(DC ~ 26.5 GHz)	11667B	Hewlett Packard	5001	04/17/2025	Annual
DC Power Supply	E3632A	Agilent	MY40010147	08/06/2025	Annual
Dipole Antenna	UHAP	Schwarzbeck	01274	03/10/2026	Biennial
Dipole Antenna	UHAP	Schwarzbeck	01288	08/07/2026	Biennial
Chamber	SU-642	ESPEC	93008124	02/19/2025	Annual
Horn Antenna(1 ~ 18 GHz)	BBHA 9120D	Schwarzbeck	147	08/17/2025	Biennial
Horn Antenna(1 ~ 18 GHz)	BBHA 9120D	Schwarzbeck	9120D-1298	09/11/2025	Biennial
Horn Antenna(15 ~ 40 GHz)	BBHA 9170	Schwarzbeck	BBHA9170342	09/20/2026	Biennial
Horn Antenna(15 ~ 40 GHz)	BBHA 9170	Schwarzbeck	BBHA9170124	03/28/2025	Biennial
Signal Analyzer(10 Hz ~ 26.5 GHz)	N9020A	Agilent	MY52090906	04/19/2025	Annual
ATTENUATOR(20 dB)	8493C	Hewlett Packard	17280	04/17/2025	Annual
Spectrum Analyzer(10 Hz ~ 40 GHz)	FSV40	REOHDE & SCHWARZ	100931	08/06/2025	Annual
Base Station	8960 (E5515C)	Agilent	MY48360800	08/05/2025	Annual
Loop Antenna(9 kHz ~ 30 MHz)	FMZB1513	Schwarzbeck	1513-333	03/07/2026	Biennial
Trilog Broadband Antenna	VULB9168	Schwarzbeck	895	08/28/2026	Biennial
Trilog Broadband Antenna	VULB9168	Schwarzbeck	1135	08/19/2026	Biennial
Wideband Radio Communication Tester	MT8821C	Anritsu Corp.	6262094331	11/17/2024	Annual
Wideband Radio Communication Tester	MT8820C	Anritsu Corp.	6201026545	12/11/2024	Annual
SIGNAL GENERATOR (100 kHz ~ 40 GHz)	SMB100A	REOHDE & SCHWARZ	177633	07/26/2025	Annual
Signal Analyzer(5 Hz ~ 40.0 GHz)	N9030B	KEYSIGHT	MY55480167	05/17/2025	Annual
FCC LTE Mobile Conducted RF Automation Test Software	-	HCT CO., LTD.,	-	-	-

Note:

- Equipment listed above that has a calibration due date during the testing period, the testing is completed before equipment expiration date.
- Especially, all antenna for measurement is calibrated in accordance with the requirements of C63.5 (Version : 2017).

5. MEASUREMENT UNCERTAINTY

The measurement uncertainties shown below were calculated in accordance with the requirements of ANSI C63.4:2014.

All measurement uncertainty values are shown with a coverage factor of $k = 2$ to indicate a 95 % level of confidence. The measurement data shown herein meets or exceeds the U_{CISPR} measurement uncertainty values specified in CISPR 16-4-2 and, thus, can be compared directly to specified limits to determine compliance.

Parameter	Expanded Uncertainty ($\pm$ dB)
Conducted Disturbance (150 kHz ~ 30 MHz)	1.98 (Confidence level about 95 %, $k=2$)
Radiated Disturbance (9 kHz ~ 30 MHz)	4.36 (Confidence level about 95 %, $k=2$)
Radiated Disturbance (30 MHz ~ 1 GHz)	5.70 (Confidence level about 95 %, $k=2$)
Radiated Disturbance (1 GHz ~ 18 GHz)	5.52 (Confidence level about 95 %, $k=2$)
Radiated Disturbance (18 GHz ~ 40 GHz)	5.66 (Confidence level about 95 %, $k=2$)
Radiated Disturbance (Above 40 GHz)	5.58 (Confidence level about 95 %, $k=2$)

6. SUMMARY OF TEST RESULTS

6.1 Test Condition : Conducted Test

Test Description	FCC Part Section(s)	Test Limit	Test Result
Occupied Bandwidth	§ 2.1049	N/A	PASS
Band Edge / Spurious and Harmonic Emissions at Antenna Terminal.	§ 2.1051, § 90.543(e)	< 43 + 10log ₁₀ (P[Watts]) at Band Edge and for all out-of-band emissions	PASS
On all frequencies between 769-775 MHz and 799-805 MHz.	§ 90.543(e)	< 65 + 10log ₁₀ (P[Watts])	PASS (See Note2)
Conducted Output Power	§ 2.1046	N/A	See Note1
Frequency stability / variation of ambient temperature	§ 2.1055, § 90.539(e)	< 2.5 ppm	PASS

Note:

1. See SAR Report
2. Since it was not possible to set the resolution bandwidth to 6.25 kHz with the available equipment, a bandwidth of 10 kHz was used instead to show compliance.

6.2 Test Condition : Radiated Test

Test Description	FCC Part Section(s)	Test Limit	Test Result
Effective Radiated Power	§ 90.542(a)(7)	< 3 Watts max. ERP	PASS
Radiated Spurious and Harmonic Emissions	§ 2.1053, § 90.543(e)	< 43 + 10log ₁₀ (P[Watts]) for all out-of band emissions	PASS
Undesirable Emissions in the 1559 – 1610 MHz band	§ 2.1053, § 90.543(f)	< -70dBW/MHz EIRP (wideband) < -80dBW EIRP (narrowband)	PASS

7. SAMPLE CALCULATION

7.1 ERP Sample Calculation

Ch./ Freq.		Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain (dBd)	C.L	Pol.	ERP	
channel	Freq.(MHz)						W	dBm
128	824.20	-21.37	38.40	-10.61	0.95	H	0.483	26.84

$$\text{ERP} = \text{Substitute LEVEL(dBm)} + \text{Ant. Gain} - \text{CL(Cable Loss)}$$

- 1) The EUT mounted on a non-conductive turntable is 2.5 meter above test site ground level.
- 2) During the test, the turn table is rotated until the maximum signal is found.
- 3) Record the field strength meter's level.
- 4) Replace the EUT with dipole/Horn antenna that is connected to a calibrated signal generator.
- 5) Increase the signal generator output till the field strength meter's level is equal to the item (3).
- 6) The signal generator output level with Ant. Gain and cable loss are the rating of effective radiated power.

7.2 EIRP Sample Calculation

Ch./ Freq.		Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain (dBi)	C.L	Pol.	EIRP	
channel	Freq.(MHz)						W	dBm
20175	1,732.50	-15.75	18.45	9.90	1.76	H	0.456	26.59

$$\text{EIRP} = \text{Substitute LEVEL(dBm)} + \text{Ant. Gain} - \text{CL(Cable Loss)}$$

- 1) The EUT mounted on a non-conductive turntable is 2.5 meter above test site ground level.
- 2) During the test, the turn table is rotated until the maximum signal is found.
- 3) Record the field strength meter's level.
- 4) Replace the EUT with dipole/Horn antenna that is connected to a calibrated signal generator.
- 5) Increase the signal generator output till the field strength meter's level is equal to the item (3).
- 6) The signal generator output level with Ant. Gain and cable loss are the rating of equivalent isotropic radiated power.

7.3. Emission Designator

GSM Emission Designator

Emission Designator = 249KGXW
GSM BW = 249 kHz
G = Phase Modulation
X = Cases not otherwise covered
W = Combination (Audio/Data)

EDGE Emission Designator

Emission Designator = 249KG7W
GSM BW = 249 kHz
G = Phase Modulation
7 = Quantized/Digital Info
W = Combination (Audio/Data)

WCDMA Emission Designator

Emission Designator = 4M17F9W
WCDMA BW = 4.17 MHz
F = Frequency Modulation
9 = Composite Digital Info
W = Combination (Audio/Data)

QPSK Modulation

Emission Designator = 4M48G7D
LTE BW = 4.48 MHz
G = Phase Modulation
7 = Quantized/Digital Info
D = Data transmission; telemetry; telecommand

QAM Modulation

Emission Designator = 4M48W7D
LTE BW = 4.48 MHz
W = Amplitude/Angle Modulated
7 = Quantized/Digital Info
D = Data transmission; telemetry; telecommand

8. TEST DATA(Main 1 ANT)

8.1 EFFECTIVE RADIATED POWER

Freq (MHz)	Mod/ Bandwidth	Modulation	Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain (dBd)	C.L	Pol	Limit	ERP		RB	
								W	W	dBm	Size	Offset
790.5	LTE B14 (5 MHz)	QPSK	-31.41	29.42	-10.29	1.42	H	< 3.00	0.059	17.71	1	0
		16-QAM	-32.62	28.21	-10.29	1.42	H		0.045	16.50		
		64-QAM	-33.68	27.15	-10.29	1.42	H		0.035	15.44		
		256-QAM	-36.50	24.33	-10.29	1.42	H		0.018	12.62		
793.0		QPSK	-31.53	29.55	-10.31	1.42	H		0.061	17.82	1	0
		16-QAM	-32.26	28.82	-10.31	1.42	H		0.051	17.09		
		64-QAM	-33.37	27.71	-10.31	1.42	H		0.040	15.98		
		256-QAM	-36.56	24.52	-10.31	1.42	H		0.019	12.79		
795.5		QPSK	-31.46	29.87	-10.34	1.42	H		0.065	18.11	1	0
		16-QAM	-32.19	29.14	-10.34	1.42	H		0.055	17.38		
		64-QAM	-33.31	28.02	-10.34	1.42	H		0.042	16.26		
		256-QAM	-36.49	24.84	-10.34	1.42	H		0.020	13.08		

Freq (MHz)	Mod/ Bandwidth	Modulation	Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain (dBd)	C.L	Pol	Limit	ERP		RB	
								W	W	dBm	Size	Offset
793.0	LTE B14 (10 MHz)	QPSK	-31.45	29.63	-10.31	1.42	H	< 3.00	0.062	17.90	1	0
		16-QAM	-32.29	28.79	-10.31	1.42	H		0.051	17.06		
		64-QAM	-33.37	27.71	-10.31	1.42	H		0.040	15.98		
		256-QAM	-36.55	24.53	-10.31	1.42	H		0.019	12.80		

8.2 RADIATED SPURIOUS EMISSIONS

MODE: LTE B14
 MODULATION SIGNAL: 5 MHz QPSK
 DISTANCE: 3 meters

Ch	Freq (MHz)	Measured Level (dBm)	Ant. Gain (dBi)	Substitute Level (dBm)	C.L	Pol	Result (dBm)	Limit (dBm)	RB	
									Size	Offset
23305 (790.5)	1 581.0	-49.73	9.04	-67.38	1.98	V	-60.32	-40.00	1	0
	2 371.5	-39.38	10.10	-54.42	2.47	V	-46.79	-13.00		
	3 162.0	-47.24	11.34	-61.03	2.93	H	-52.62	-13.00		
23330 (793.0)	1 586.0	-48.99	9.08	-66.87	1.99	H	-59.78	-40.00	1	0
	2 379.0	-38.88	10.10	-54.05	2.46	V	-46.41	-13.00		
	3 172.0	-48.76	11.38	-62.48	2.90	H	-54.00	-13.00		
23355 (795.5)	1 591.0	-48.60	9.12	-66.70	2.00	H	-59.58	-40.00	1	0
	2 386.5	-39.98	10.10	-55.31	2.46	H	-47.67	-13.00		
	3 182.0	-48.03	11.42	-61.54	2.89	V	-53.01	-13.00		

■ MODE: LTE B14
 ■ MODULATION SIGNAL: 10 MHz QPSK
 ■ DISTANCE: 3 meters

Ch	Freq (MHz)	Measured Level (dBm)	Ant. Gain (dBi)	Substitute Level (dBm)	C.L	Pol	Result (dBm)	Limit (dBm)	RB	
									Size	Offset
23330 (793.0)	1 586.0	-47.95	9.08	-65.83	1.99	H	-58.74	-40.00	1	49
	2 379.0	-39.20	10.10	-54.37	2.46	V	-46.73	-13.00		
	3 172.0	-47.56	11.38	-61.28	2.90	H	-52.80	-13.00		

1559 MHz ~ 1610 MHz BAND

- ▣ OPERATING FREQUENCY: 790.5 MHz, 793.0 MHz, 795.5 MHz
- ▣ MEASURED OUTPUT POWER: 5 MHz QPSK
- ▣ DISTANCE: 3 meters
- ▣ WIDEBAND EMISSION LIMIT: -70 dBW/ MHz (= -40 dBm/ MHz)

Operating Frequency (MHz)	Measured Frequency (MHz)	EMISSION TYPE	Measured Level (dBm)	Ant. Gain (dBi)	Substitute Level (dBm)	C.L	Pol	Result (dBm)	Margin (dB)
790.5	1570.8	Wide Band	-57.25	8.96	-74.91	1.96	H	-67.91	27.91
793.0	1609.5		-57.29	9.30	-75.68	1.99	V	-68.37	28.37
795.5	1579.0		-57.38	9.04	-75.03	1.98	H	-67.97	27.97

Note:

Since the bandwidth of that Spurious emission is greater than 700 Hz, we applied -70 dBW/MHz according to § 27.53(f).

- ▣ OPERATING FREQUENCY: 793.0 MHz
- ▣ MEASURED OUTPUT POWER: 10 MHz QPSK
- ▣ DISTANCE: 3 meters
- ▣ WIDEBAND EMISSION LIMIT: -70 dBW/ MHz (= -40 dBm/ MHz)

Operating Frequency (MHz)	Measured Frequency (MHz)	EMISSION TYPE	Measured Level (dBm)	Ant. Gain (dBi)	Substitute Level (dBm)	C.L	Pol	Result (dBm)	Margin (dB)
793.0	1579.5	Wide Band	-57.34	9.04	-74.99	1.98	V	-67.93	27.93

Note:

Since the bandwidth of that Spurious emission is greater than 700 Hz, we applied -70 dBW/MHz according to § 27.53(f).

8.3 PEAK-TO-AVERAGE RATIO

Band	Band Width	Frequency (MHz)	Modulation	Resource Block Size	Resource Block Offset	Data (dB)
14	5 MHz	793.0	QPSK	25	0	4.42
			16-QAM	25	0	5.33
			64-QAM	25	0	5.98
			256-QAM	25	0	6.46
	10 MHz		QPSK	50	0	4.48
			16-QAM	50	0	5.37
			64-QAM	50	0	5.99
			256-QAM	50	0	6.49

Note:

1. Plots of the EUT's P.A.P.R are shown Page 49 ~ 56.
2. P.A.P.R is not required. These values are reported for information only.

8.4 OCCUPIED BANDWIDTH

Band	Band Width	Frequency (MHz)	Modulation	Resource Block Size	Resource Block Offset	Data (MHz)
14	5 MHz	793.0	QPSK	25	0	4.5062
			16-QAM	25	0	4.5224
			64-QAM	25	0	4.5046
			256-QAM	25	0	4.5309
	10 MHz		QPSK	50	0	9.0321
			16-QAM	50	0	9.0222
			64-QAM	50	0	9.0090
			256-QAM	50	0	8.9802

Note:

1. Plots of the EUT's Occupied Bandwidth are shown Page 57 ~ 64.

8.5 CONDUCTED SPURIOUS EMISSIONS

Band	Band Width (MHz)	Frequency (MHz)	Frequency of Maximum Harmonic (GHz)	Factor (dB)	Measurement Maximum Data (dBm)	Result (dBm)	Limit (dBm)
14	5	790.5	3.1865	27.976	-67.342	-39.366	-13.00
		793.0	3.7034	27.976	-66.830	-38.854	
		795.5	3.7094	27.976	-66.602	-38.626	
	10	793.0	3.7010	27.976	-67.245	-39.269	

Note:

1. Plots of the EUT's Conducted Spurious Emissions are shown Page 65 ~ 68.
2. Conducted Spurious Emissions was Tested QPSK Modulation, Resource Block Size 1 and Resource Block Offset 0
3. Result (dBm) = Measurement Maximum Data (dBm) + Factor (dB)
4. Factor (dB) = Cable Loss + Attenuator + Power Splitter

Frequency Range (GHz)	Factor [dB]
0.03 – 1	25.270
1 – 5	27.976
5 – 10	28.591
10 – 15	29.116
15 – 20	29.489
Above 20(26.5)	30.131

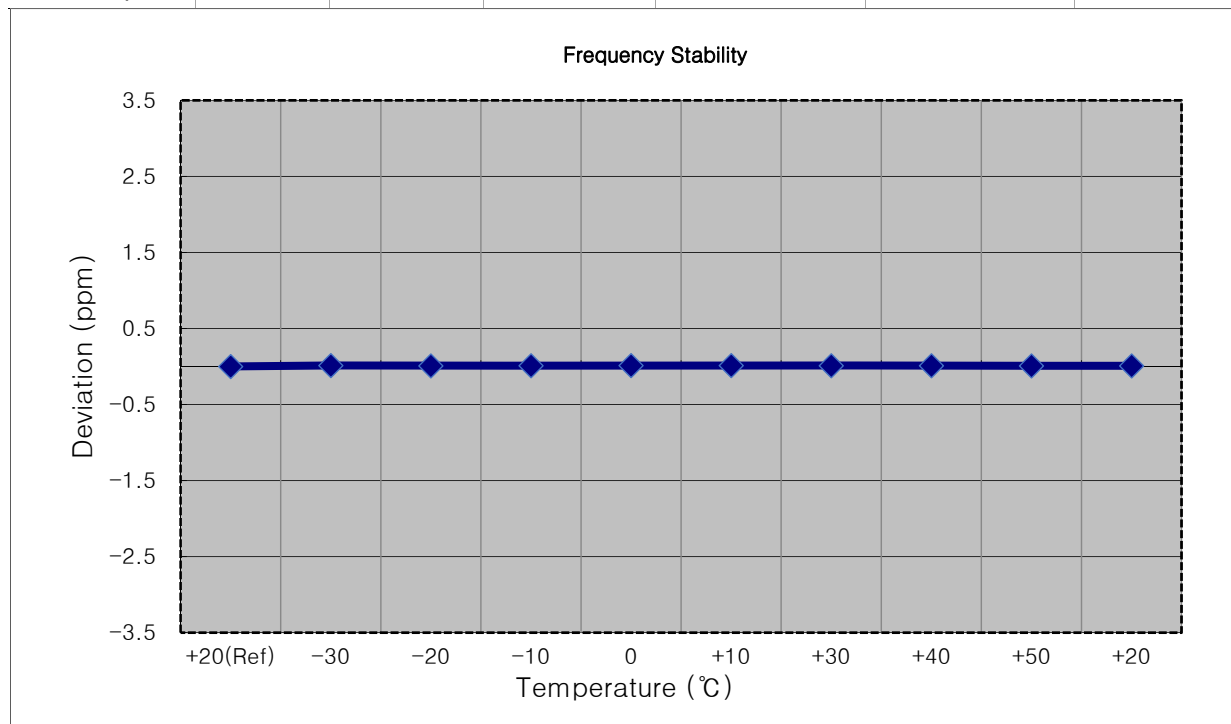
8.6 BAND EDGE

- Plots of the EUT's Band Edge are shown Page 69 ~ 84.

8.7 FREQUENCY STABILITY / VARIATION OF AMBIENT TEMPERATURE

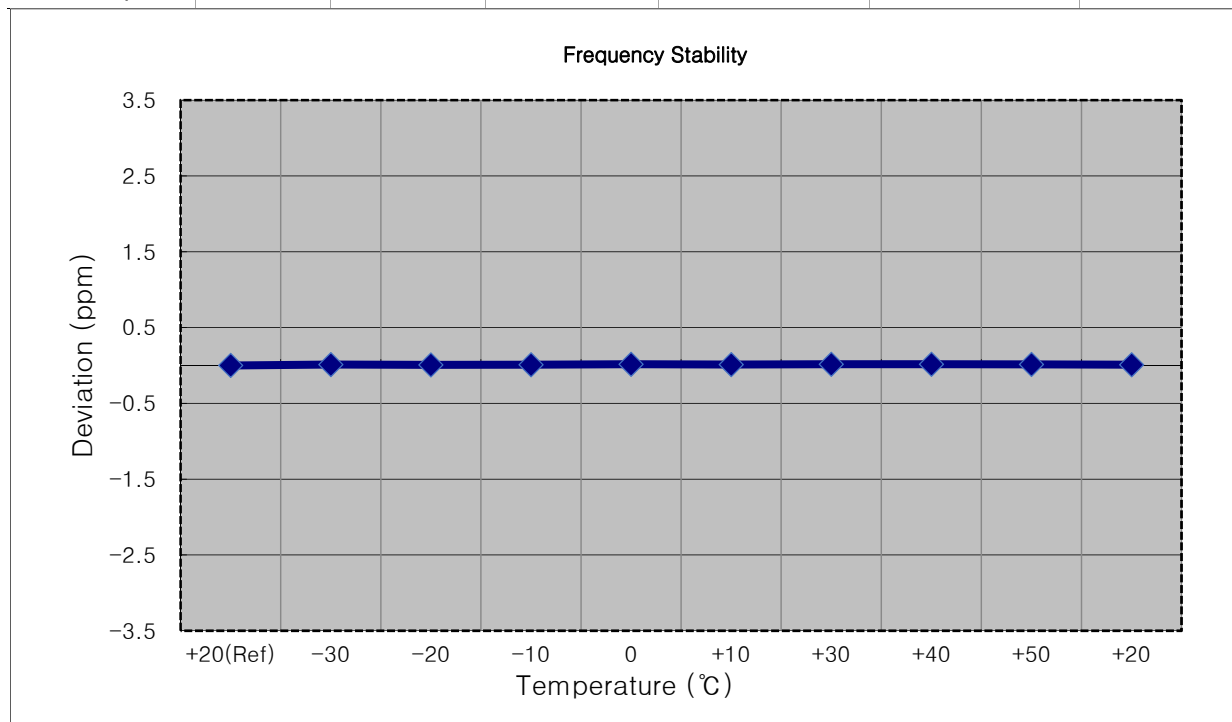
MODE:	<u>LTE 14</u>
OPERATING FREQUENCY:	<u>790,500,000 Hz</u>
CHANNEL:	<u>23305 (5 MHz)</u>
REFERENCE VOLTAGE:	<u>3.880 VDC</u>
DEVIATION LIMIT:	<u>2.5ppm</u>

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(°C)	(Hz)	(Hz)	(%)	
100 %	3.880	+20(Ref)	790 500 013	0.00	0.000 000	0.0000
100 %		-30	790 500 022	9.10	0.000 001	0.0115
100 %		-20	790 500 020	7.20	0.000 001	0.0091
100 %		-10	790 500 020	7.60	0.000 001	0.0096
100 %		0	790 500 022	9.20	0.000 001	0.0116
100 %		+10	790 500 022	9.80	0.000 001	0.0124
100 %		+30	790 500 021	8.60	0.000 001	0.0109
100 %		+40	790 500 021	8.30	0.000 001	0.0105
100 %		+50	790 500 019	6.40	0.000 001	0.0081
Batt. Endpoint	3.300	+20	790 500 019	6.80	0.000 001	0.0086



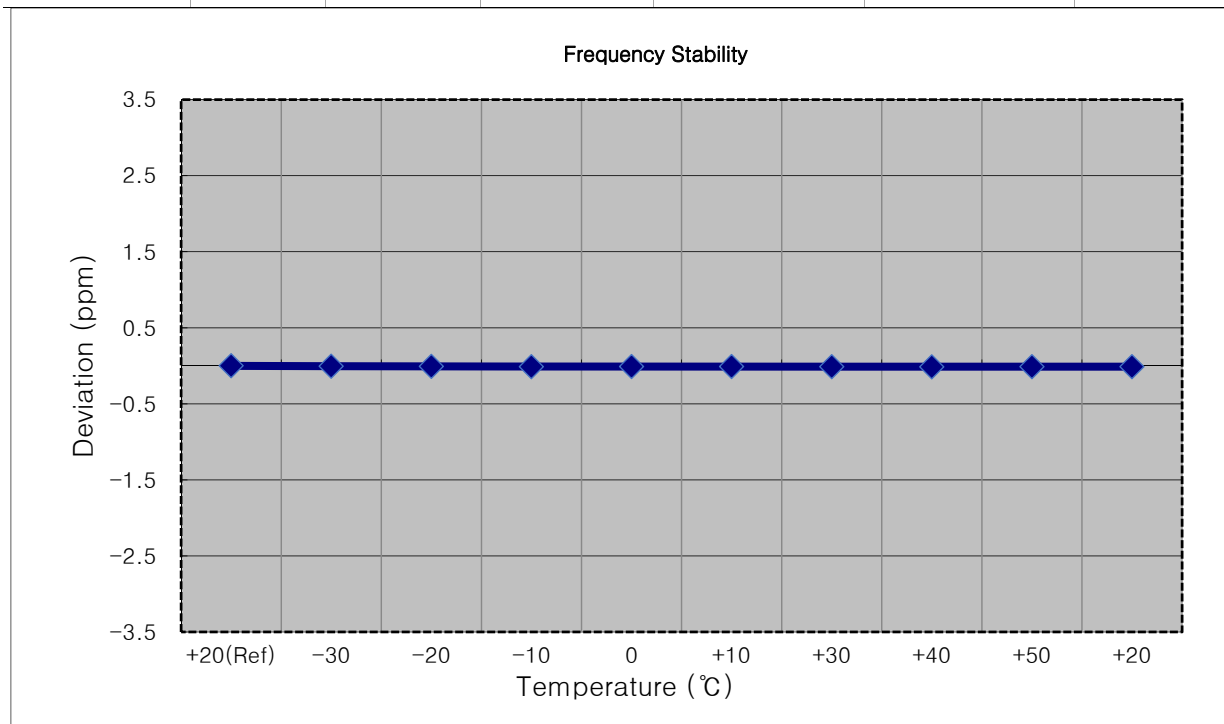
MODE: LTE 14
 OPERATING FREQUENCY: 793,000,000 Hz
 CHANNEL: 23330 (5 MHz)
 REFERENCE VOLTAGE: 3.880 VDC
 DEVIATION LIMIT: 2.5ppm

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(°C)	(Hz)	(Hz)	(%)	
100 %	3.880	+20(Ref)	793 000 010	0.00	0.000 000	0.0000
100 %		-30	793 000 019	8.40	0.000 001	0.0106
100 %		-20	793 000 015	4.50	0.000 001	0.0057
100 %		-10	793 000 017	6.40	0.000 001	0.0081
100 %		0	793 000 022	11.30	0.000 001	0.0142
100 %		+10	793 000 019	8.50	0.000 001	0.0107
100 %		+30	793 000 022	12.00	0.000 002	0.0151
100 %		+40	793 000 022	12.00	0.000 002	0.0151
100 %		+50	793 000 020	9.60	0.000 001	0.0121
Batt. Endpoint	3.300	+20	793 000 018	7.20	0.000 001	0.0091



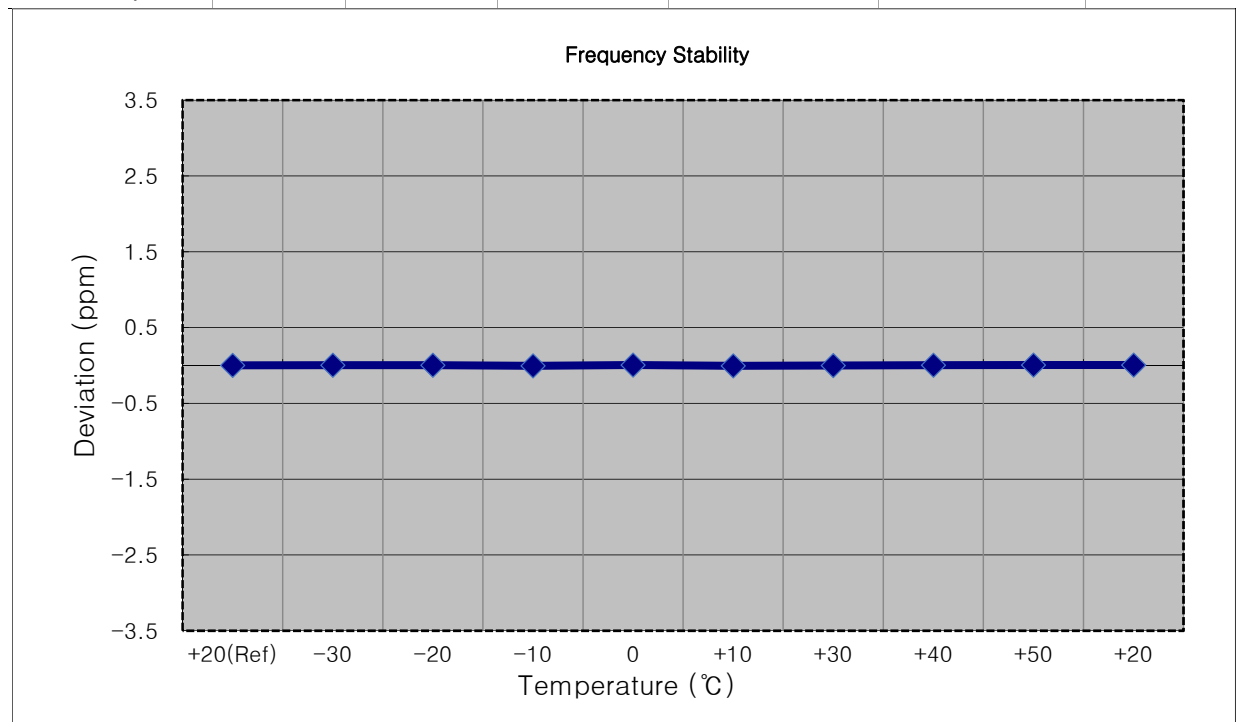
- ▣ MODE: LTE 14
- ▣ OPERATING FREQUENCY: 795,500,000 Hz
- ▣ CHANNEL: 23355 (5 MHz)
- ▣ REFERENCE VOLTAGE: 3.880 VDC
- ▣ DEVIATION LIMIT: 2.5ppm

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(°C)	(Hz)	(Hz)	(%)	
100 %	3.880	+20(Ref)	795 499 991	0.00	0.000 000	0.0000
100 %		-30	795 499 986	-5.30	-0.000 001	-0.0067
100 %		-20	795 499 984	-7.10	-0.000 001	-0.0089
100 %		-10	795 499 981	-9.50	-0.000 001	-0.0119
100 %		0	795 499 983	-7.60	-0.000 001	-0.0096
100 %		+10	795 499 982	-8.60	-0.000 001	-0.0108
100 %		+30	795 499 981	-10.30	-0.000 001	-0.0129
100 %		+40	795 499 980	-10.90	-0.000 001	-0.0137
100 %		+50	795 499 981	-9.70	-0.000 001	-0.0122
Batt. Endpoint	3.300	+20	795 499 981	-9.50	-0.000 001	-0.0119



MODE:	<u>LTE 14</u>
OPERATING FREQUENCY:	<u>793,000,000 Hz</u>
CHANNEL:	<u>23330 (10 MHz)</u>
REFERENCE VOLTAGE:	<u>3.880 VDC</u>
DEVIATION LIMIT:	<u>2.5ppm</u>

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(°C)	(Hz)	(Hz)	(%)	
100 %	3.880	+20(Ref)	792 999 996	0.00	0.000 000	0.0000
100 %		-30	792 999 997	1.70	0.000 000	0.0021
100 %		-20	792 999 998	2.30	0.000 000	0.0029
100 %		-10	792 999 991	-4.30	-0.000 001	-0.0054
100 %		0	792 999 999	3.80	0.000 000	0.0048
100 %		+10	792 999 991	-4.40	-0.000 001	-0.0055
100 %		+30	792 999 994	-1.90	0.000 000	-0.0024
100 %		+40	792 999 997	1.80	0.000 000	0.0023
100 %		+50	792 999 999	3.80	0.000 000	0.0048
Batt. Endpoint	3.300	+20	792 999 999	3.40	0.000 000	0.0043



9. TEST DATA(Sub 1 ANT)

9.1 EFFECTIVE RADIATED POWER

Freq (MHz)	Mod/ Bandwidth	Modulation	Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain (dBd)	C.L	Pol	Limit	ERP		RB	
								W	W	dBm	Size	Offset
790.5	LTE B14 (5 MHz)	QPSK	-29.99	30.84	-10.29	1.42	V	< 3.00	0.082	19.13	1	0
		16-QAM	-30.71	30.12	-10.29	1.42	V		0.069	18.41		
		64-QAM	-31.81	29.02	-10.29	1.42	V		0.054	17.31		
		256-QAM	-35.02	25.81	-10.29	1.42	V		0.026	14.10		
793.0		QPSK	-30.02	31.06	-10.31	1.42	V		0.086	19.33	1	0
		16-QAM	-30.65	30.43	-10.31	1.42	V		0.074	18.70		
		64-QAM	-31.75	29.33	-10.31	1.42	V		0.058	17.60		
		256-QAM	-35.12	25.96	-10.31	1.42	V		0.026	14.23		
795.5		QPSK	-30.07	31.26	-10.34	1.42	V		0.089	19.50	1	0
		16-QAM	-30.66	30.67	-10.34	1.42	V		0.078	18.91		
		64-QAM	-31.82	29.51	-10.34	1.42	V		0.060	17.75		
		256-QAM	-35.20	26.13	-10.34	1.42	V		0.027	14.37		

Freq (MHz)	Mod/ Bandwidth	Modulation	Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain (dBd)	C.L	Pol	Limit	ERP		RB	
								W	W	dBm	Size	Offset
793.0	LTE B14 (10 MHz)	QPSK	-29.97	31.11	-10.31	1.42	V	< 3.00	0.087	19.38	1	0
		16-QAM	-30.76	30.32	-10.31	1.42	V		0.072	18.59		
		64-QAM	-31.89	29.19	-10.31	1.42	V		0.056	17.46		
		256-QAM	-35.05	26.03	-10.31	1.42	V		0.027	14.30		

9.2 RADIATED SPURIOUS EMISSIONS

MODE: LTE B14
 MODULATION SIGNAL: 5 MHz QPSK
 DISTANCE: 3 meters

Ch	Freq (MHz)	Measured Level (dBm)	Ant. Gain (dBi)	Substitute Level (dBm)	C.L	Pol	Result (dBm)	Limit (dBm)	RB	
									Size	Offset
23305 (790.5)	1 581.0	-49.72	9.04	-67.37	1.98	H	-60.31	-40.00	1	0
	2 371.5	-38.56	10.10	-53.60	2.47	H	-45.97	-13.00		
	3 162.0	-49.12	11.34	-62.91	2.93	H	-54.50	-13.00		
23330 (793.0)	1 586.0	-49.75	9.08	-67.63	1.99	H	-60.54	-40.00	1	0
	2 379.0	-39.53	10.10	-54.70	2.46	H	-47.06	-13.00		
	3 172.0	-48.01	11.38	-61.73	2.90	H	-53.25	-13.00		
23355 (795.5)	1 591.0	-49.25	9.12	-67.35	2.00	H	-60.23	-40.00	1	0
	2 386.5	-39.43	10.10	-54.76	2.46	V	-47.12	-13.00		
	3 182.0	-48.38	11.42	-61.89	2.89	H	-53.36	-13.00		

■ MODE: LTE B14
 ■ MODULATION SIGNAL: 10 MHz QPSK
 ■ DISTANCE: 3 meters

Ch	Freq (MHz)	Measured Level (dBm)	Ant. Gain (dBi)	Substitute Level (dBm)	C.L	Pol	Result (dBm)	Limit (dBm)	RB	
									Size	Offset
23330 (793.0)	1 586.0	-48.93	9.08	-66.81	1.99	H	-59.72	-40.00	1	0
	2 379.0	-39.08	10.10	-54.25	2.46	H	-46.61	-13.00		
	3 172.0	-48.75	11.38	-62.47	2.90	H	-53.99	-13.00		

1559 MHz ~ 1610 MHz BAND

- ▣ OPERATING FREQUENCY: 790.5 MHz, 793.0 MHz, 795.5 MHz
- ▣ MEASURED OUTPUT POWER: 5 MHz QPSK
- ▣ DISTANCE: 3 meters
- ▣ WIDEBAND EMISSION LIMIT: -70 dBW/ MHz (= -40 dBm/ MHz)

Operating Frequency (MHz)	Measured Frequency (MHz)	EMISSION TYPE	Measured Level (dBm)	Ant. Gain (dBi)	Substitute Level (dBm)	C.L	Pol	Result (dBm)	Margin (dB)
790.5	1589.4	Wide Band	-57.39	9.12	-75.49	2.00	V	-68.37	28.37
793.0	1578.3		-57.36	9.04	-75.01	1.98	V	-67.95	27.95
795.5	1589.6		-57.45	9.12	-75.55	2.00	V	-68.43	28.43

Note:

Since the bandwidth of that Spurious emission is greater than 700 Hz, we applied -70 dBW/MHz according to § 27.53(f).

- ▣ OPERATING FREQUENCY: 793.0 MHz
- ▣ MEASURED OUTPUT POWER: 10 MHz QPSK
- ▣ DISTANCE: 3 meters
- ▣ WIDEBAND EMISSION LIMIT: -70 dBW/ MHz (= -40 dBm/ MHz)

Operating Frequency (MHz)	Measured Frequency (MHz)	EMISSION TYPE	Measured Level (dBm)	Ant. Gain (dBi)	Substitute Level (dBm)	C.L	Pol	Result (dBm)	Margin (dB)
793.0	1567.4	Wide Band	-57.26	8.96	-74.92	1.96	V	-67.92	27.92

Note:

Since the bandwidth of that Spurious emission is greater than 700 Hz, we applied -70 dBW/MHz according to § 27.53(f).

9.3 PEAK-TO-AVERAGE RATIO

Band	Band Width	Frequency (MHz)	Modulation	Resource Block Size	Resource Block Offset	Data (dB)
14	5 MHz	793.0	QPSK	25	0	4.28
			16-QAM	25	0	5.14
			64-QAM	25	0	5.78
			256-QAM	25	0	6.39
	10 MHz		QPSK	50	0	4.41
			16-QAM	50	0	5.28
			64-QAM	50	0	5.88
			256-QAM	50	0	6.45

Note:

1. Plots of the EUT's P.A.P.R are shown Page 86 ~ 93.
2. P.A.P.R is not required. These values are reported for information only.

9.4 OCCUPIED BANDWIDTH

Band	Band Width	Frequency (MHz)	Modulation	Resource Block Size	Resource Block Offset	Data (MHz)
14	5 MHz	793.0	QPSK	25	0	4.5240
			16-QAM	25	0	4.5387
			64-QAM	25	0	4.5300
			256-QAM	25	0	4.5012
	10 MHz		QPSK	50	0	8.9919
			16-QAM	50	0	9.0149
			64-QAM	50	0	9.0017
			256-QAM	50	0	8.9959

Note:

1. Plots of the EUT's Occupied Bandwidth are shown Page 94 ~ 101.

9.5 CONDUCTED SPURIOUS EMISSIONS

Band	Band Width (MHz)	Frequency (MHz)	Frequency of Maximum Harmonic (GHz)	Factor (dB)	Measurement Maximum Data (dBm)	Result (dBm)	Limit (dBm)
14	5	790.5	3.7064	27.976	-67.022	-39.046	-13.00
		793.0	3.6875	27.976	-66.974	-38.998	
		795.5	3.6860	27.976	-67.205	-39.229	
	10	793.0	3.1865	27.976	-67.248	-39.272	

Note:

1. Plots of the EUT's Conducted Spurious Emissions are shown Page 102 ~ 105.
2. Conducted Spurious Emissions was Tested QPSK Modulation, Resource Block Size 1 and Resource Block Offset 0
3. Result (dBm) = Measurement Maximum Data (dBm) + Factor (dB)
4. Factor (dB) = Cable Loss + Attenuator + Power Splitter

Frequency Range (GHz)	Factor [dB]
0.03 – 1	25.270
1 – 5	27.976
5 – 10	28.591
10 – 15	29.116
15 – 20	29.489
Above 20(26.5)	30.131

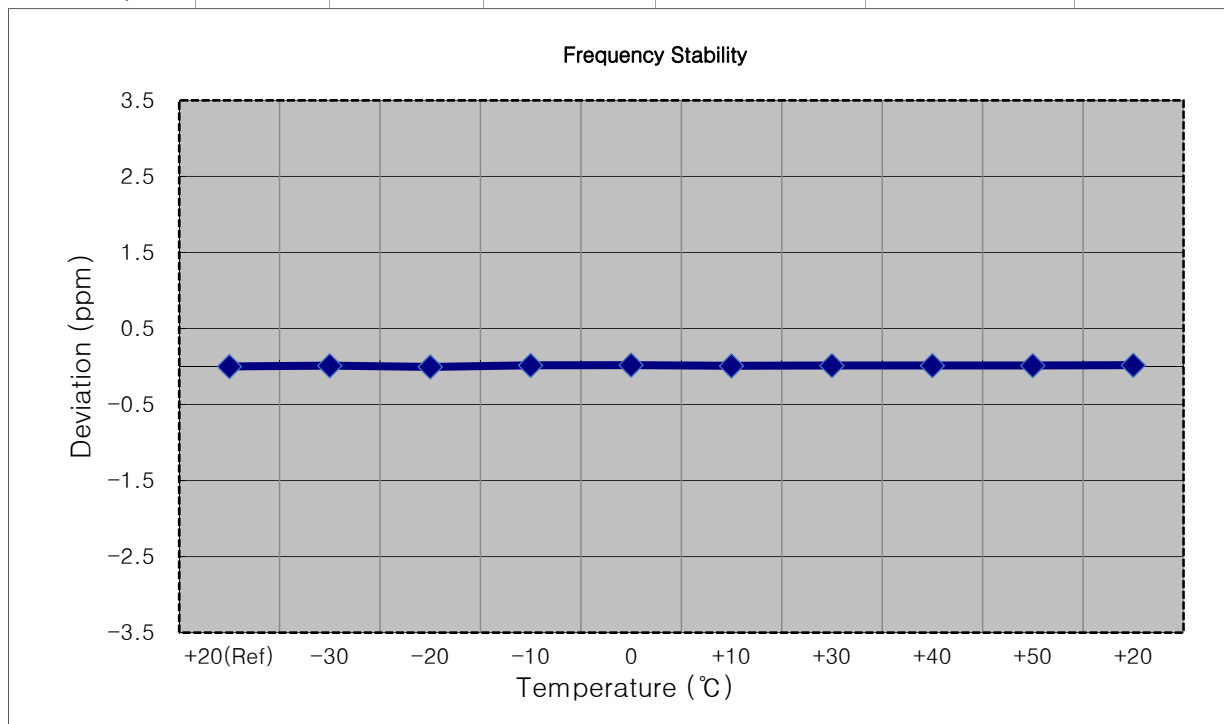
9.6 BAND EDGE

- Plots of the EUT's Band Edge are shown Page 106 ~ 121.

9.7 FREQUENCY STABILITY / VARIATION OF AMBIENT TEMPERATURE

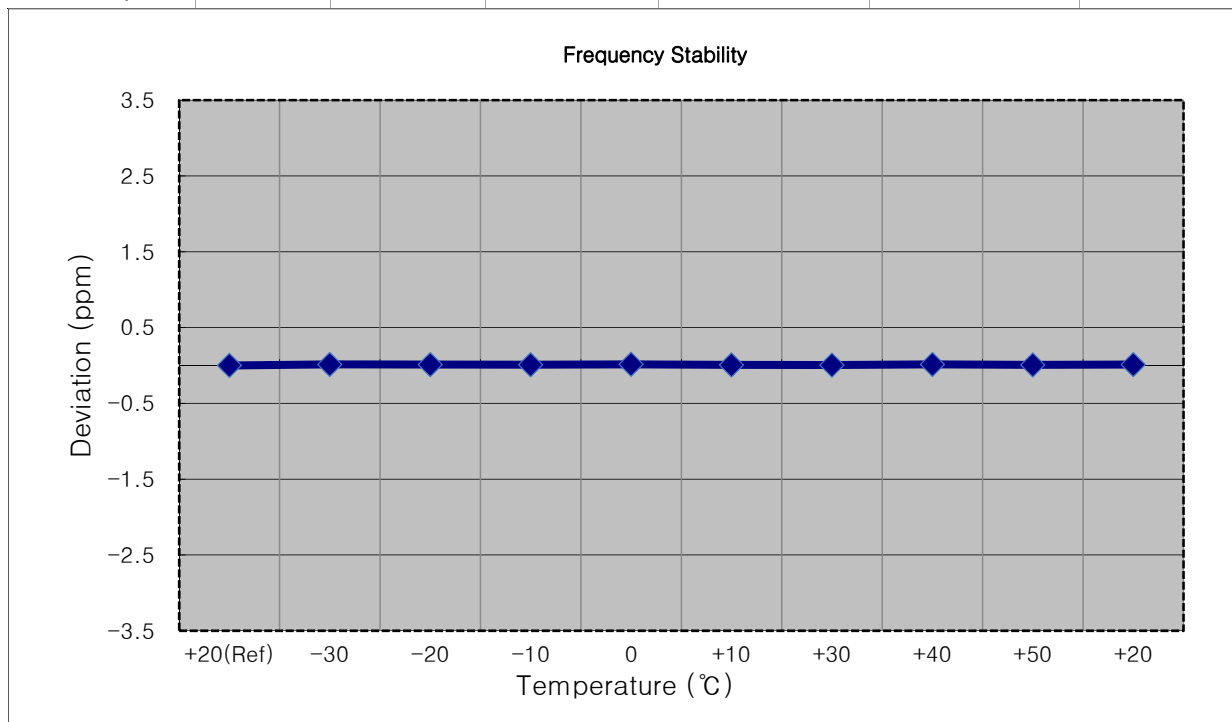
MODE:	<u>LTE 14</u>
OPERATING FREQUENCY:	<u>790,500,000 Hz</u>
CHANNEL:	<u>23305 (5 MHz)</u>
REFERENCE VOLTAGE:	<u>3.880 VDC</u>
DEVIATION LIMIT:	<u>2.5ppm</u>

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(°C)	(Hz)	(Hz)	(%)	
100 %	3.880	+20(Ref)	790 500 008	0.00	0.000 000	0.0000
100 %		-30	790 500 017	8.90	0.000 001	0.0113
100 %		-20	790 500 004	-3.90	0.000 000	-0.0049
100 %		-10	790 500 019	10.80	0.000 001	0.0137
100 %		0	790 500 023	14.60	0.000 002	0.0185
100 %		+10	790 500 015	6.70	0.000 001	0.0085
100 %		+30	790 500 018	9.40	0.000 001	0.0119
100 %		+40	790 500 018	10.20	0.000 001	0.0129
100 %		+50	790 500 019	10.50	0.000 001	0.0133
Batt. Endpoint	3.300	+20	790 500 020	12.30	0.000 002	0.0156



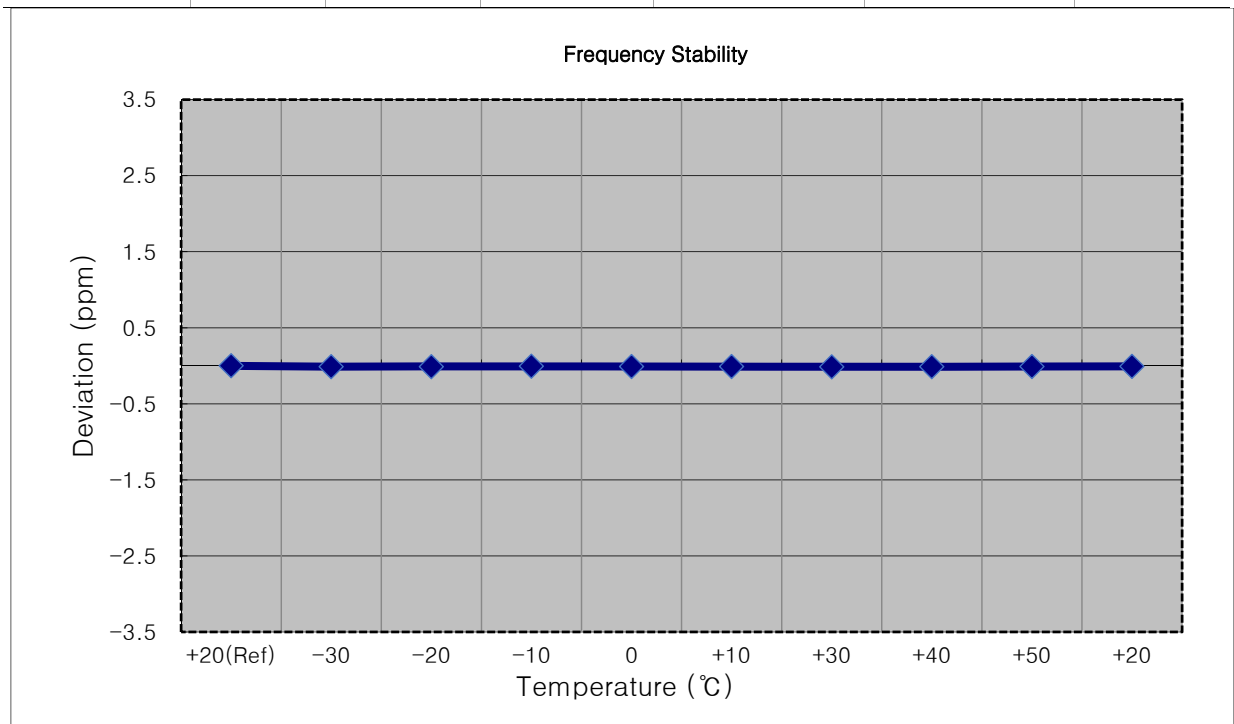
MODE: LTE 14
 OPERATING FREQUENCY: 793,000,000 Hz
 CHANNEL: 23330 (5 MHz)
 REFERENCE VOLTAGE: 3.880 VDC
 DEVIATION LIMIT: 2.5ppm

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(°C)	(Hz)	(Hz)	(%)	
100 %	3.880	+20(Ref)	793 000 014	0.00	0.000 000	0.0000
100 %		-30	793 000 024	10.10	0.000 001	0.0127
100 %		-20	793 000 022	8.20	0.000 001	0.0103
100 %		-10	793 000 021	6.90	0.000 001	0.0087
100 %		0	793 000 025	11.60	0.000 001	0.0146
100 %		+10	793 000 019	5.10	0.000 001	0.0064
100 %		+30	793 000 018	4.30	0.000 001	0.0054
100 %		+40	793 000 024	10.20	0.000 001	0.0129
100 %		+50	793 000 019	5.10	0.000 001	0.0064
Batt. Endpoint	3.300	+20	793 000 023	9.10	0.000 001	0.0115



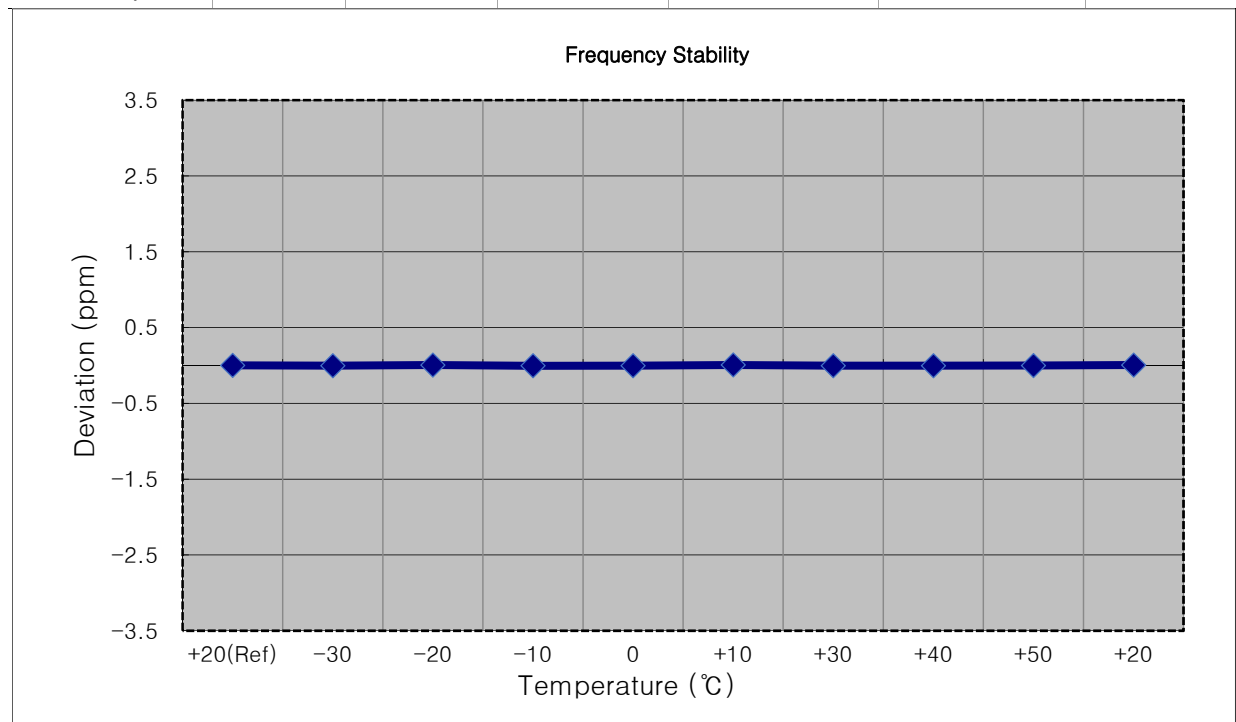
MODE:	<u>LTE 14</u>
OPERATING FREQUENCY:	<u>795,500,000 Hz</u>
CHANNEL:	<u>23355 (5 MHz)</u>
REFERENCE VOLTAGE:	<u>3.880 VDC</u>
DEVIATION LIMIT:	<u>2.5ppm</u>

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(°C)	(Hz)	(Hz)	(%)	
100 %	3.880	+20(Ref)	795 499 988	0.00	0.000 000	0.0000
100 %		-30	795 499 977	-10.50	-0.000 001	-0.0132
100 %		-20	795 499 977	-10.10	-0.000 001	-0.0127
100 %		-10	795 499 982	-5.30	-0.000 001	-0.0067
100 %		0	795 499 980	-7.40	-0.000 001	-0.0093
100 %		+10	795 499 979	-8.60	-0.000 001	-0.0108
100 %		+30	795 499 976	-11.60	-0.000 001	-0.0146
100 %		+40	795 499 978	-9.40	-0.000 001	-0.0118
100 %		+50	795 499 979	-8.30	-0.000 001	-0.0104
Batt. Endpoint	3.300	+20	795 499 981	-6.90	-0.000 001	-0.0087



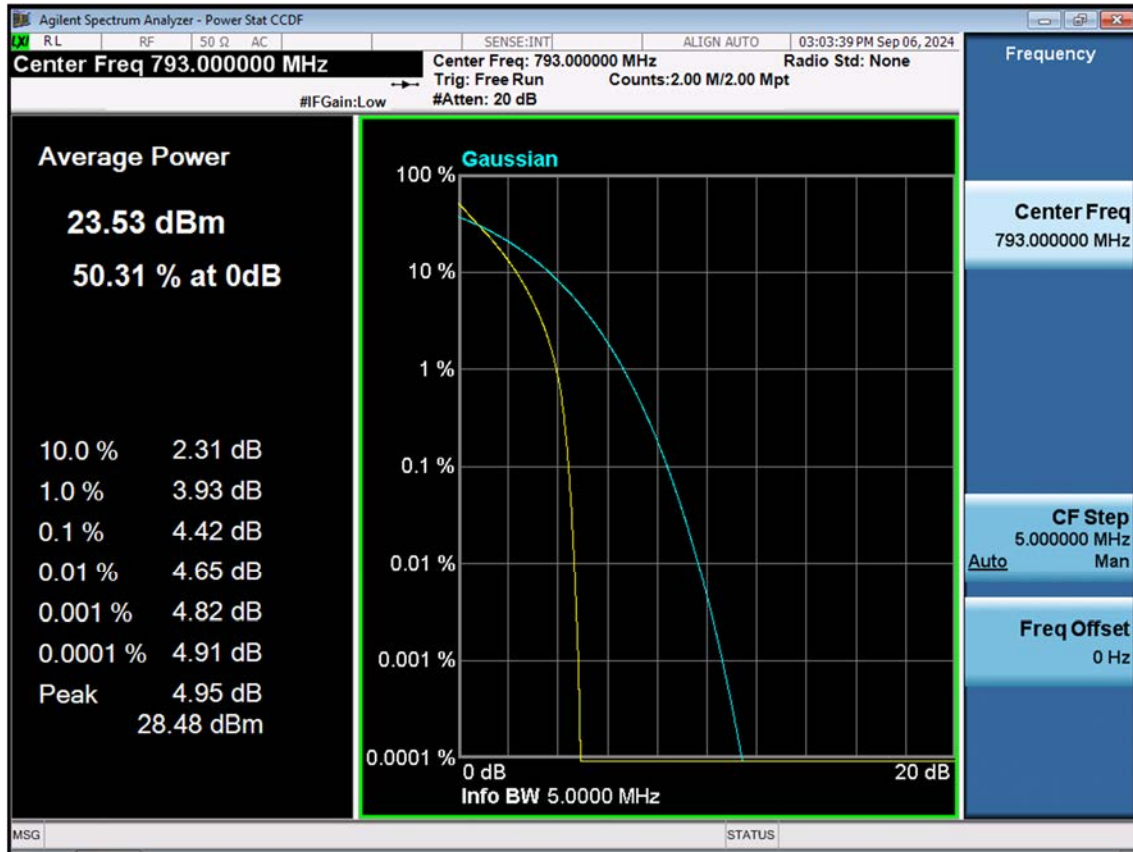
MODE: LTE 14
 OPERATING FREQUENCY: 793,000,000 Hz
 CHANNEL: 23330 (10 MHz)
 REFERENCE VOLTAGE: 3.880 VDC
 DEVIATION LIMIT: 2.5ppm

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(°C)	(Hz)	(Hz)	(%)	
100 %	3.880	+20(Ref)	793 000 003	0.00	0.000 000	0.0000
100 %		-30	793 000 000	-2.80	0.000 000	-0.0035
100 %		-20	793 000 006	3.50	0.000 000	0.0044
100 %		-10	792 999 999	-3.60	0.000 000	-0.0045
100 %		0	792 999 999	-3.50	0.000 000	-0.0044
100 %		+10	793 000 007	4.40	0.000 001	0.0055
100 %		+30	793 000 000	-2.90	0.000 000	-0.0037
100 %		+40	792 999 999	-3.20	0.000 000	-0.0040
100 %		+50	793 000 001	-2.00	0.000 000	-0.0025
Batt. Endpoint	3.300	+20	793 000 007	4.10	0.000 001	0.0052

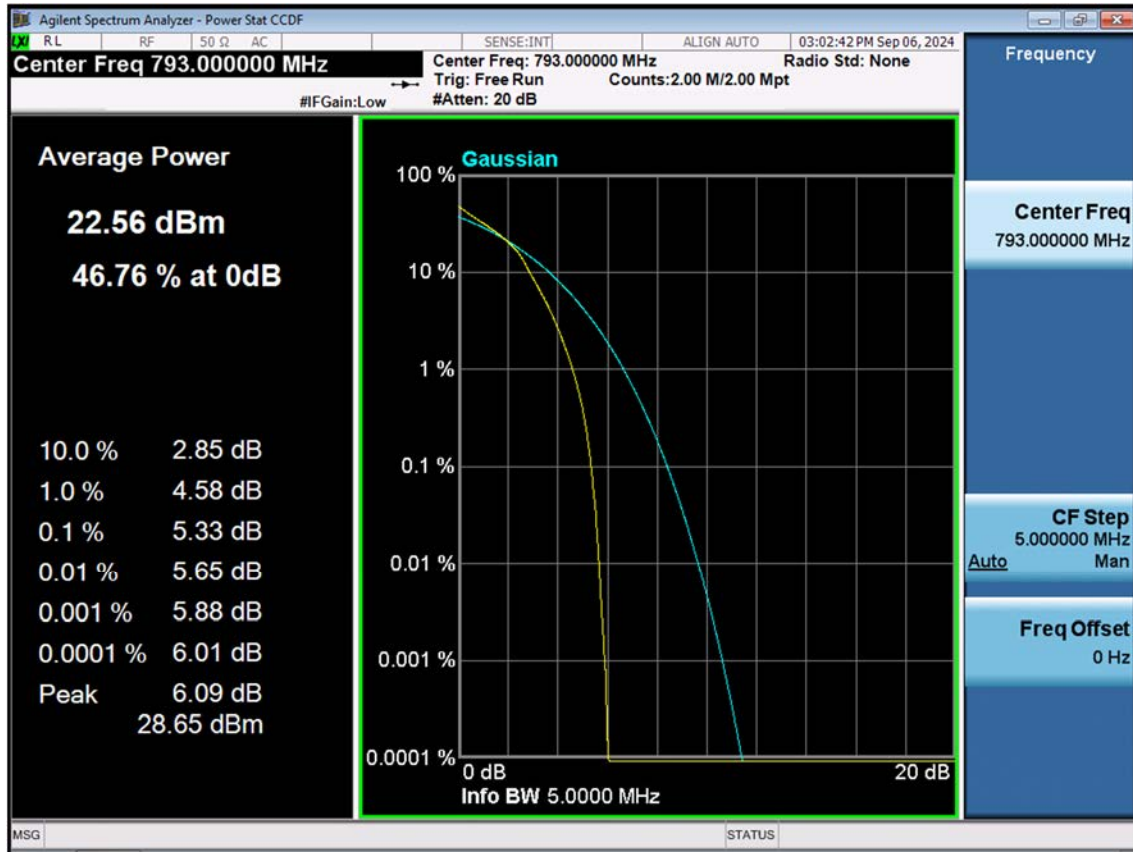


10 TEST PLOTS(Main 1 ANT)

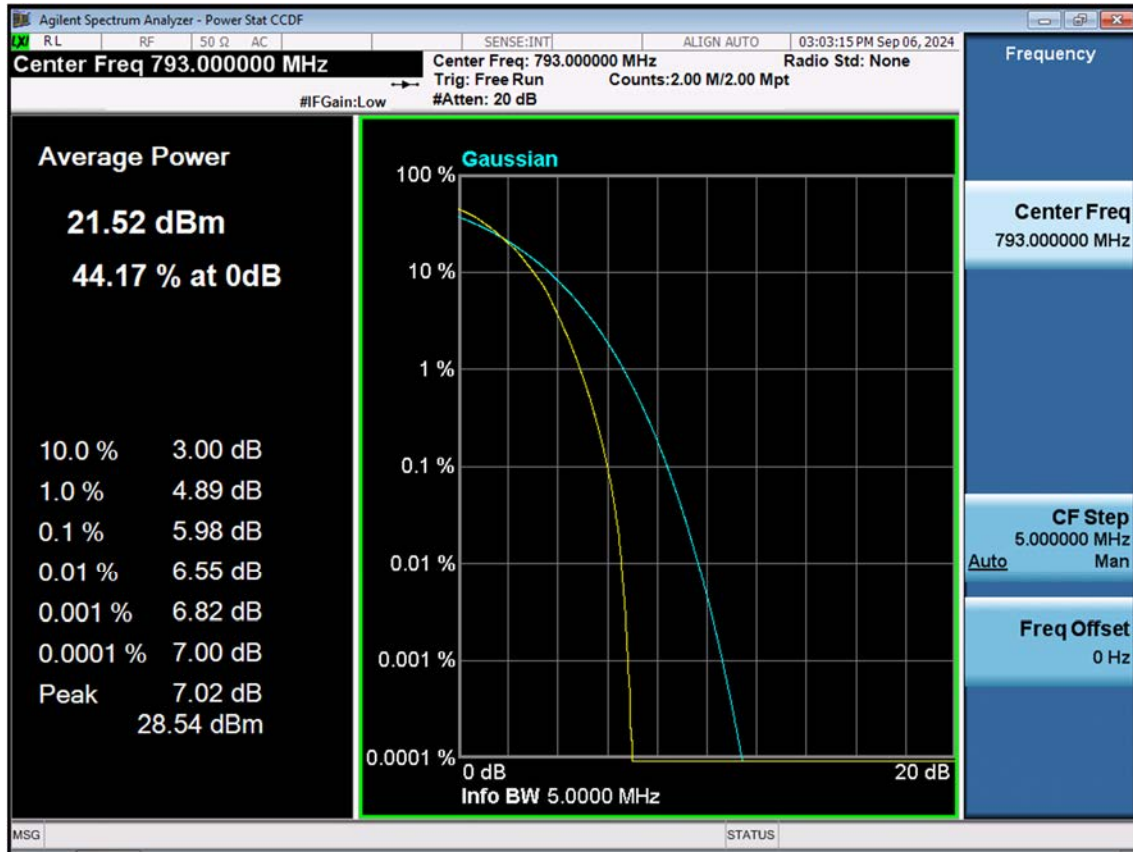
LTE B14_5 M_PAR_Mid_QPSK_FullRB



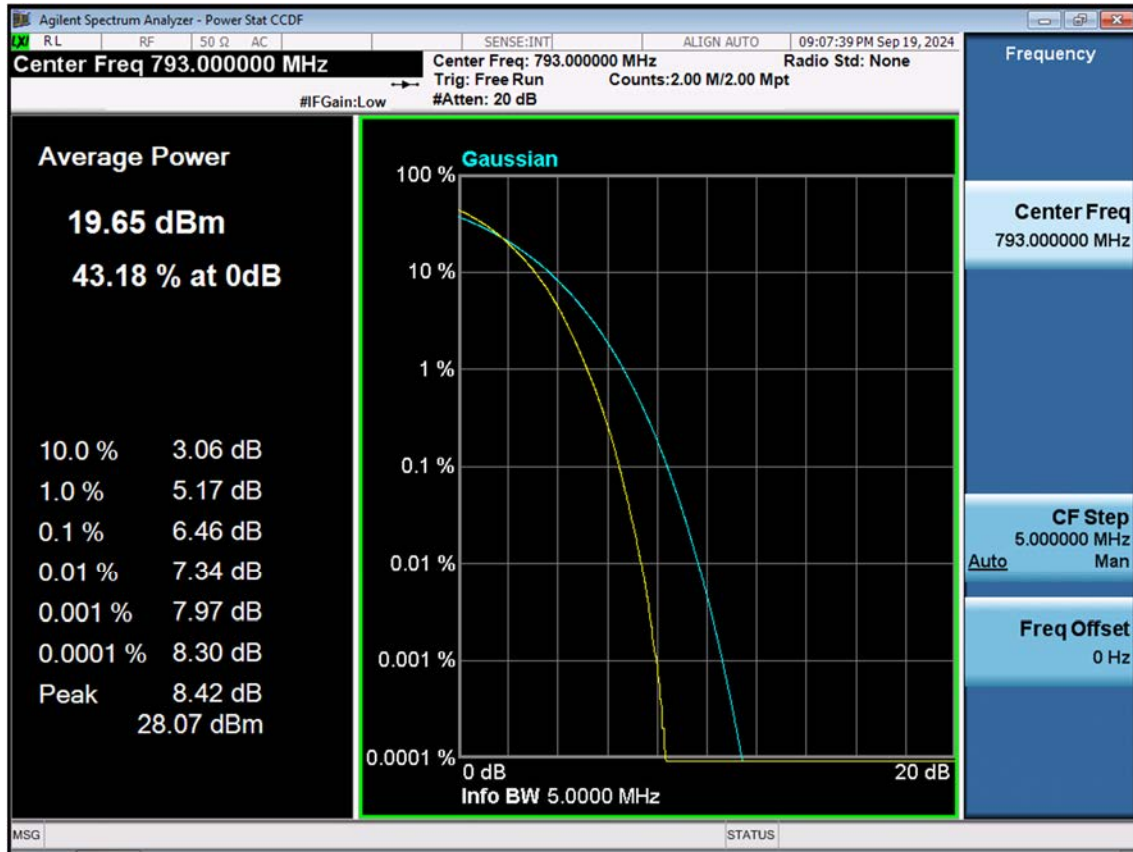
LTE B14_5 M_PAR_Mid_16QAM_FullRB



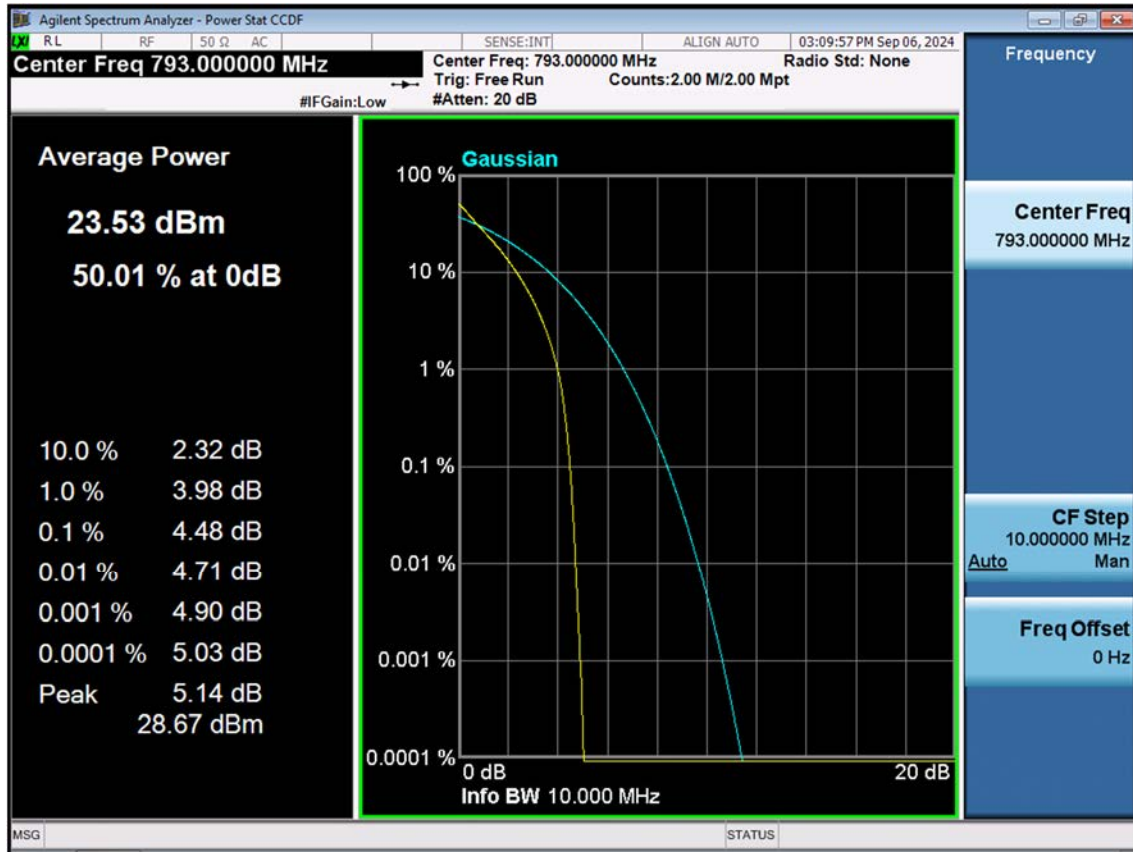
LTE B14_5 M_PAR_Mid_64QAM_FullRB



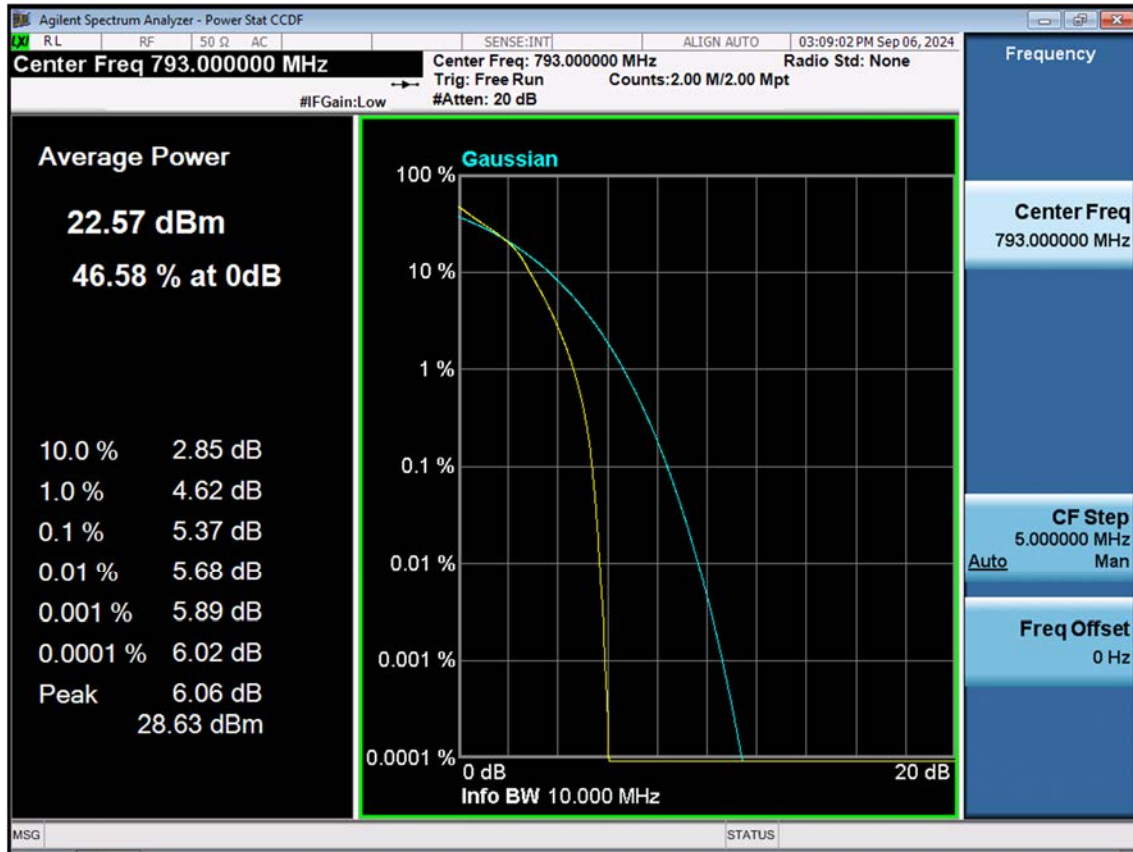
LTE B14_5 M_PAR_Mid_256QAM_FullRB



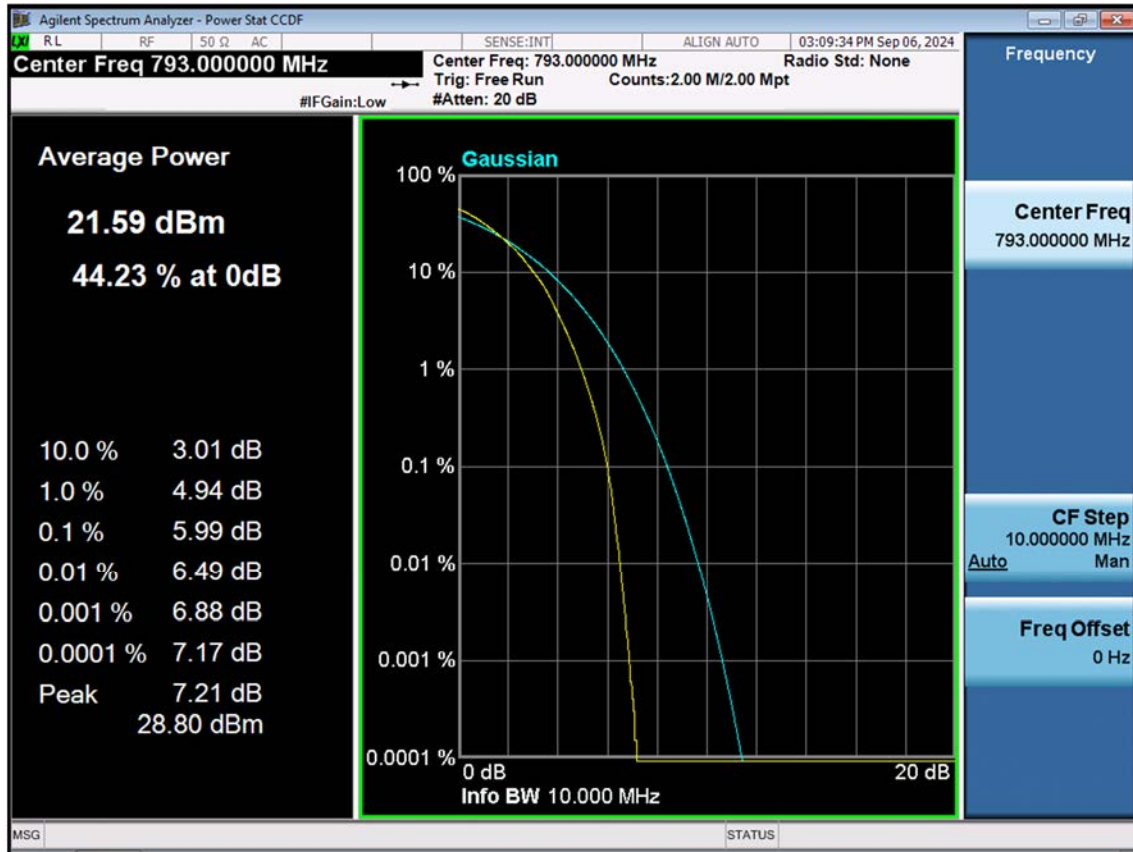
LTE B14_10 M_PAR_Mid_QPSK_FullRB



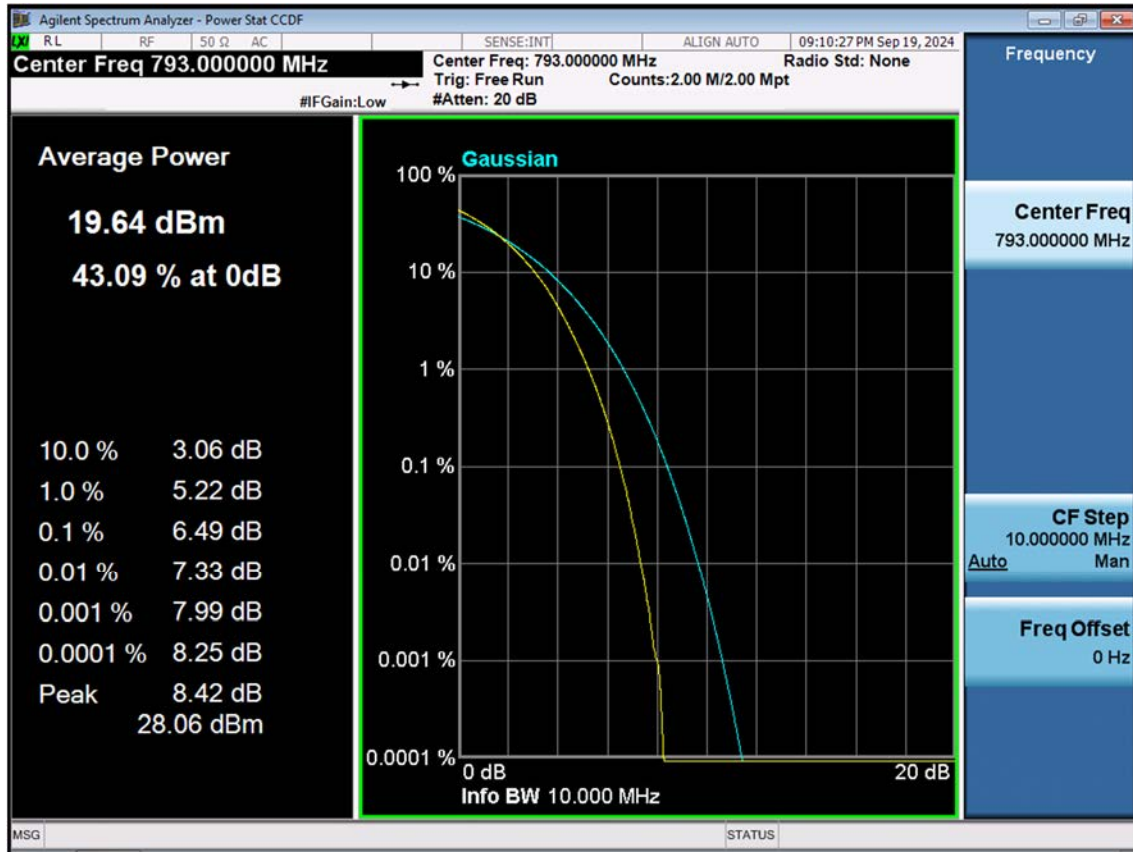
LTE B14_10 M_PAR_Mid_16QAM_FullRB



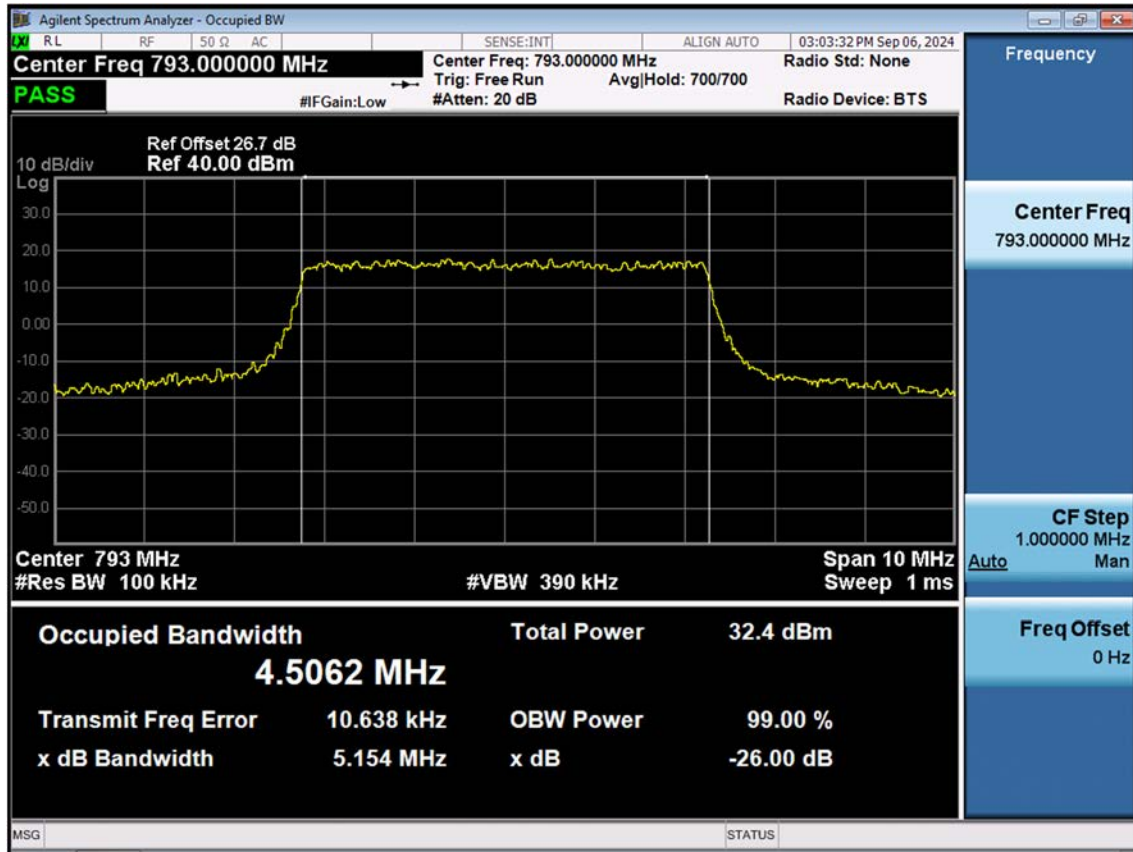
LTE B14_10 M_PAR_Mid_64QAM_FullRB



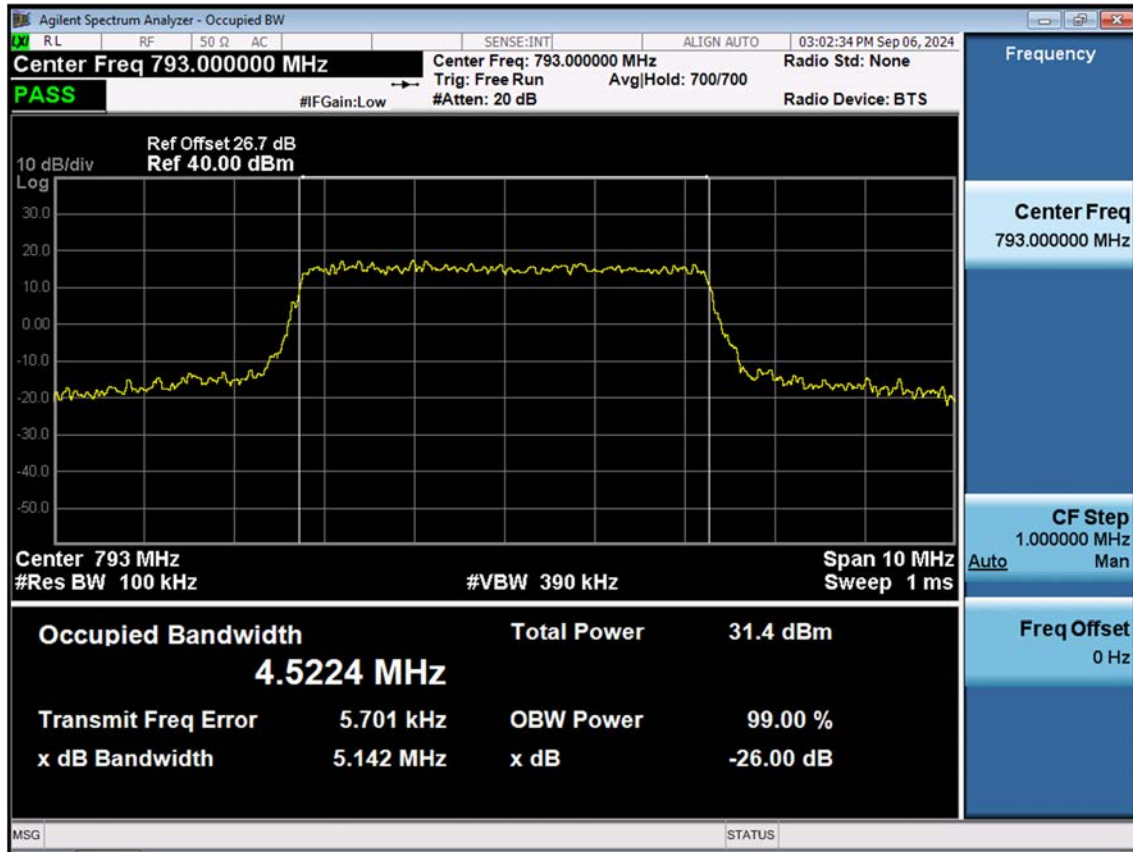
LTE B14_10 M_PAR_Mid_256QAM_FullRB



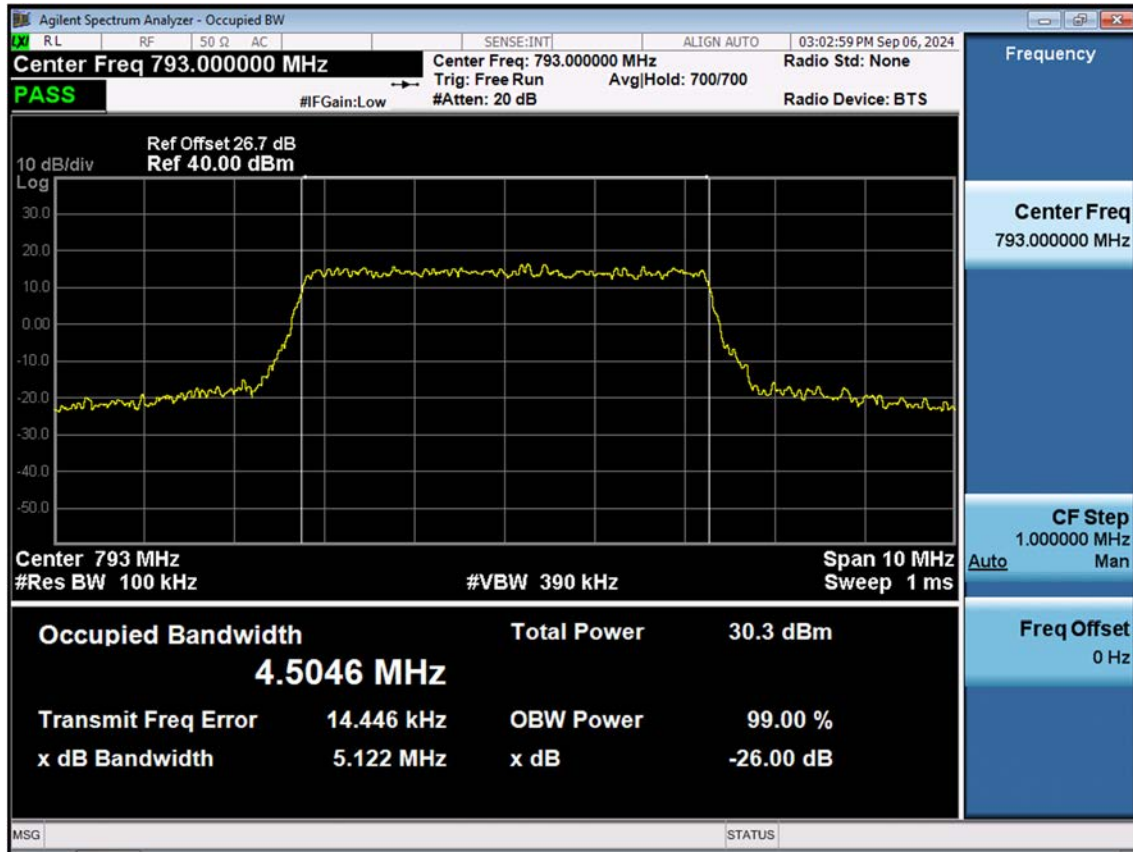
LTE B14_5 M_OBW_Mid_QPSK_FullRB



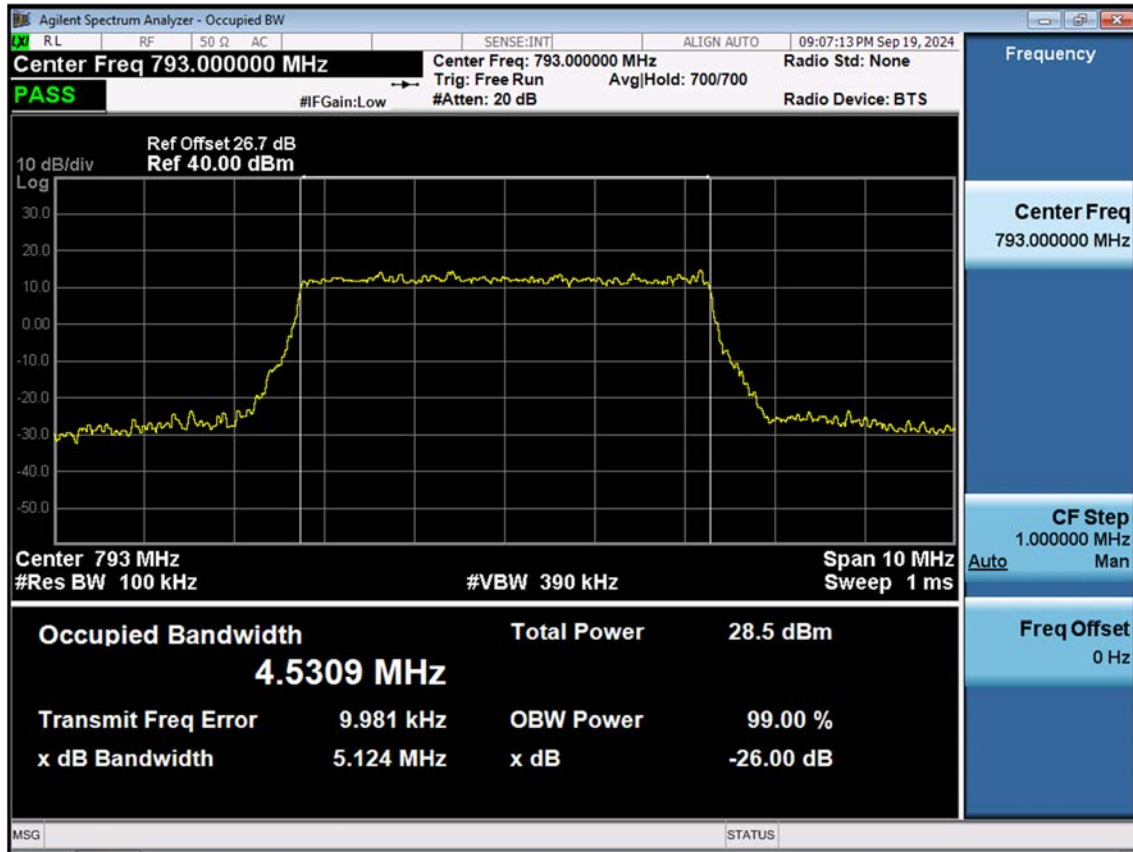
LTE B14_5 M_OBW_Mid_16QAM_FullRB



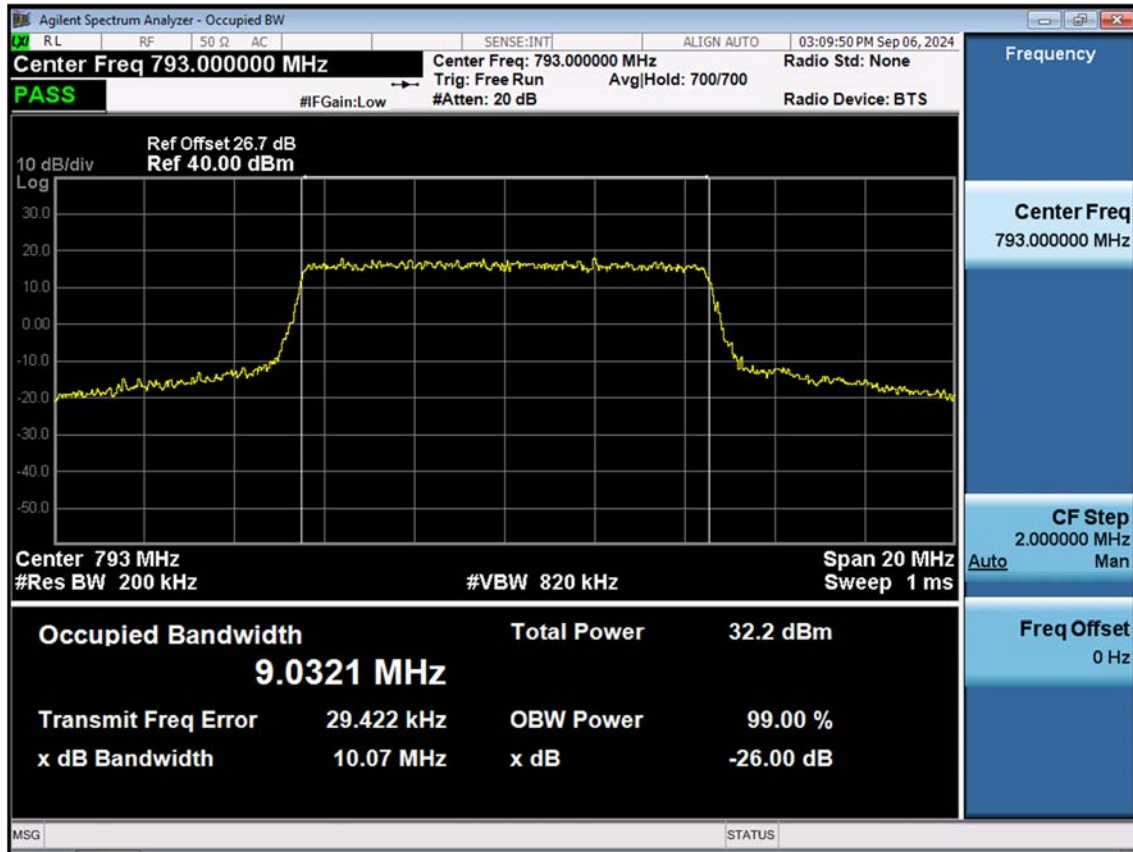
LTE B14_5 M_OBW_Mid_64QAM_FullRB



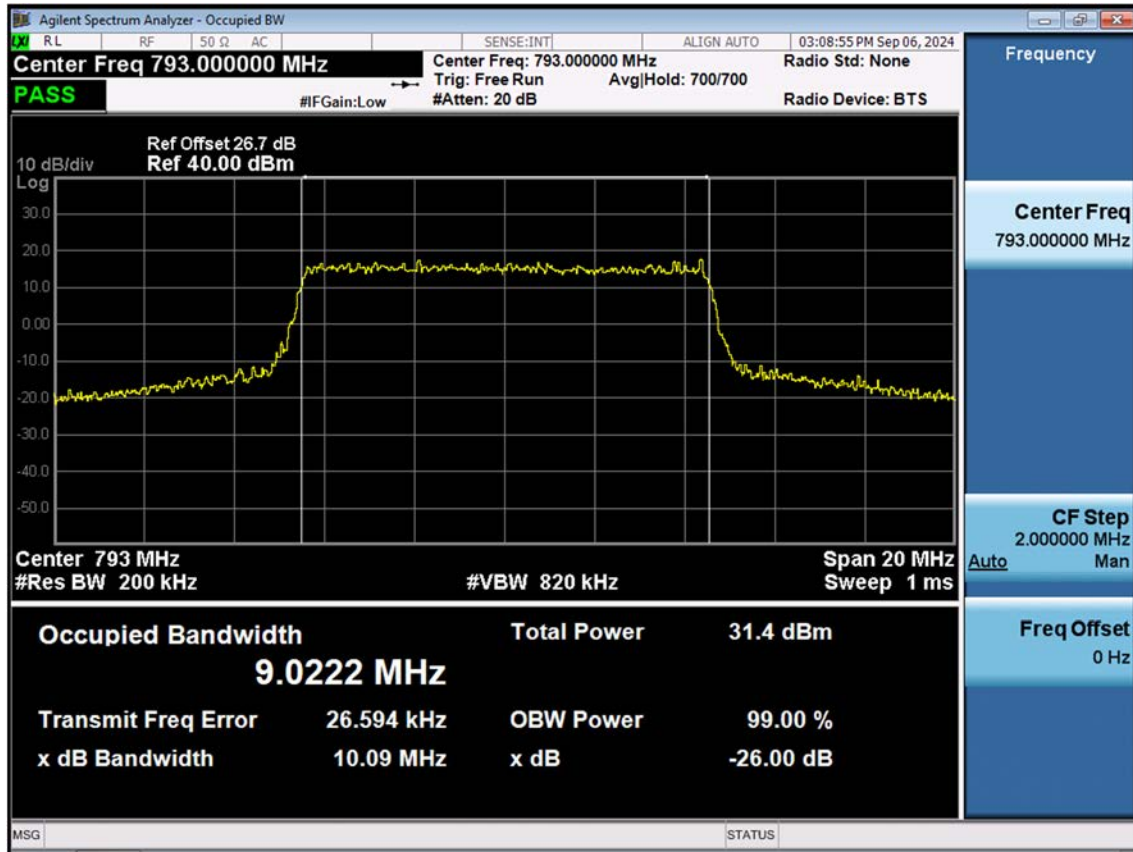
LTE B14_5 M_OBW_Mid_256QAM_FullRB



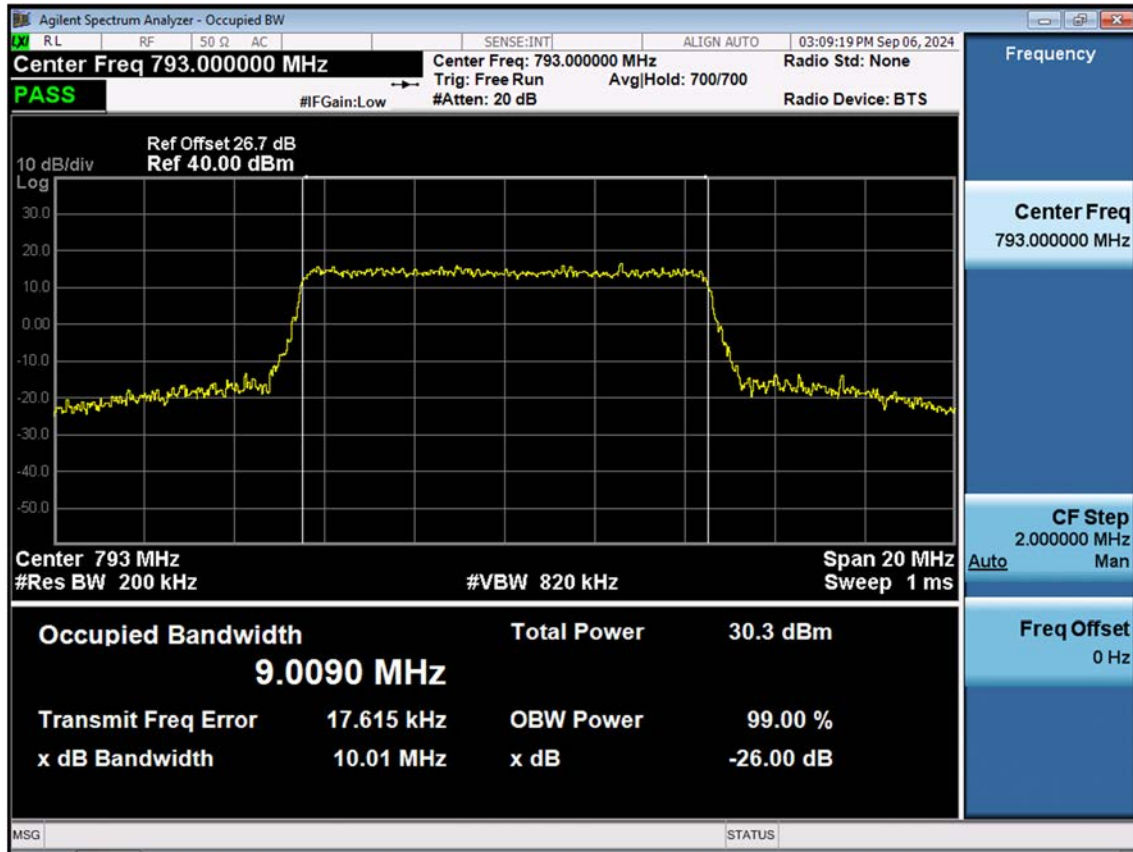
LTE B14_10 M_OBW_Mid_QPSK_FullRB



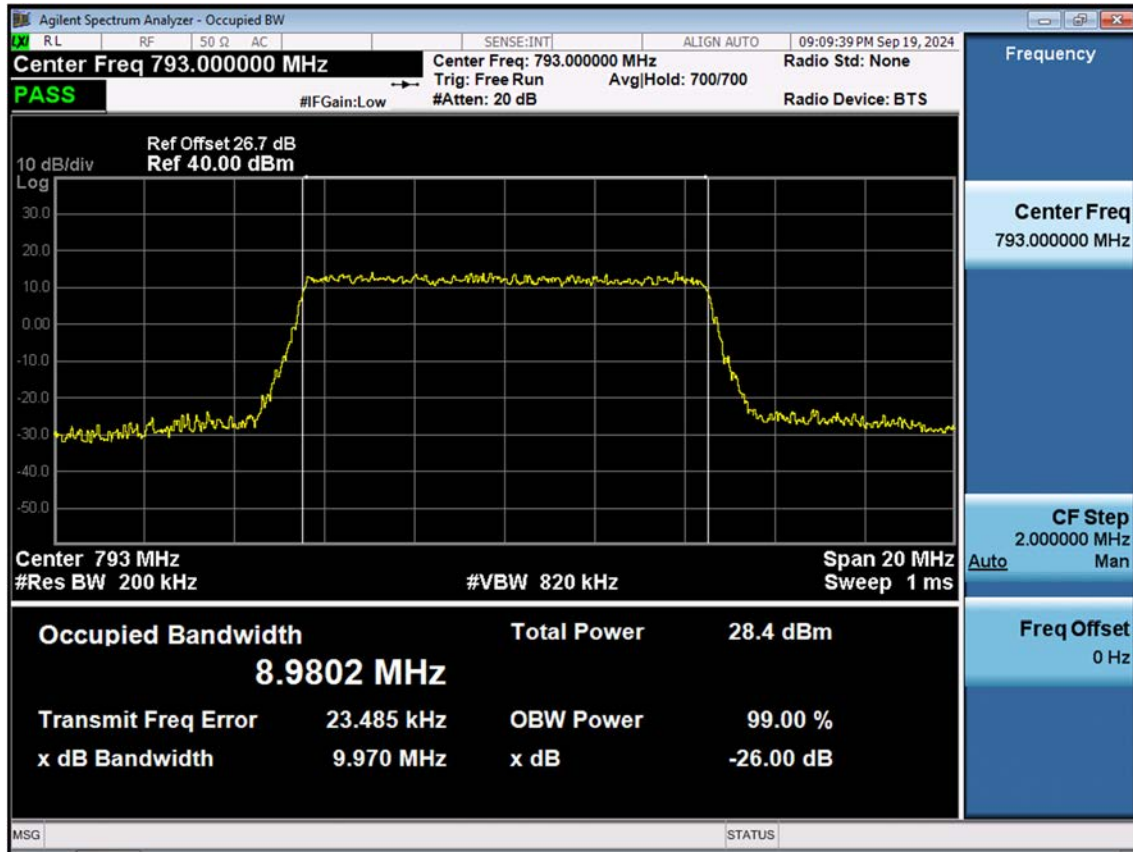
LTE B14_10 M_OBW_Mid_16QAM_FullRB



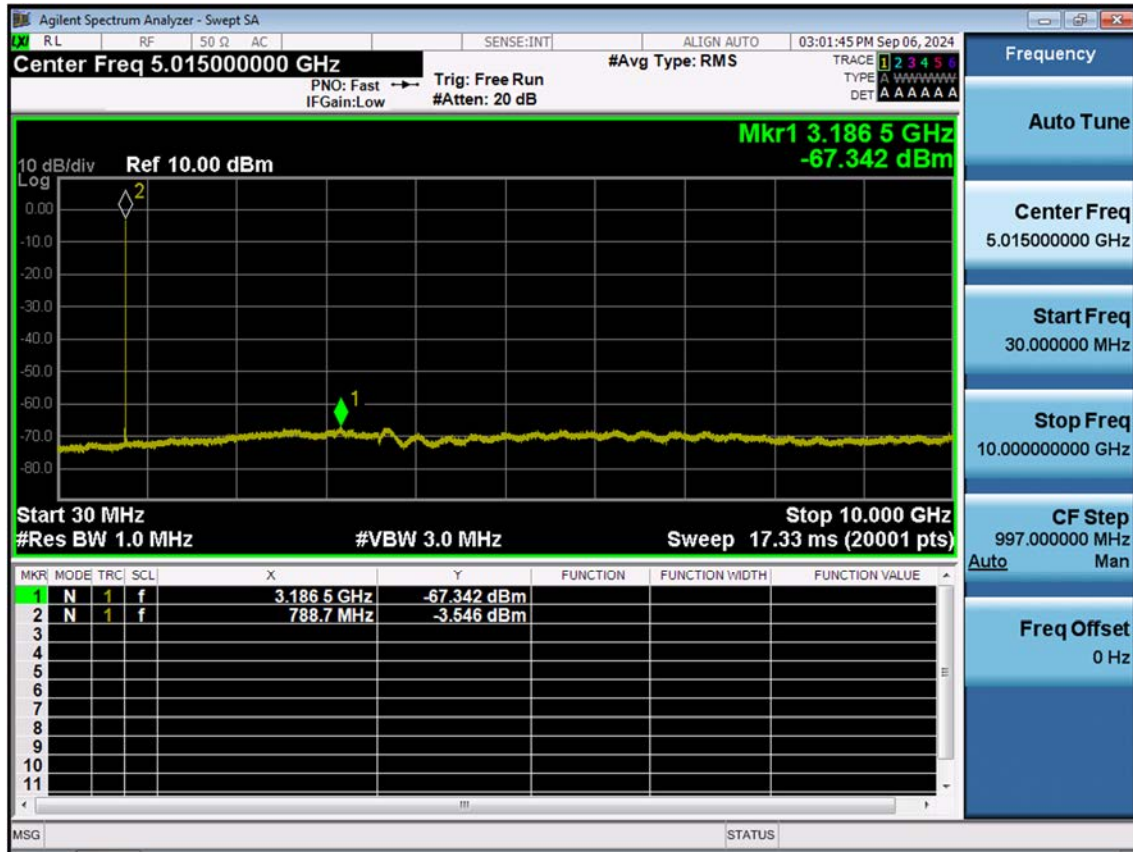
LTE B14_10 M_OBW_Mid_64QAM_FullRB



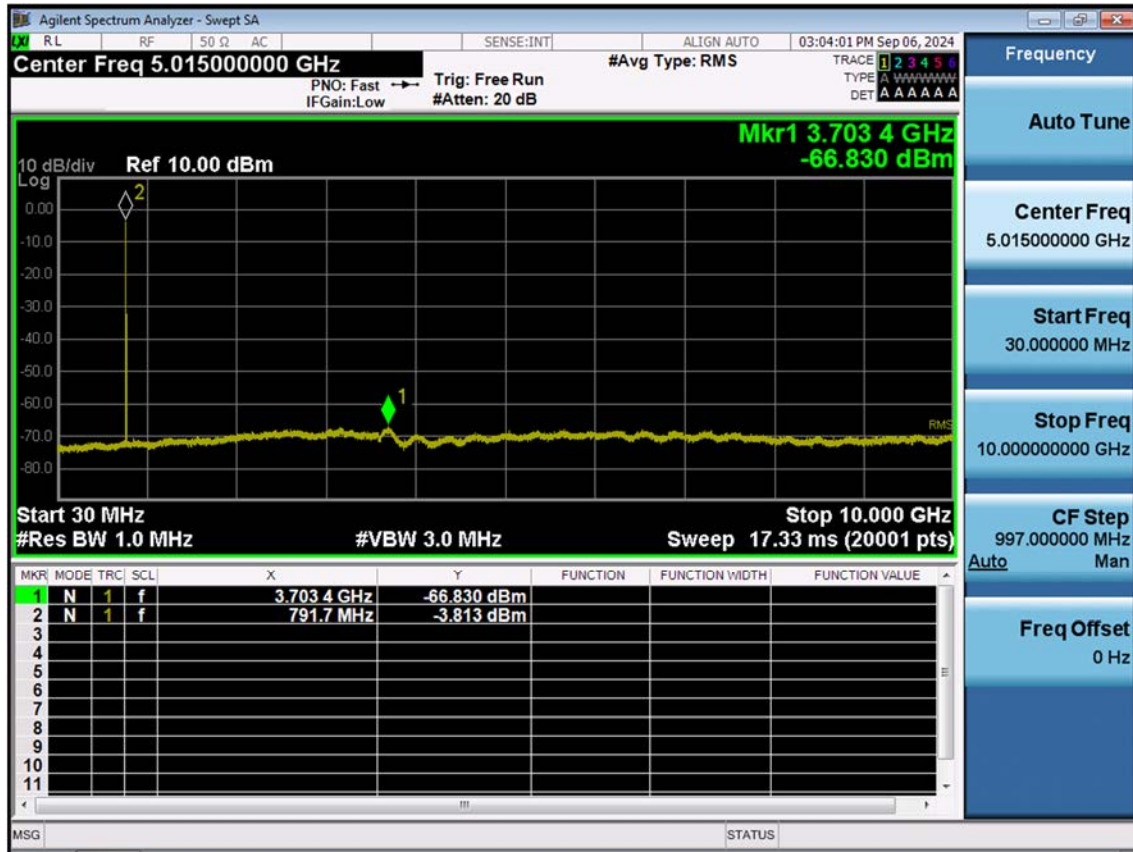
LTE B14_10 M_OBW_Mid_256QAM_FullRB



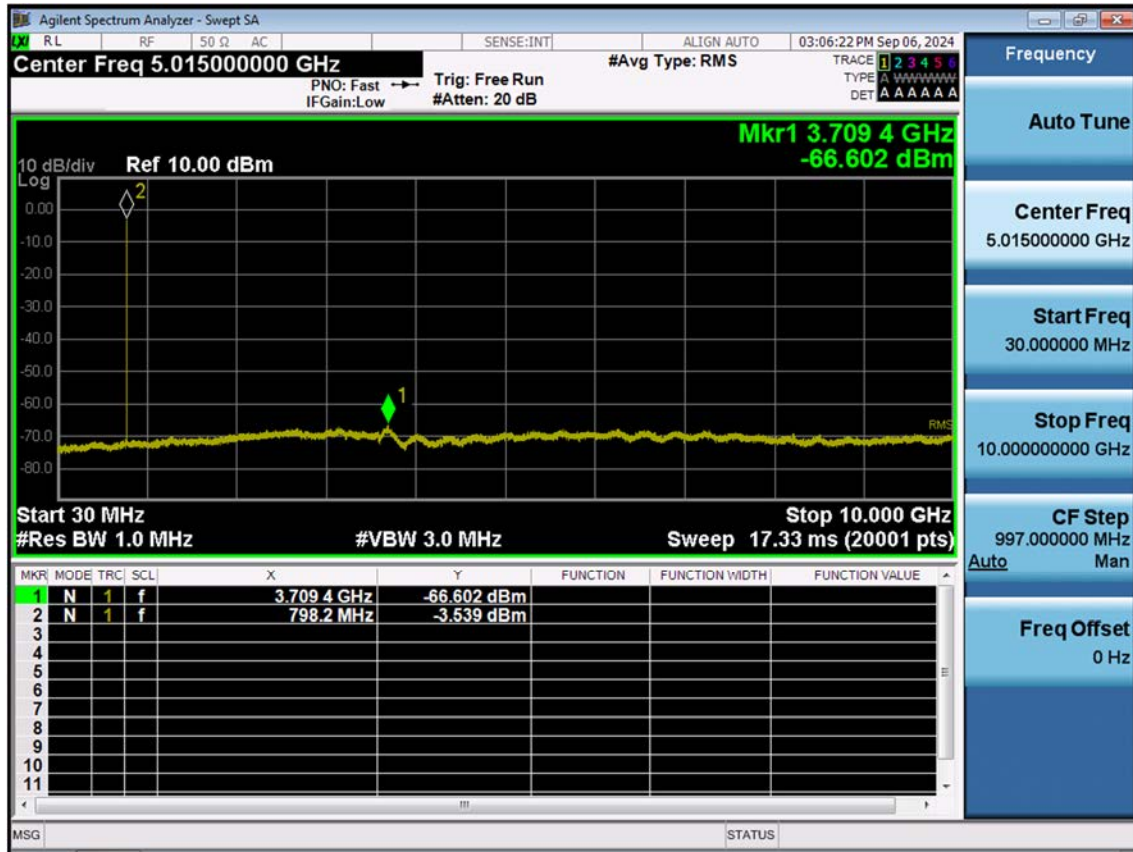
LTE B14_5 M_Conducted Spurious(30 M-10 G)_Low_QPSK_1RB



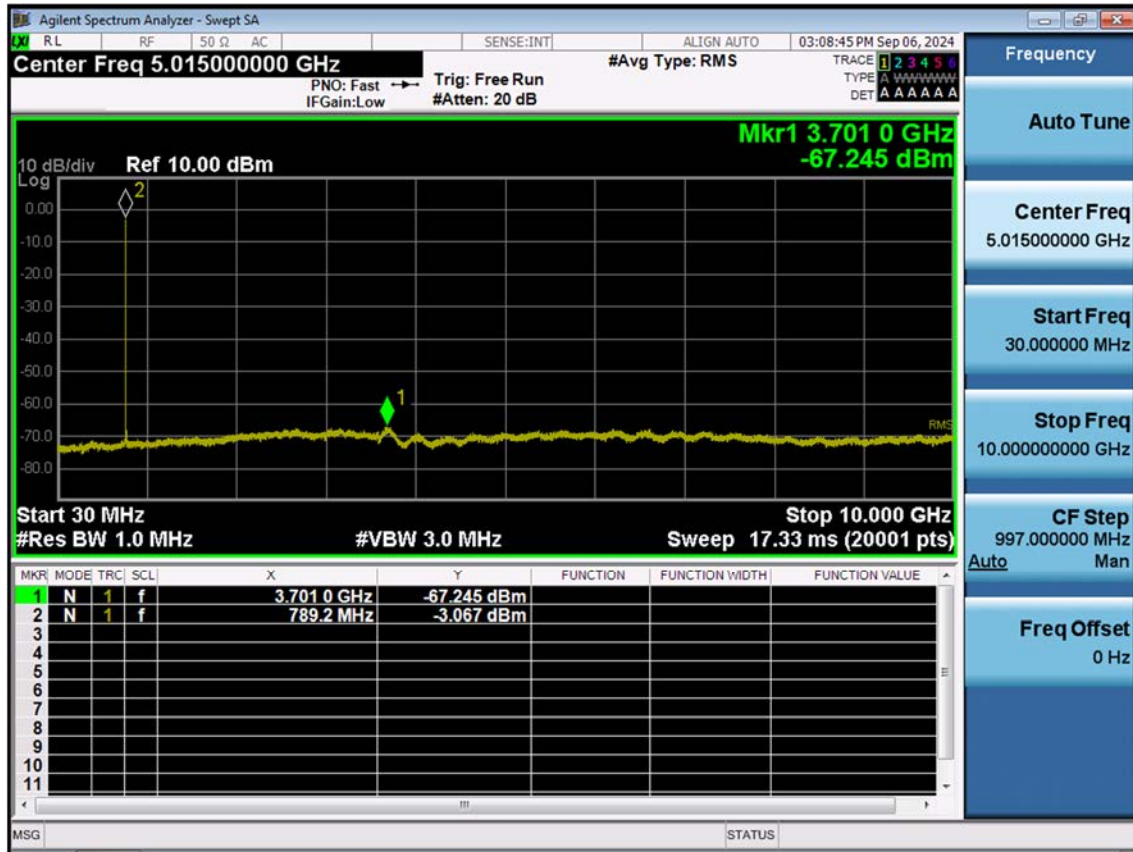
LTE B14_5 M_Conducted Spurious(30 M-10 G)_Mid_QPSK_1RB



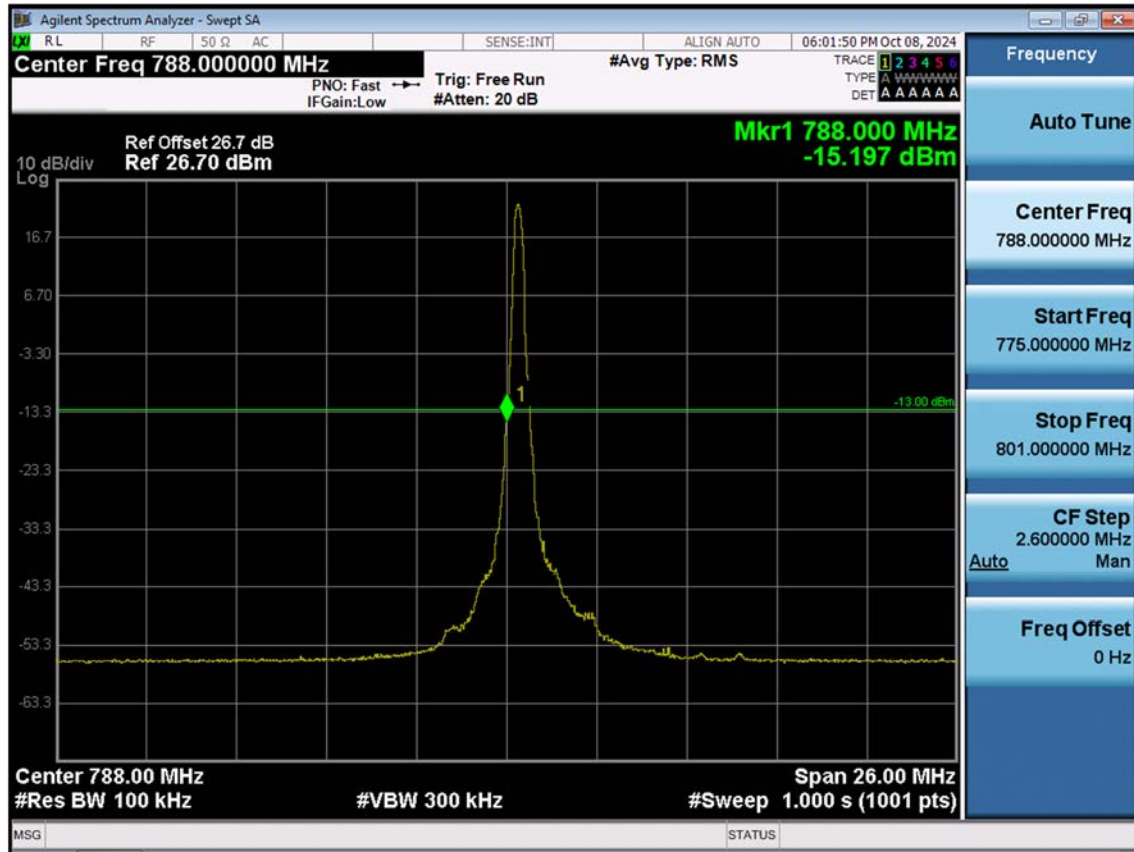
LTE B14_5 M_Conducted Spurious(30 M-10 G)_High_QPSK_1RB



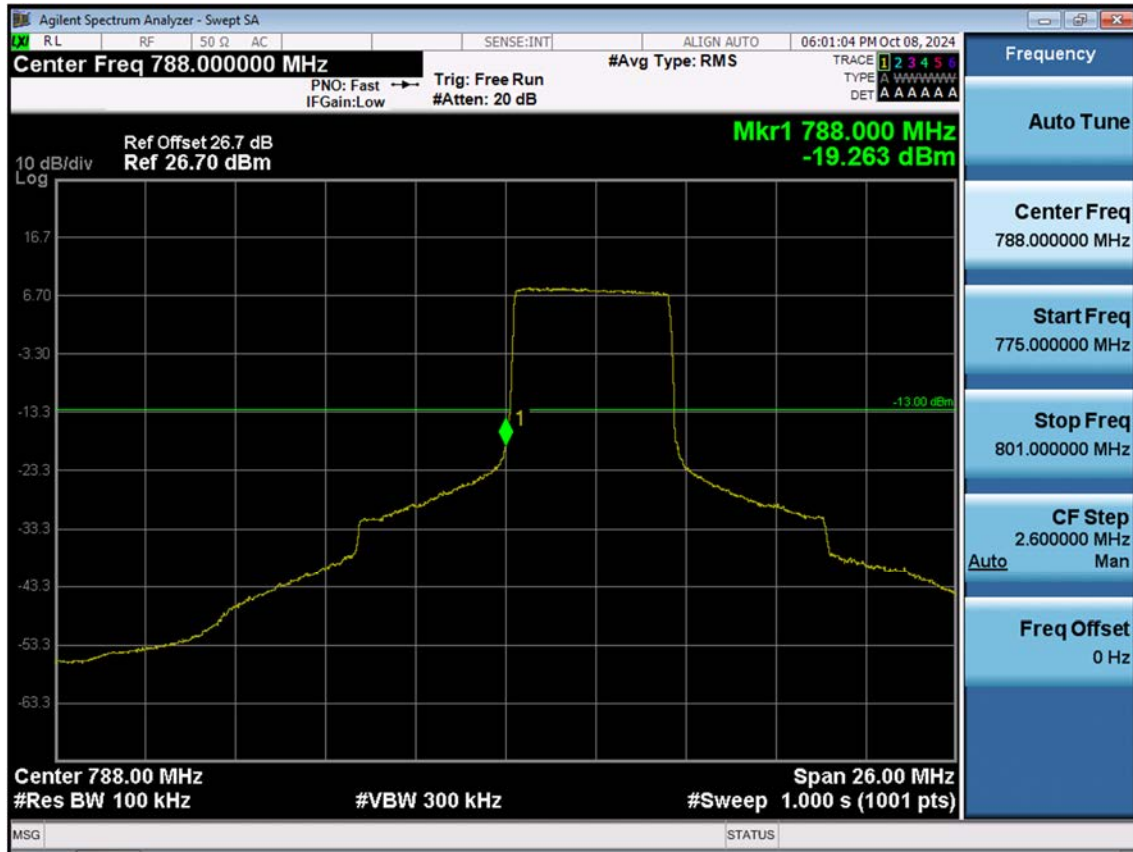
LTE B14_10 M_Conducted Spurious(30 M-10 G)_Low_QPSK_1RB



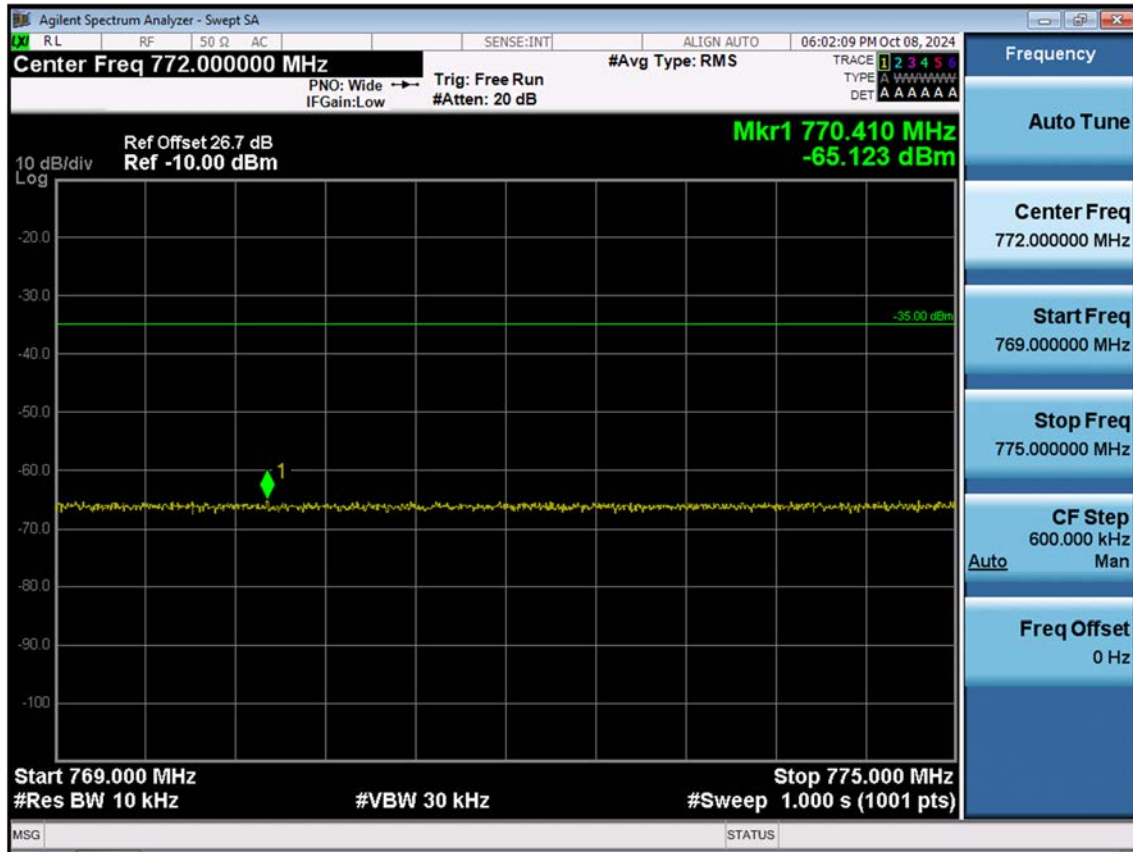
LTE B14_5 M_Band Edge_Low_QPSK_1RB



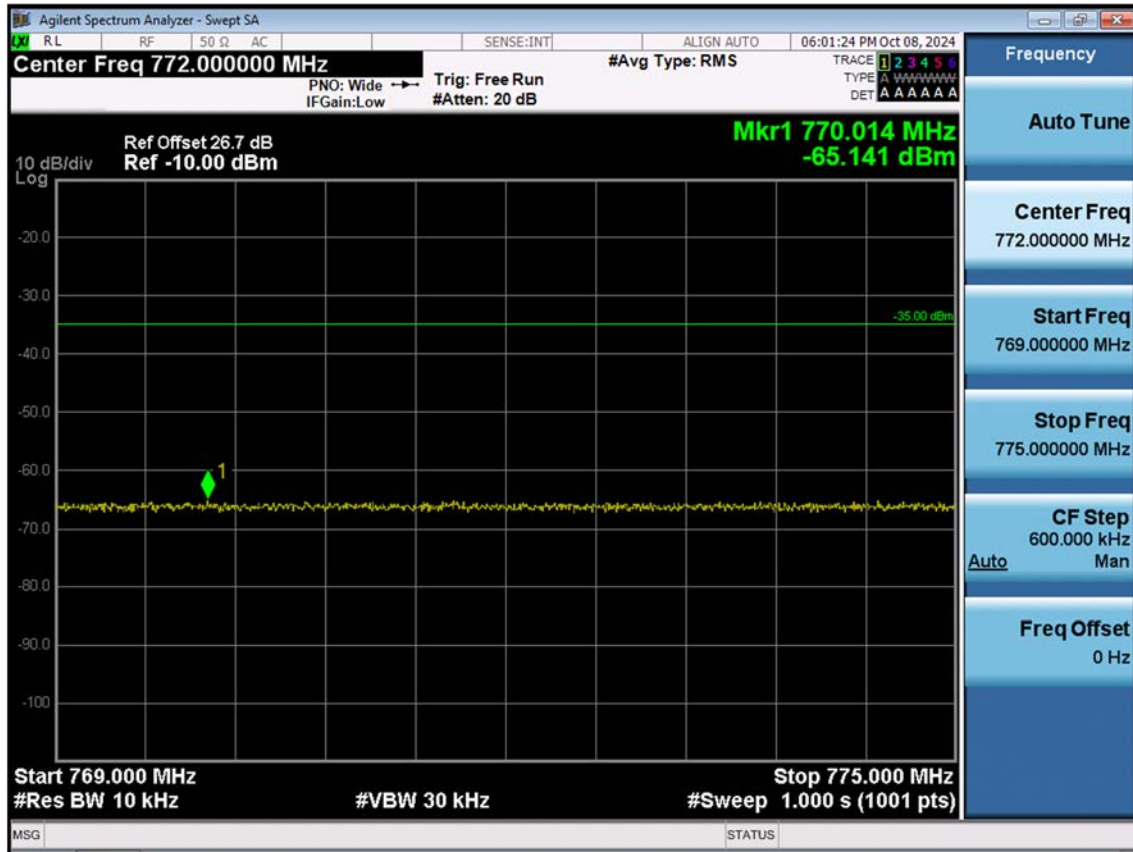
LTE B14_5 M_Band Edge_Low_QPSK_FullRB



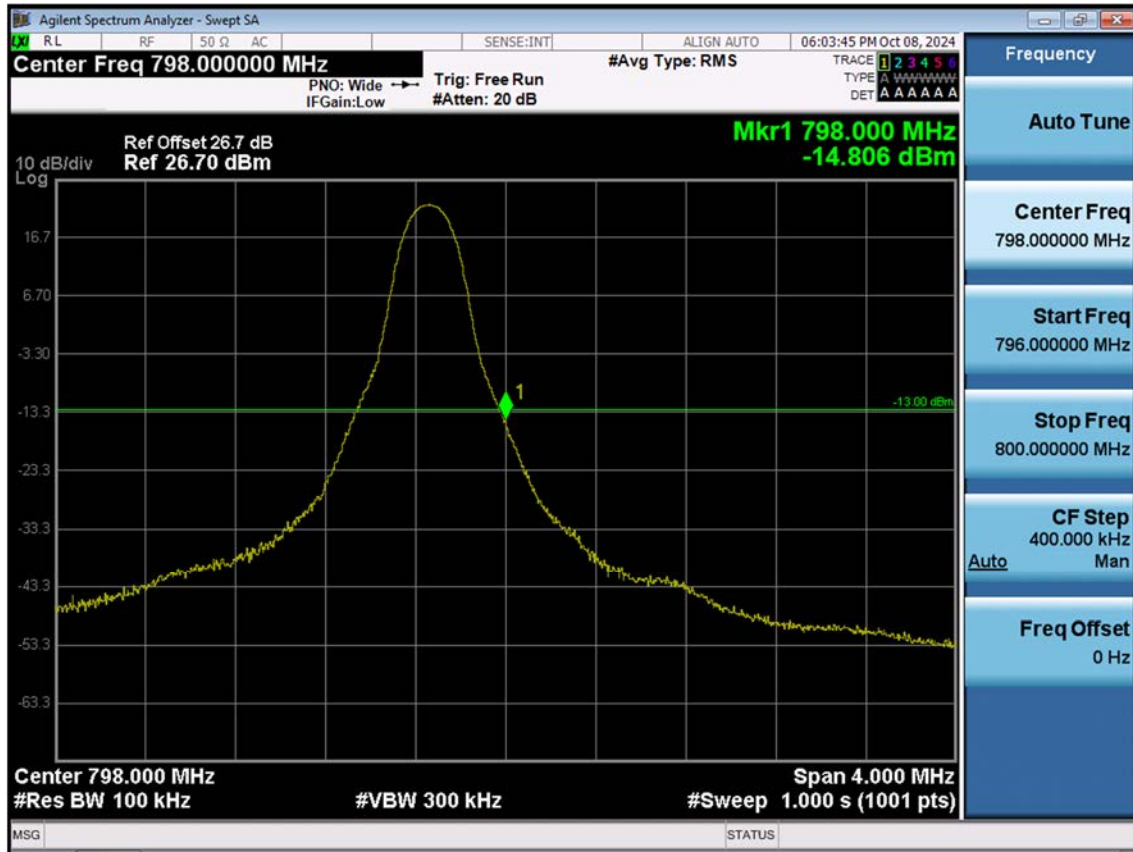
LTE B14_5 M_Extended Band Edge_Low_QPSK_1RB



LTE B14_5 M_Extended Band Edge_Low_QPSK_FullRB



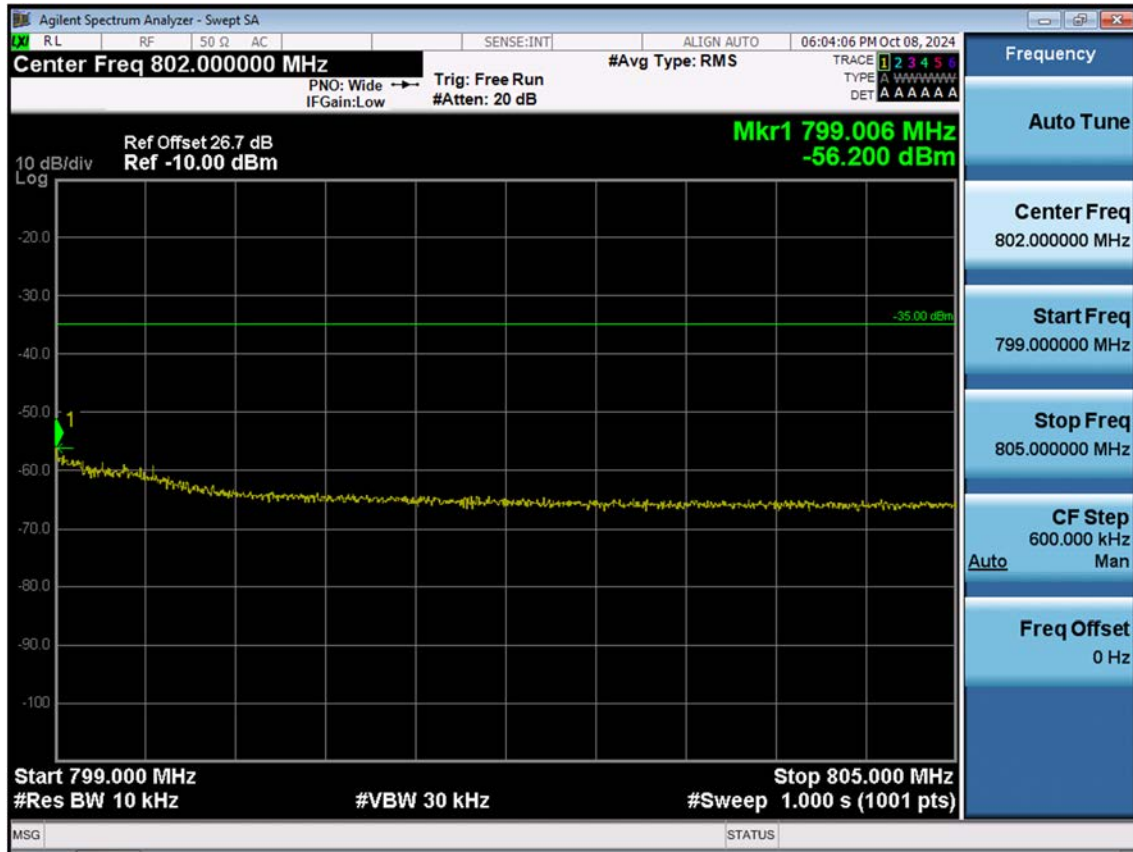
LTE B14_5 M_Band Edge_High_QPSK_1RB



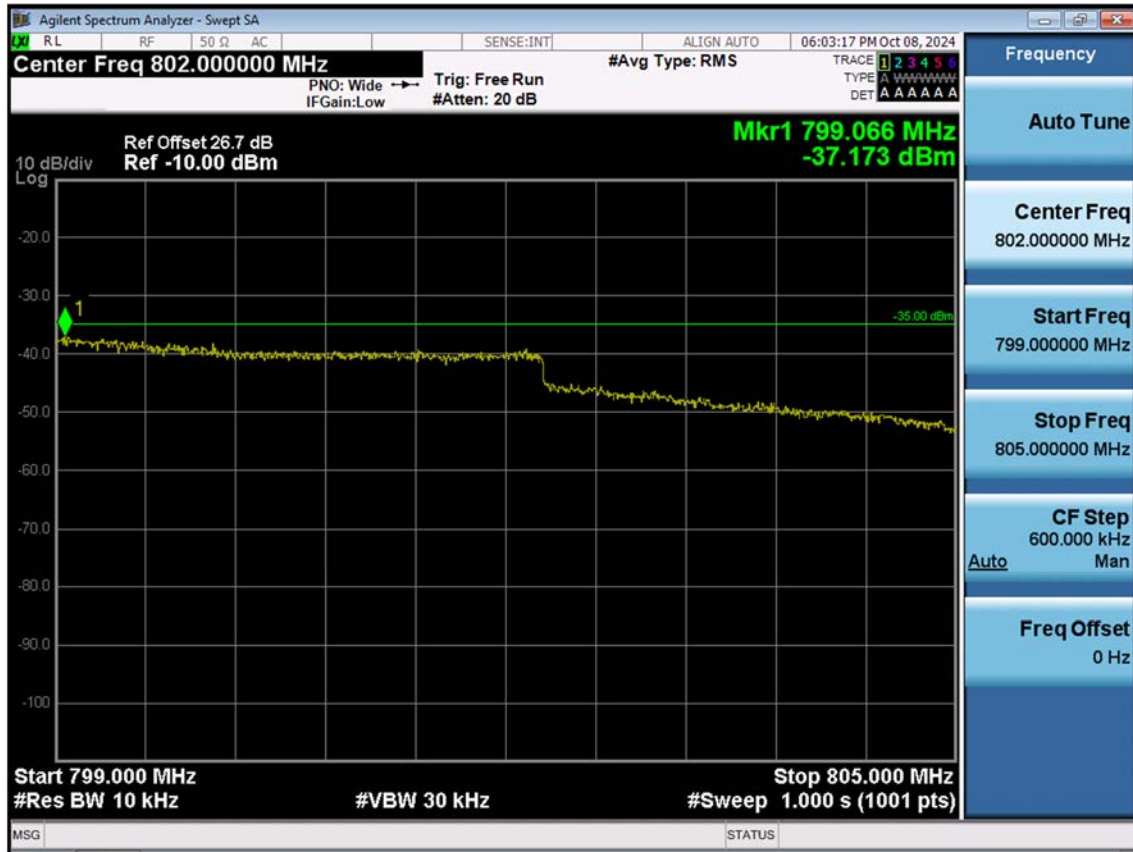
LTE B14_5 M_Band Edge_High_QPSK_FullRB



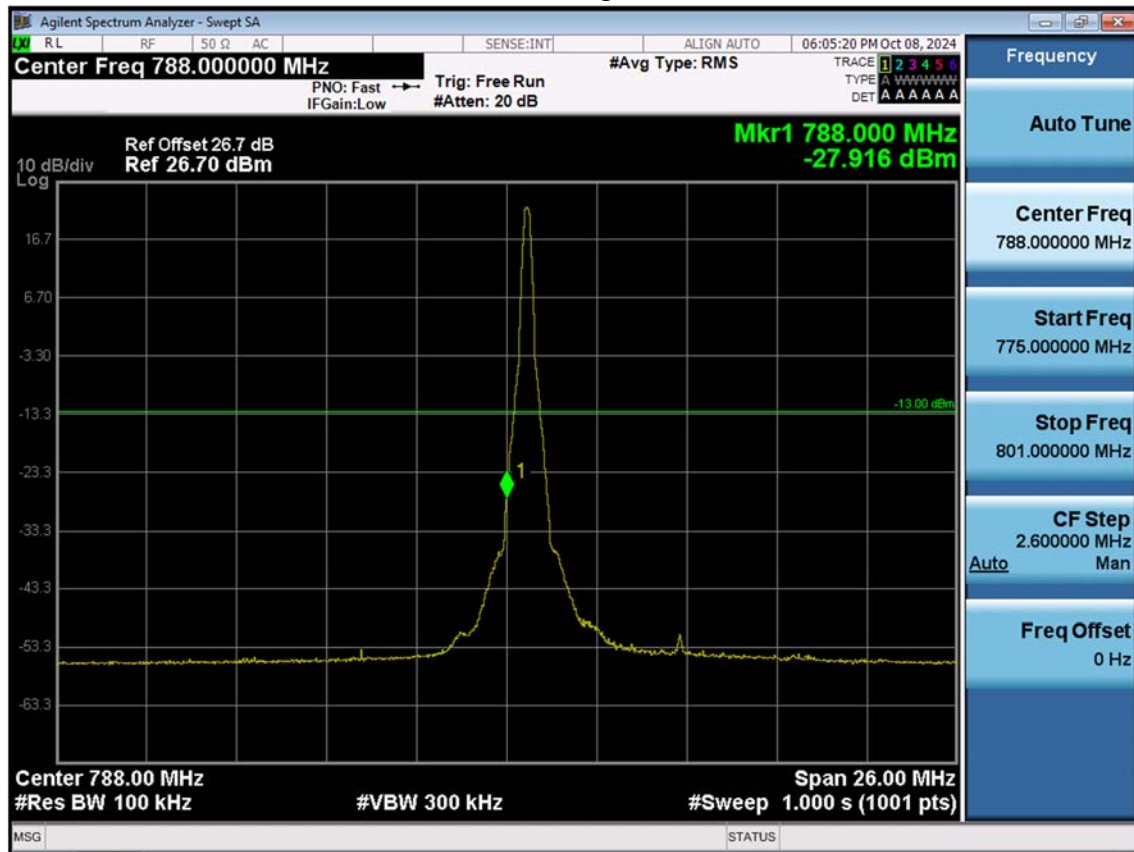
LTE B14_5 M_Extended Band Edge_High_QPSK_1RB



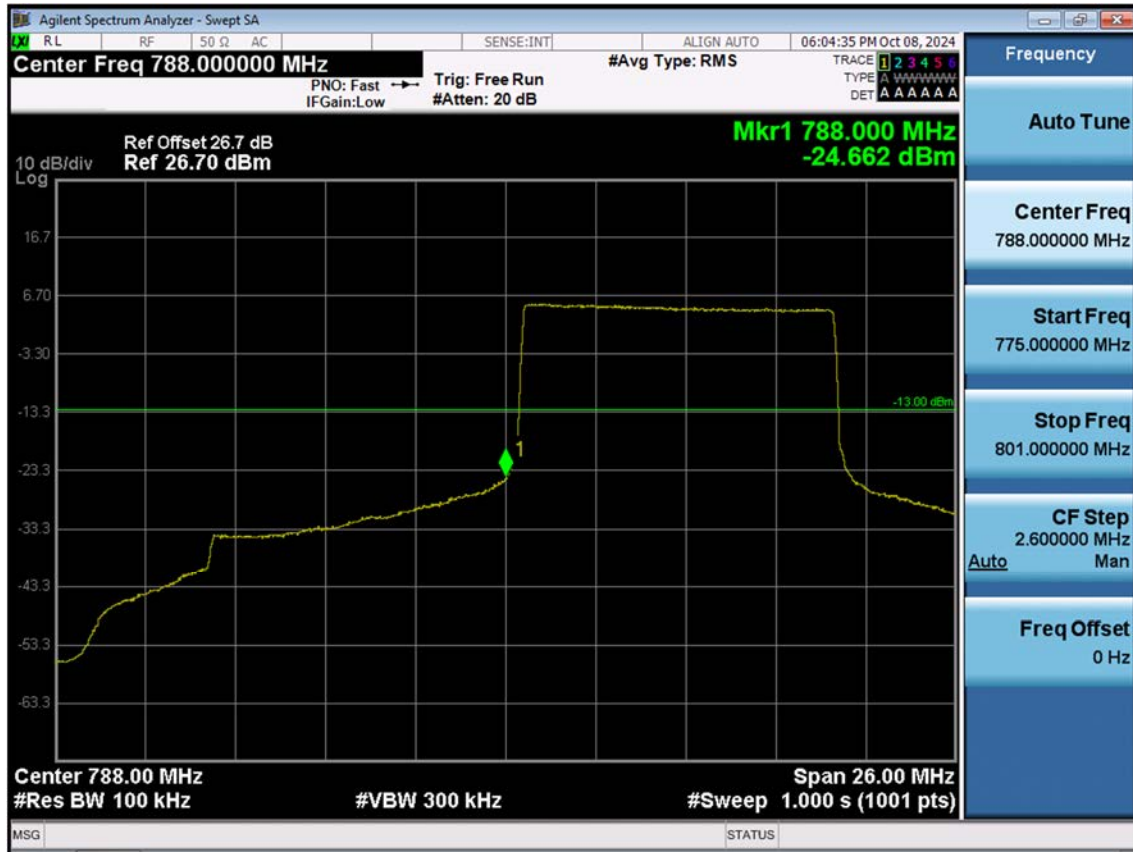
LTE B14_5 M_Extended Band Edge_High_QPSK_FullRB



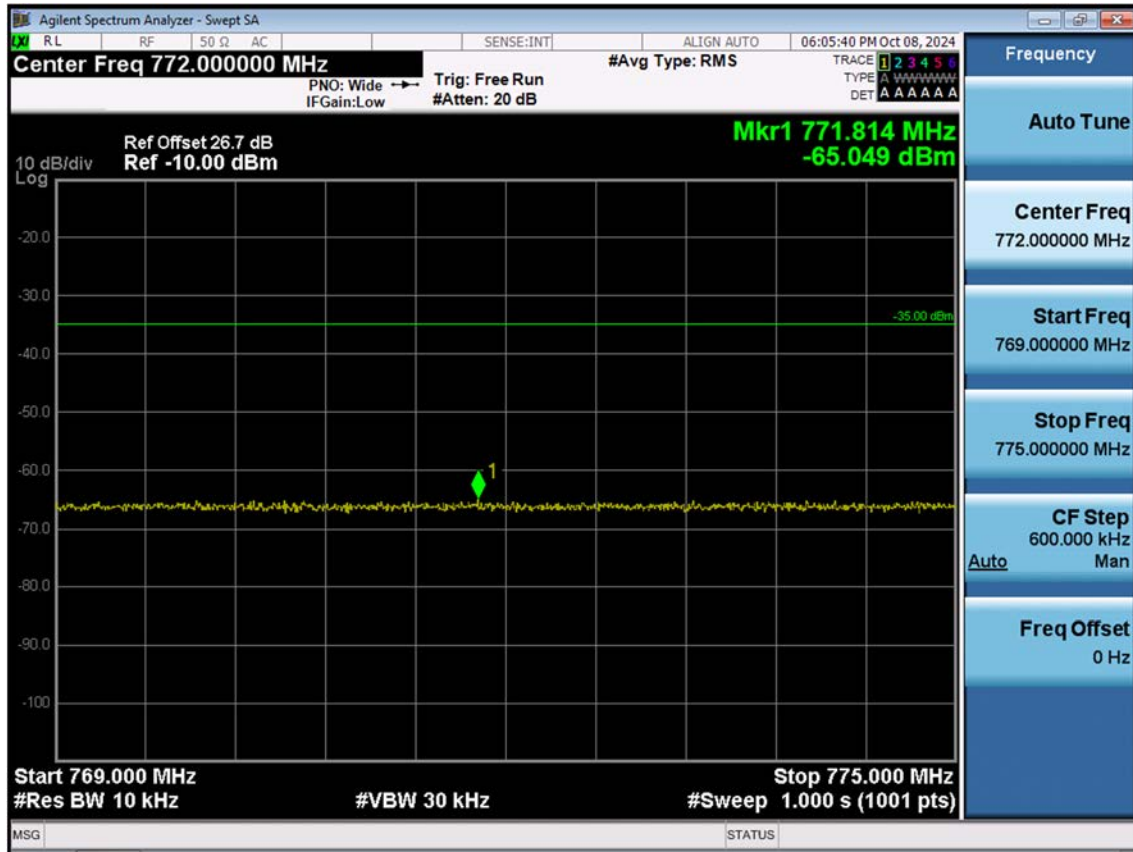
LTE B14_10 M_Band Edge_Low_QPSK_1RB



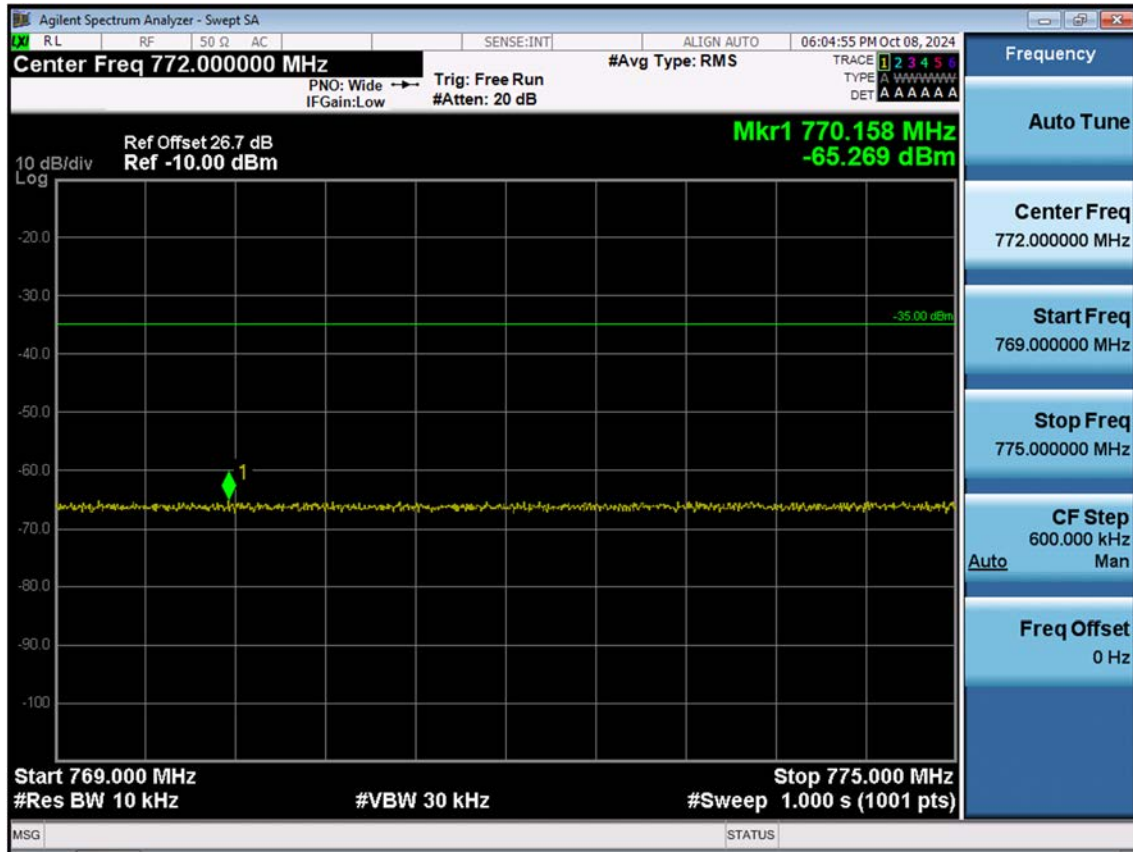
LTE B14_10 M_Band Edge_Low_QPSK_FullRB



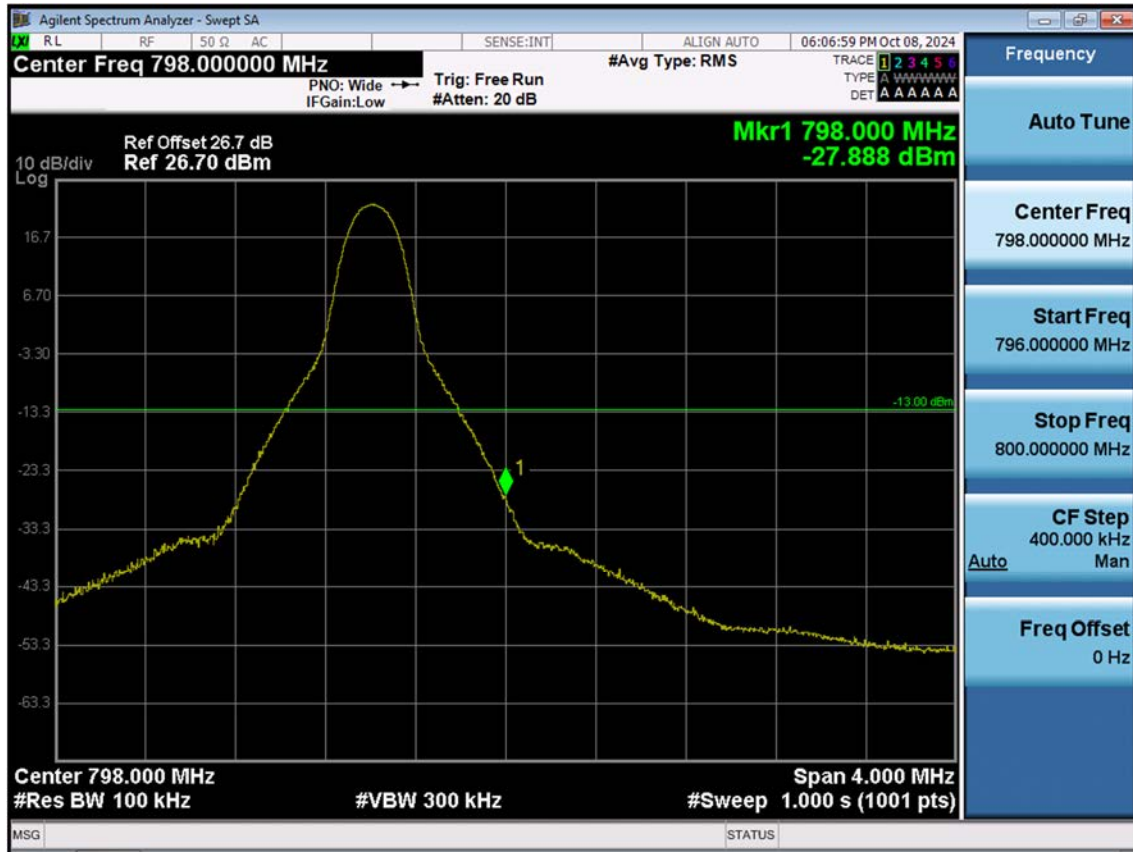
LTE B14_10 M_Extended Band Edge_Low_QPSK_1RB



LTE B14_10 M_Extended Band Edge_Low_QPSK_FullRB



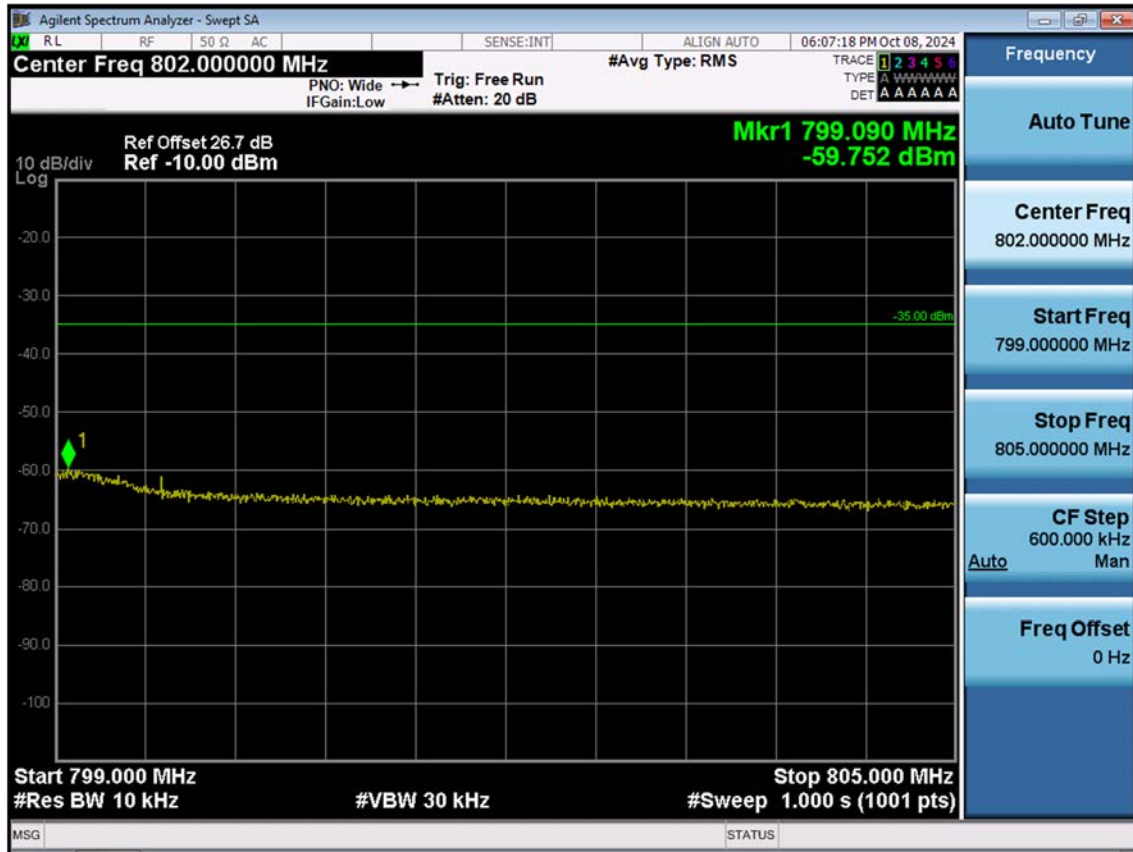
LTE B14_10 M_Band Edge_High_QPSK_1RB



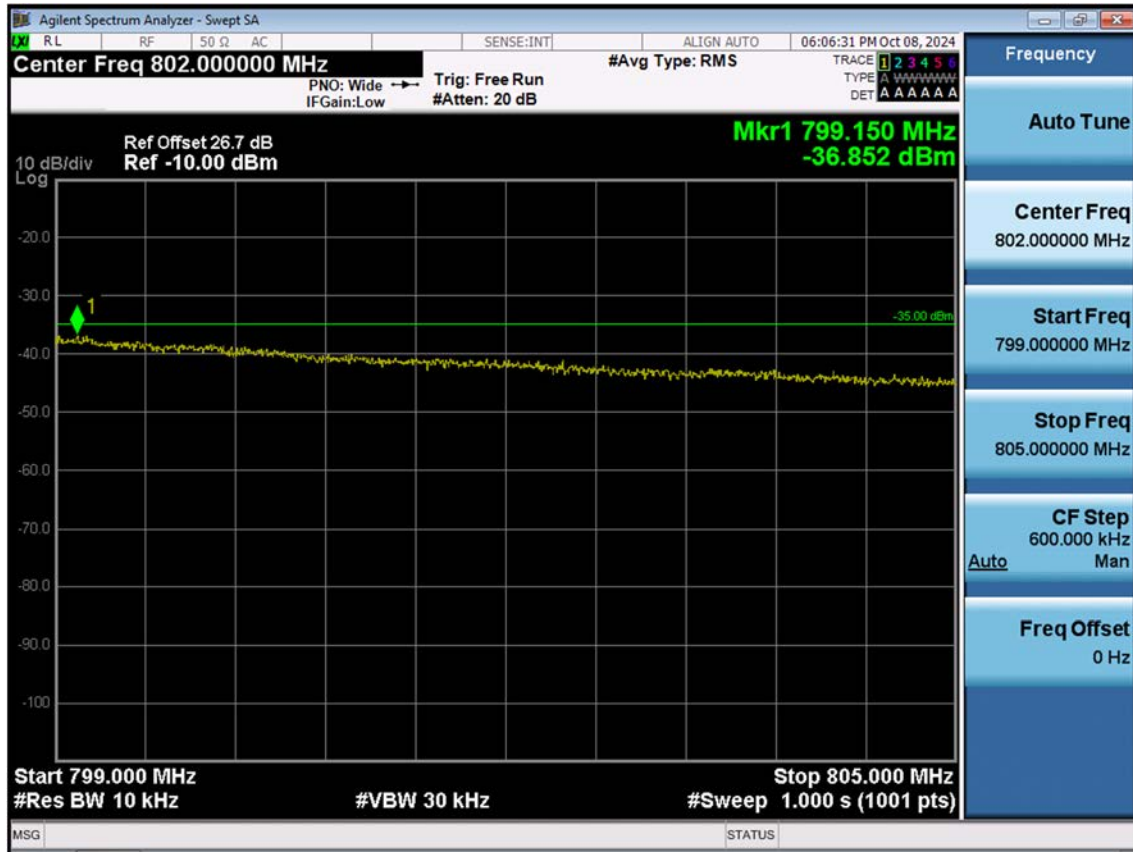
LTE B14_10 M_Band Edge_High_QPSK_FullRB



LTE B14_10 M_Extended Band Edge_High_QPSK_1RB

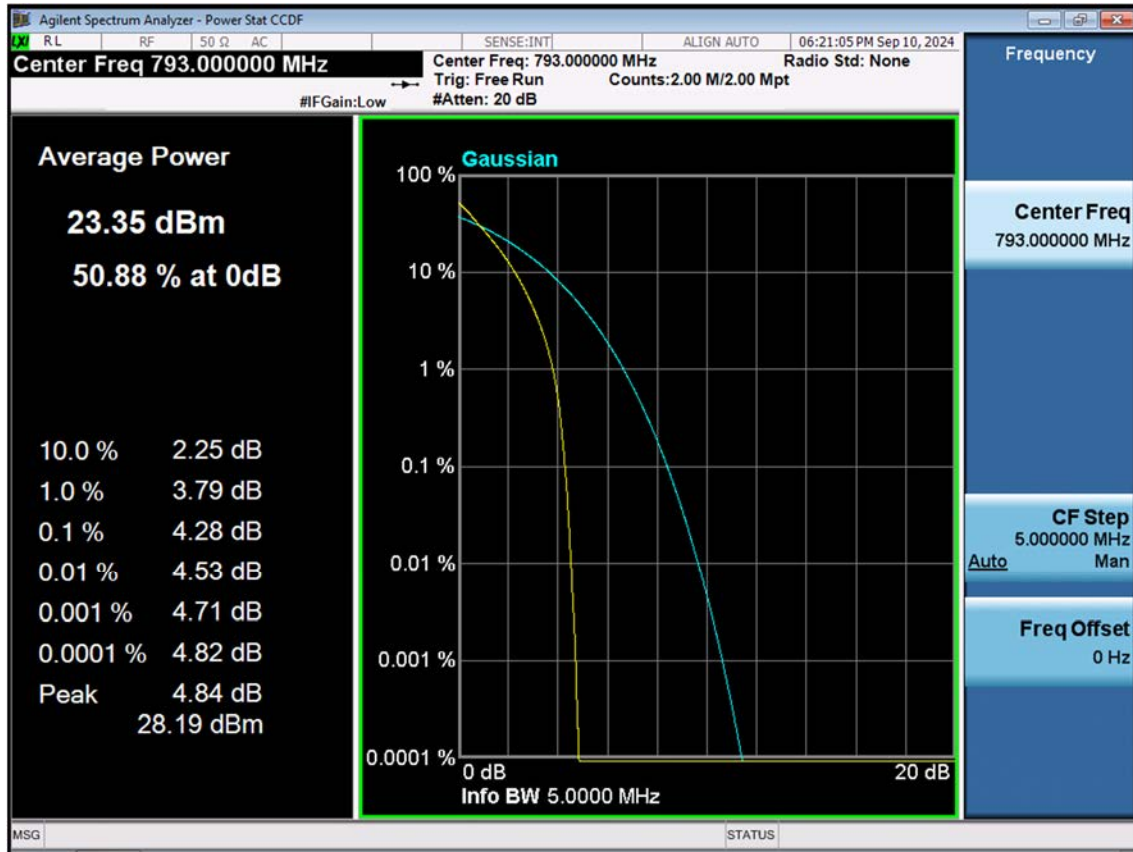


LTE B14_10 M_Extended Band Edge_High_QPSK_FullRB

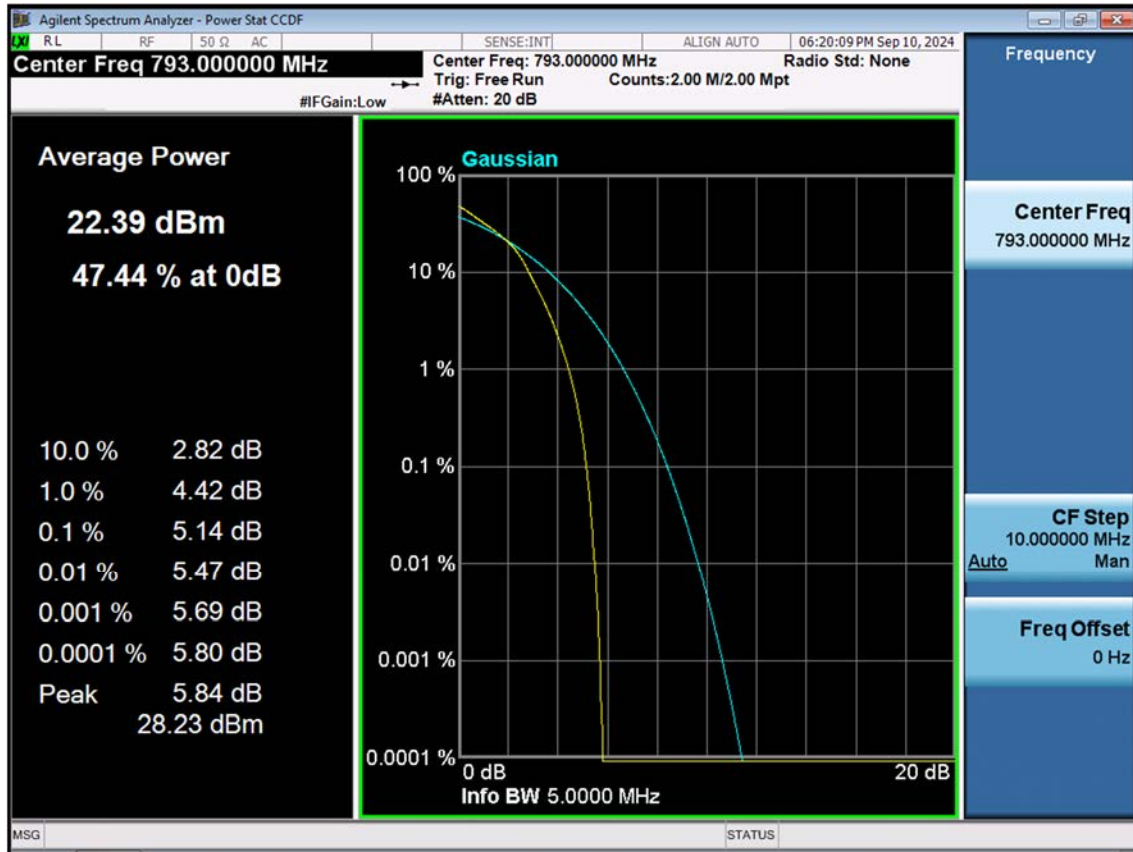


11 TEST PLOTS(Sub 1 ANT)

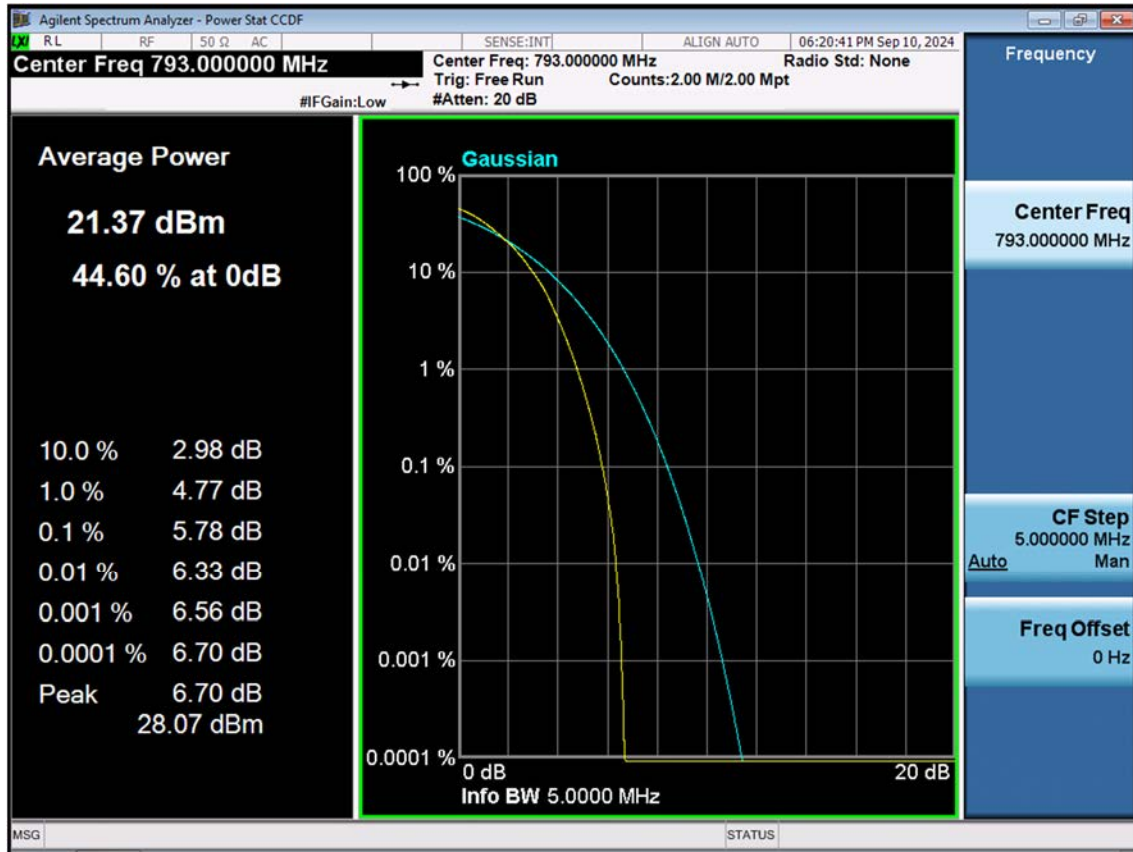
LTE B14_5 M_PAR_Mid_QPSK_FullRB



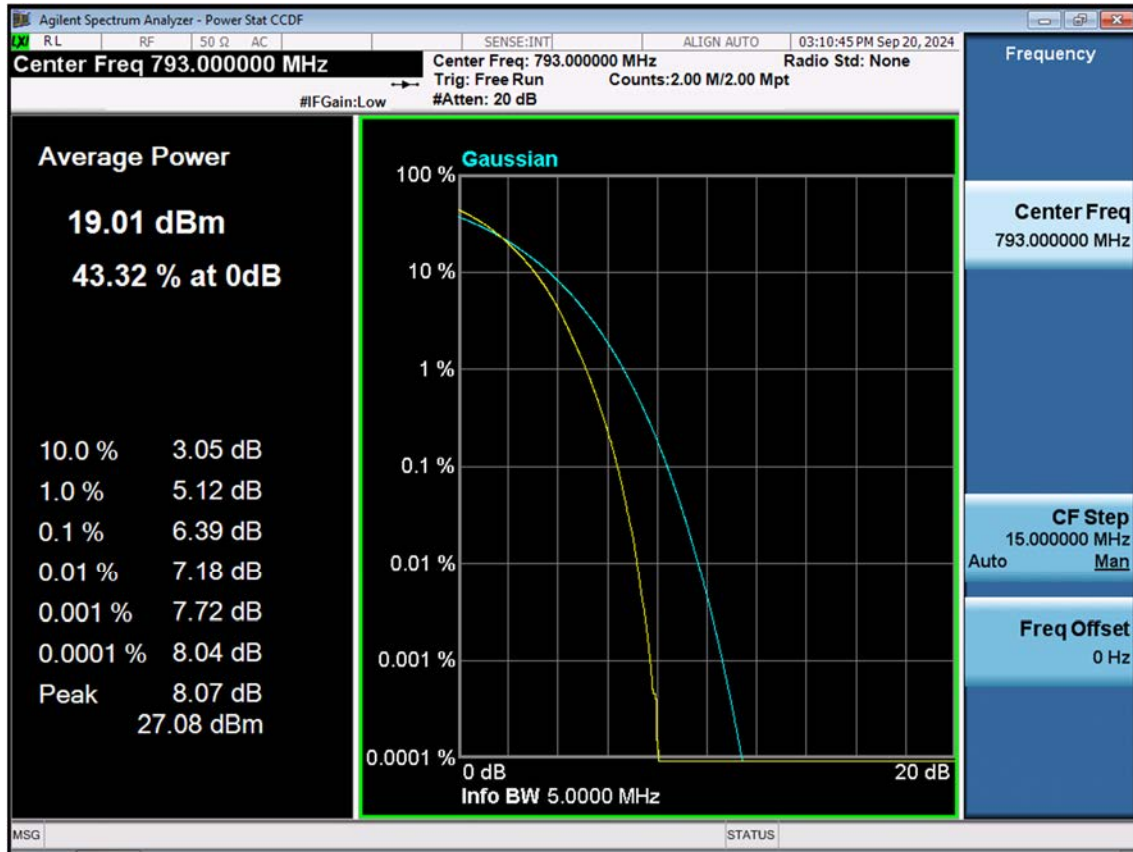
LTE B14_5 M_PAR_Mid_16QAM_FullRB



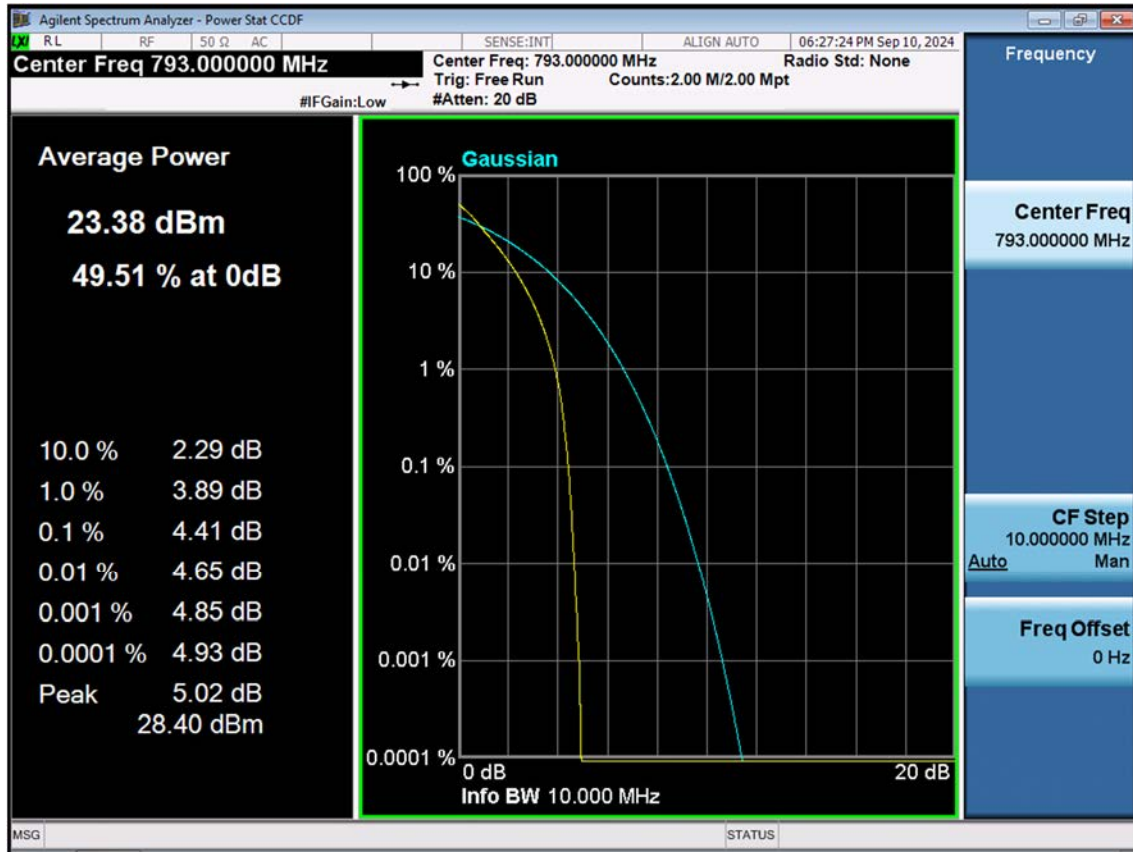
LTE B14_5 M_PAR_Mid_64QAM_FullRB



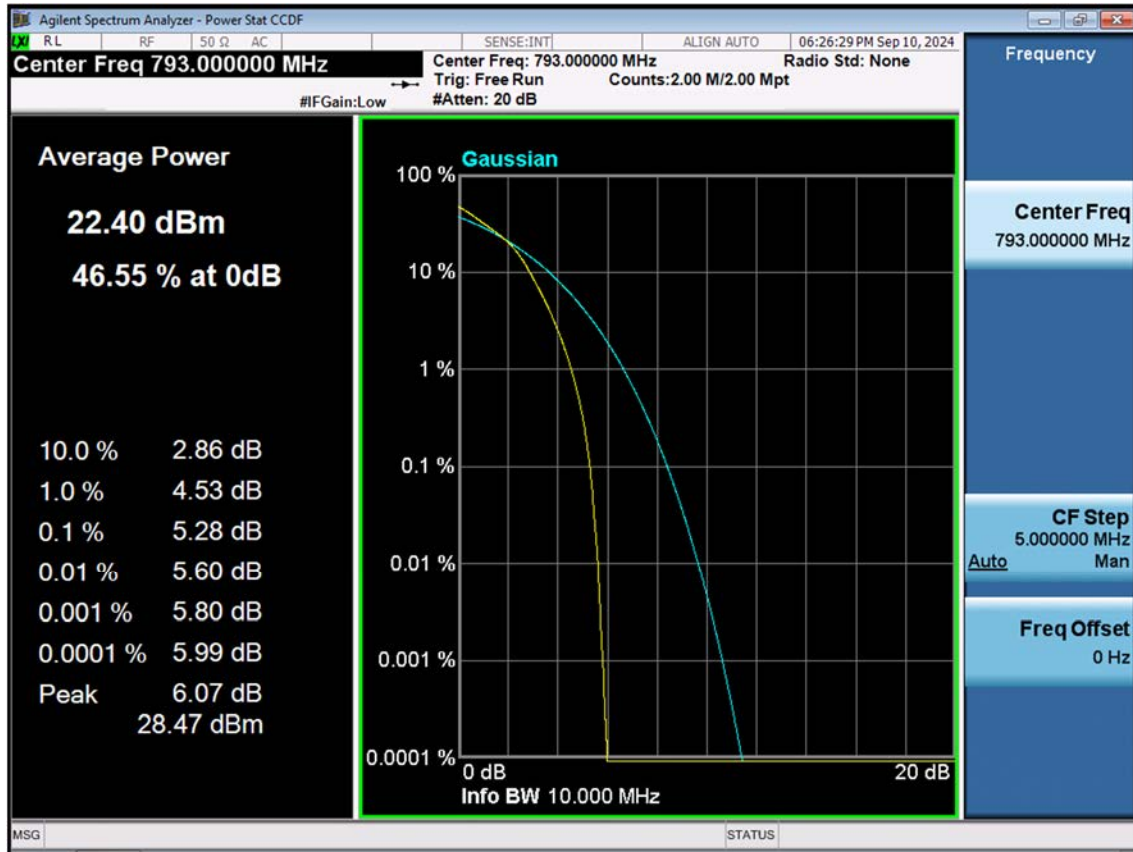
LTE B14_5 M_PAR_Mid_256QAM_FullRB



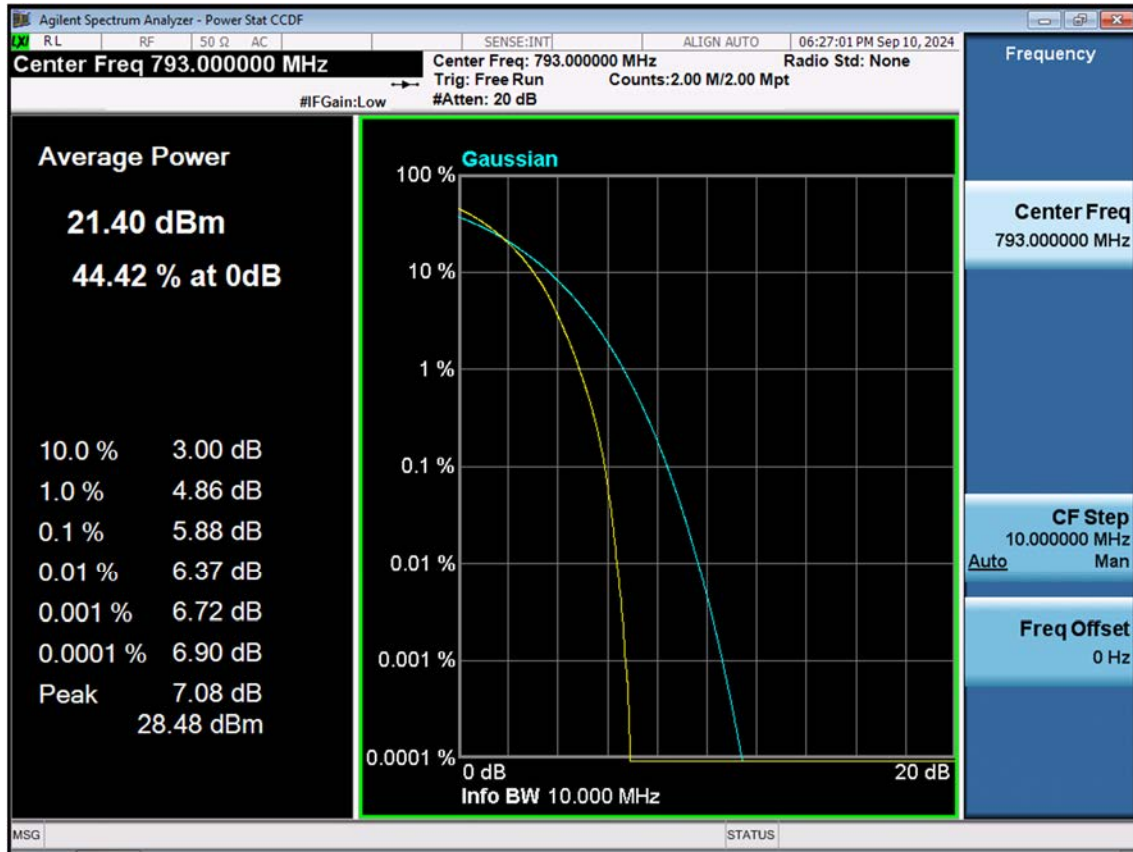
LTE B14_10 M_PAR_Mid_QPSK_FullRB



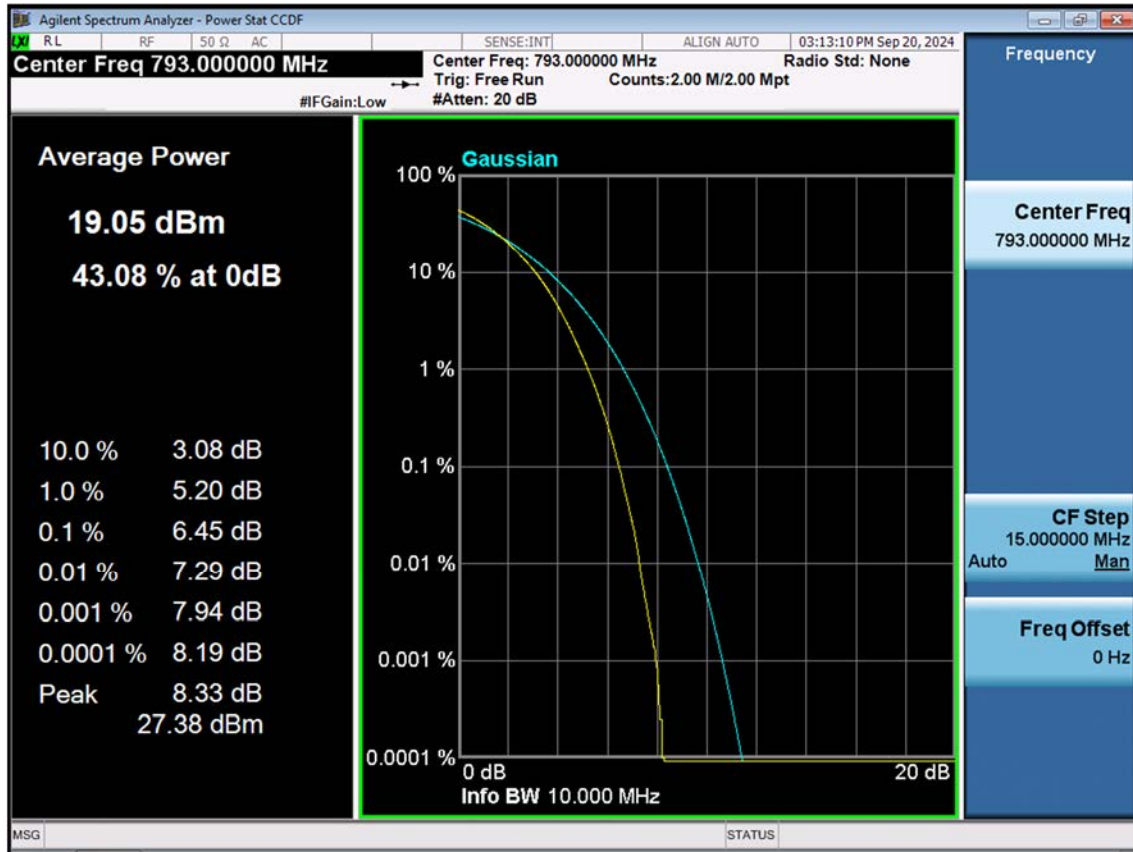
LTE B14_10 M_PAR_Mid_16QAM_FullRB



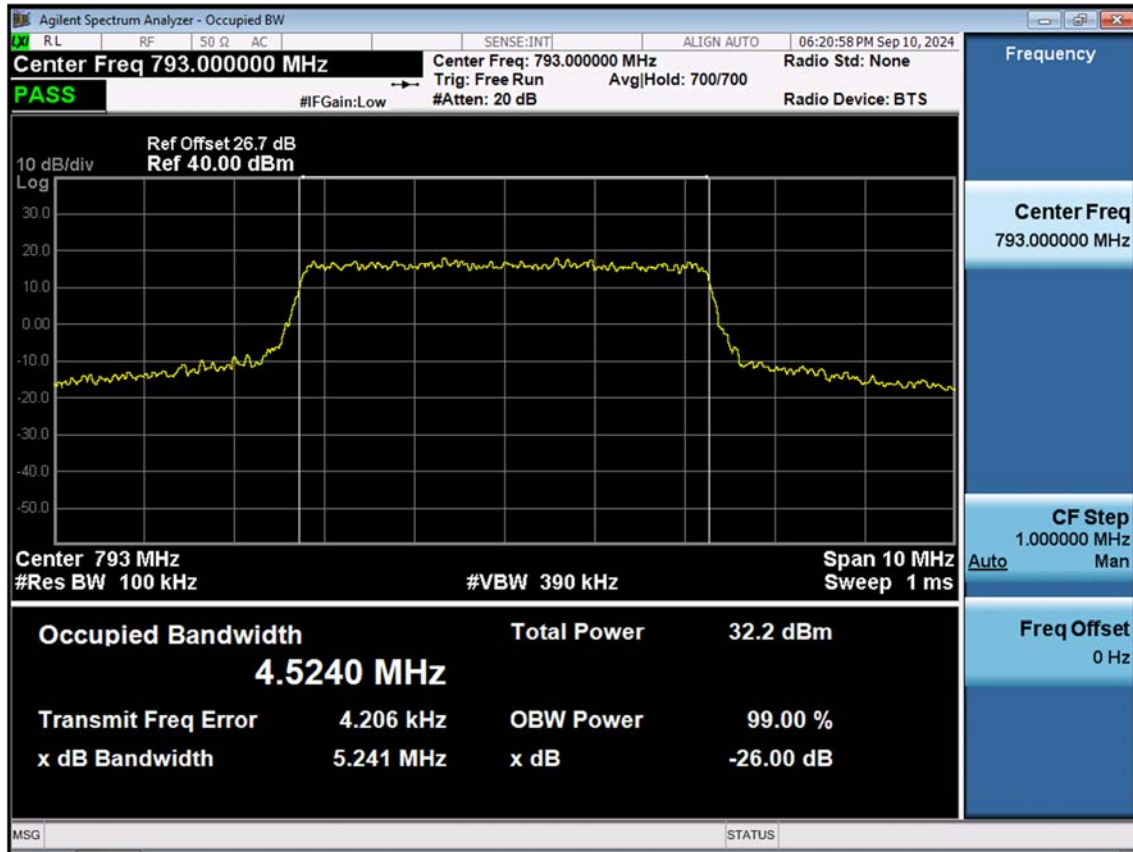
LTE B14_10 M_PAR_Mid_64QAM_FullRB



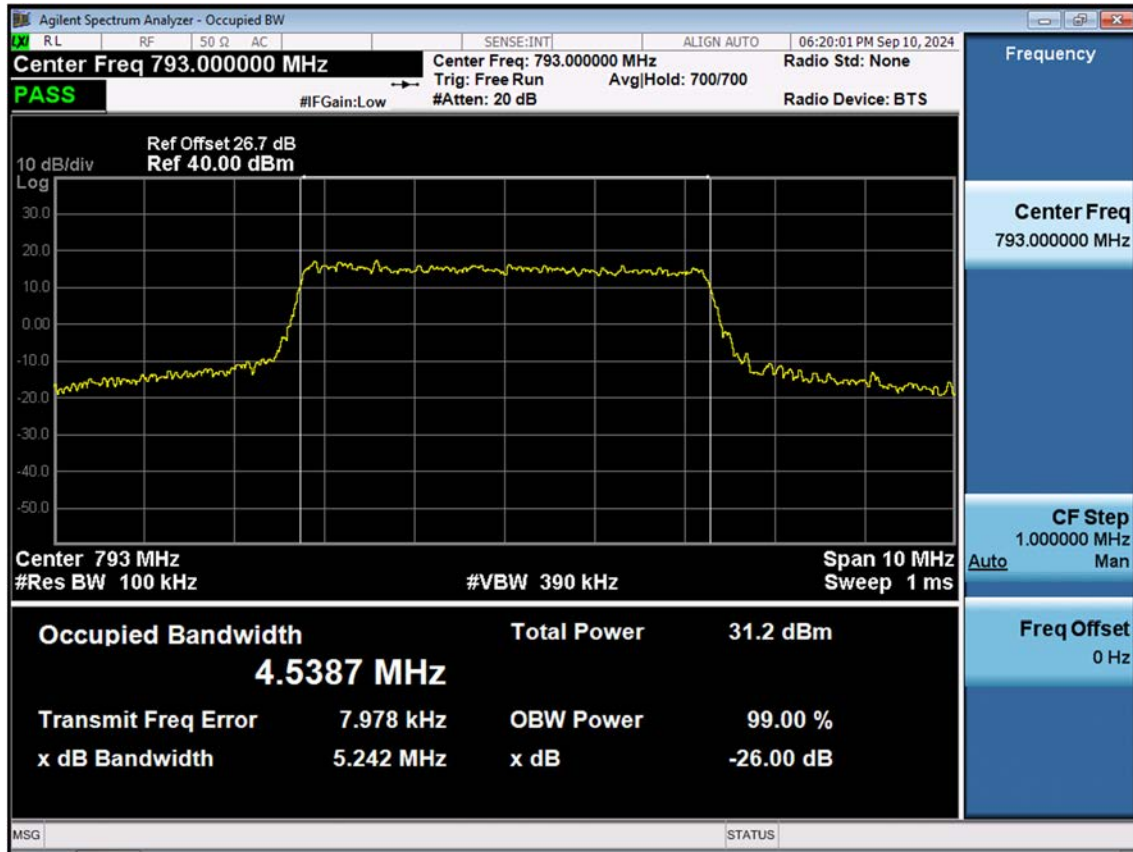
LTE B14_10 M_PAR_Mid_256QAM_FullRB



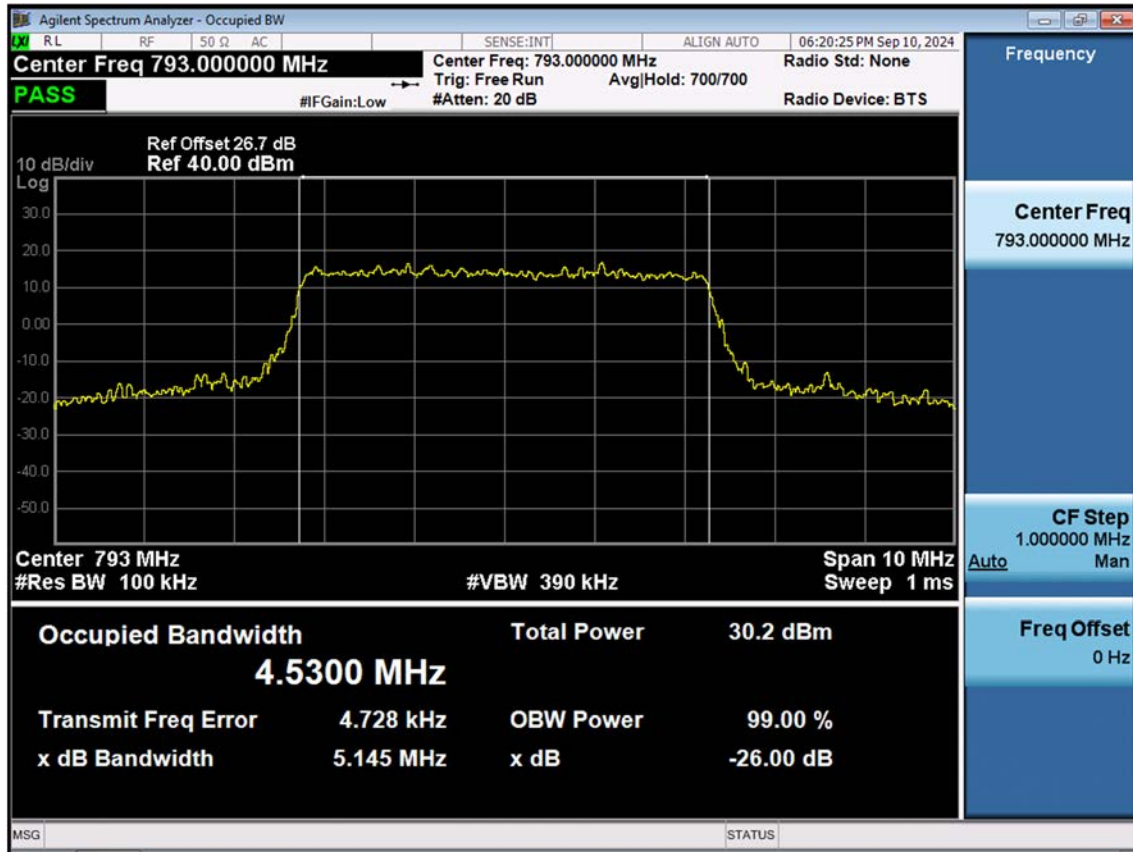
LTE B14_5 M_OBW_Mid_QPSK_FullRB



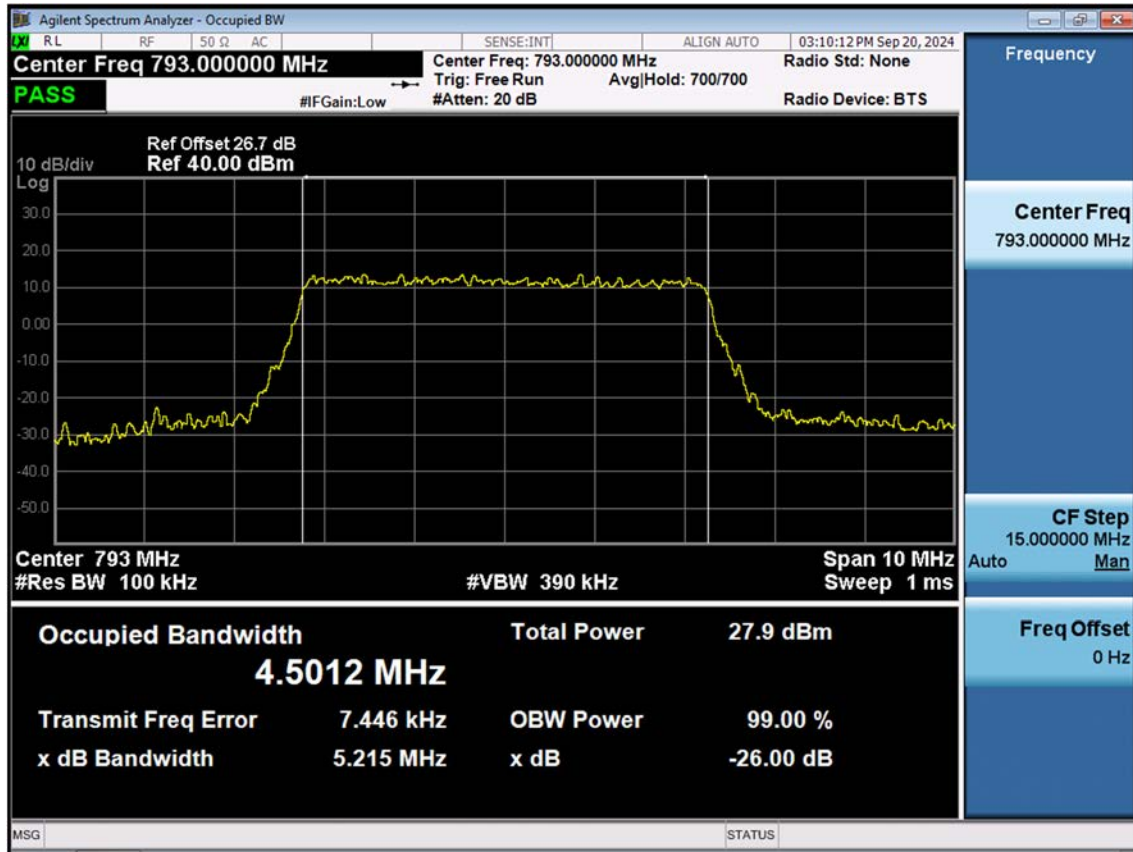
LTE B14_5 M_OBW_Mid_16QAM_FullRB



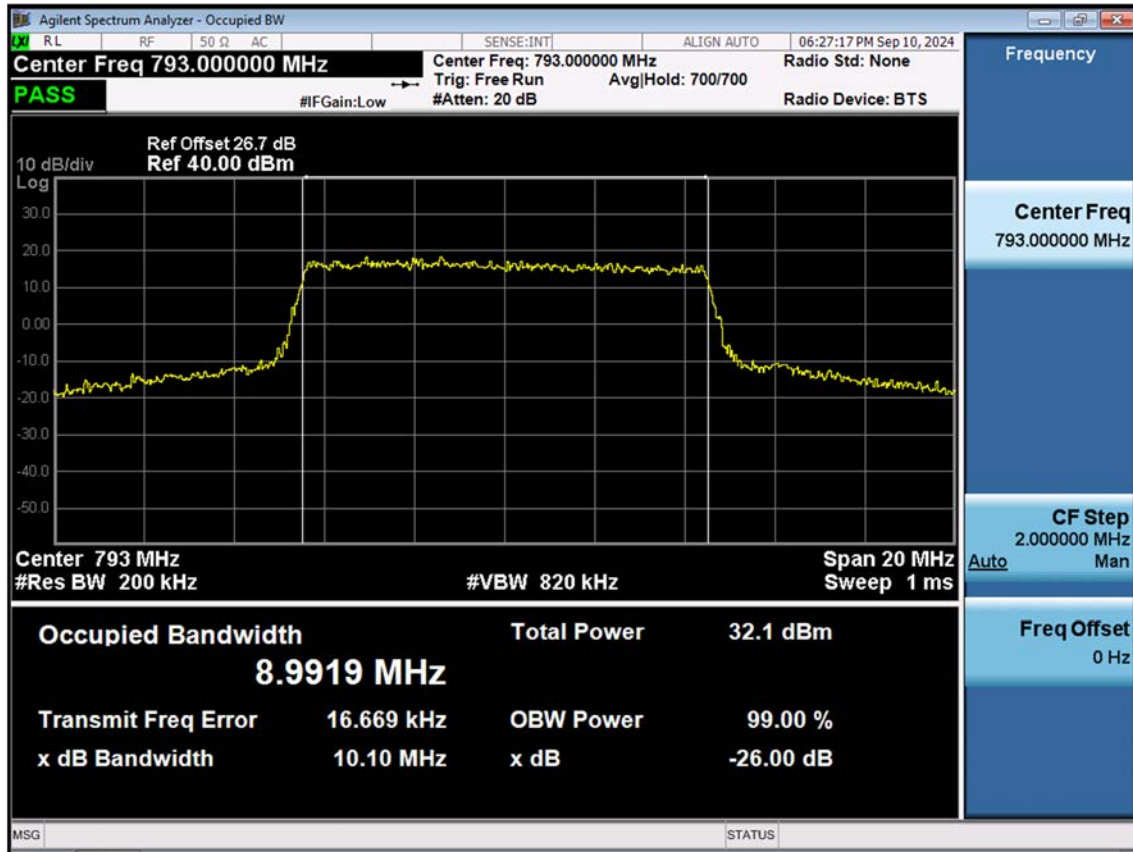
LTE B14_5 M_OBW_Mid_64QAM_FullRB



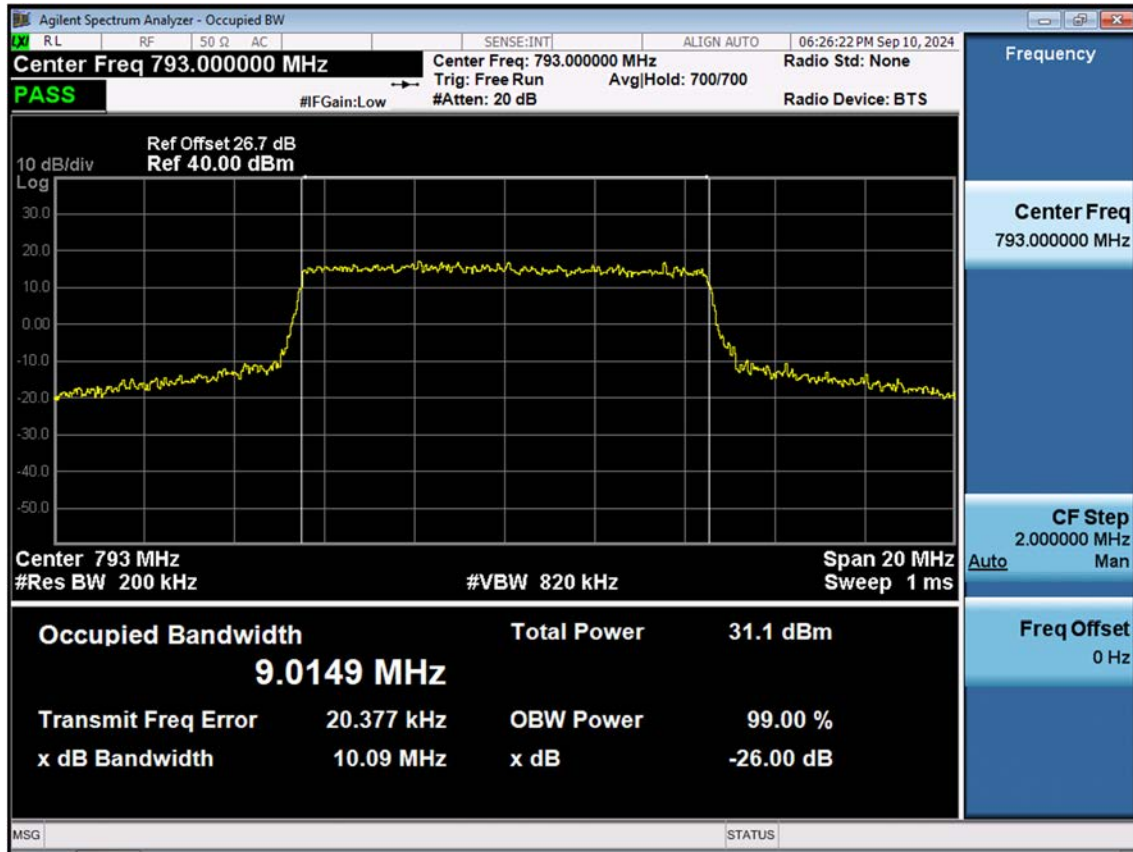
LTE B14_5 M_OBW_Mid_256QAM_FullRB



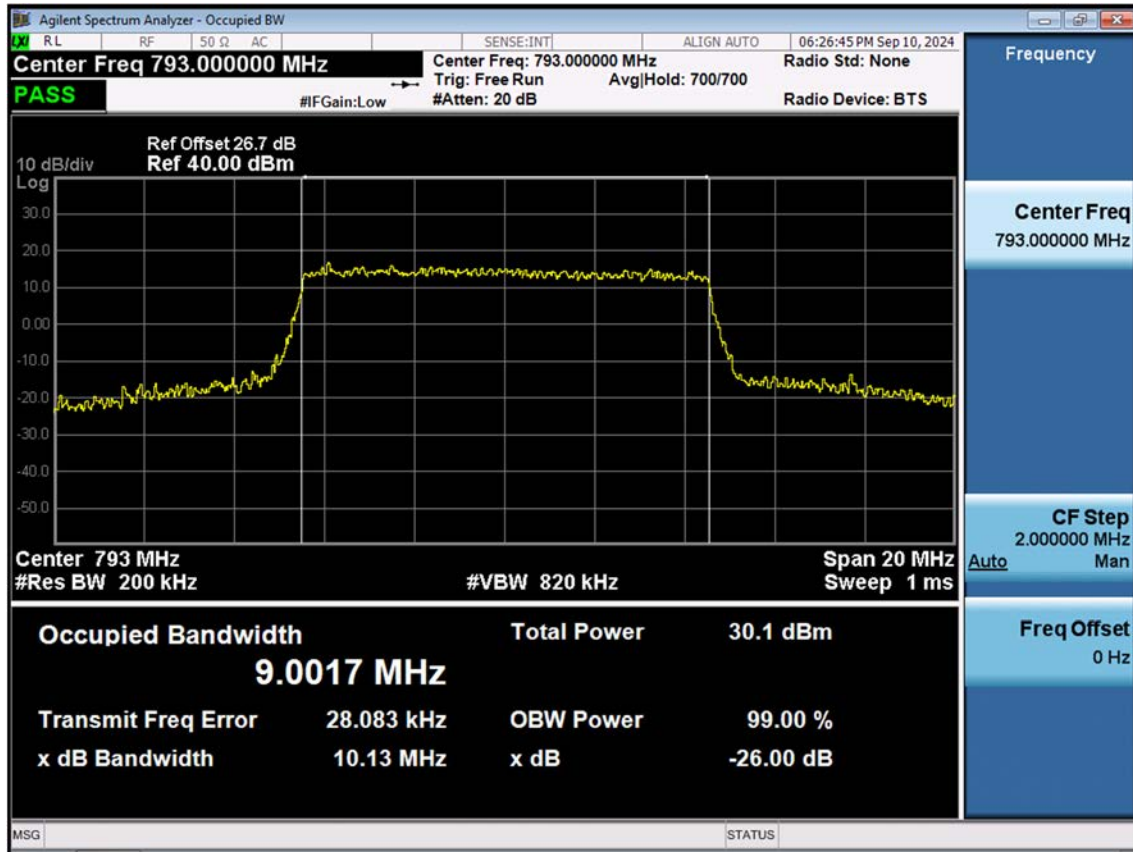
LTE B14_10 M_OBW_Mid_QPSK_FullRB



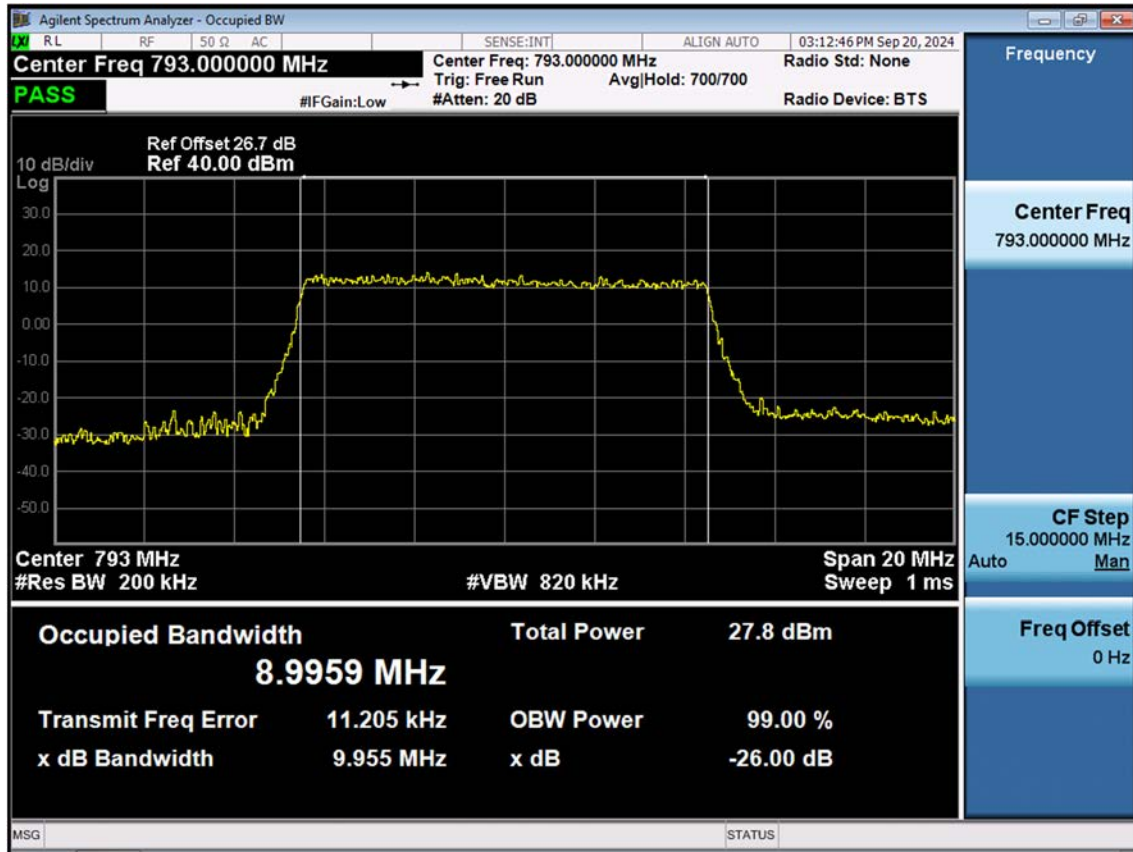
LTE B14_10 M_OBW_Mid_16QAM_FullRB



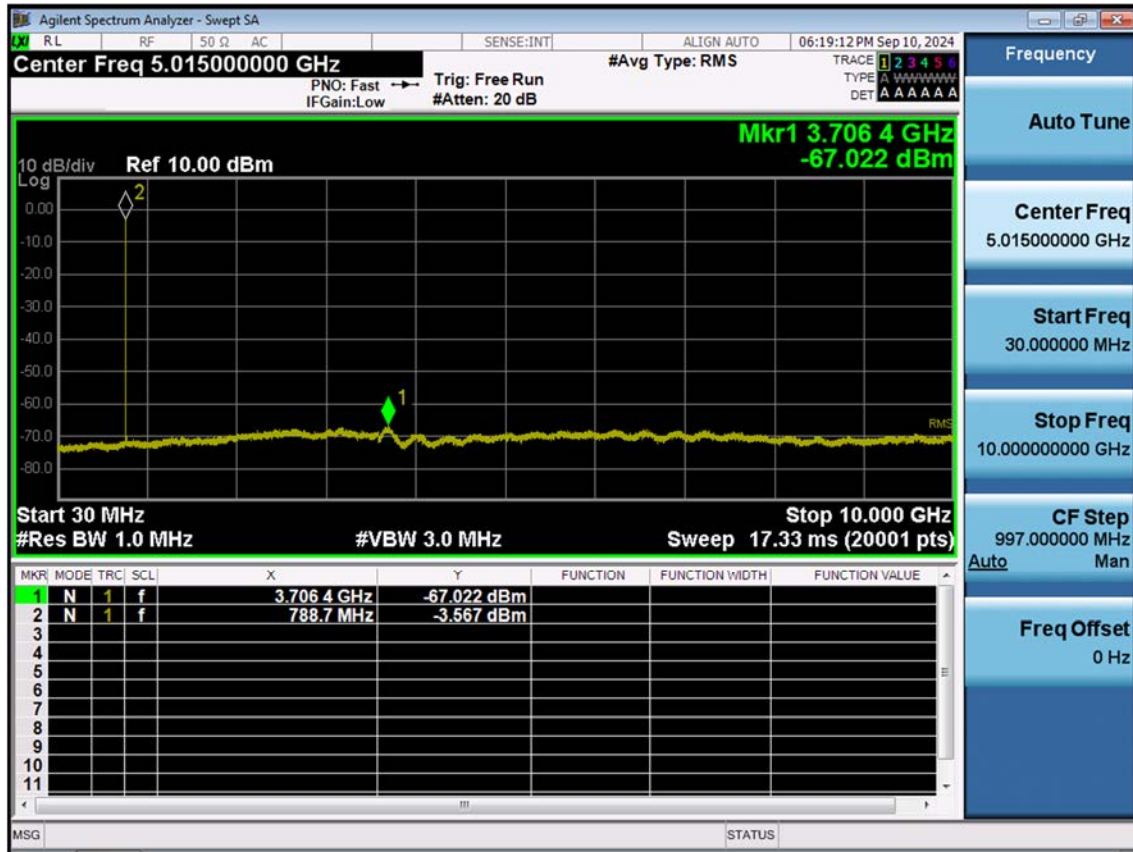
LTE B14_10 M_OBW_Mid_64QAM_FullRB



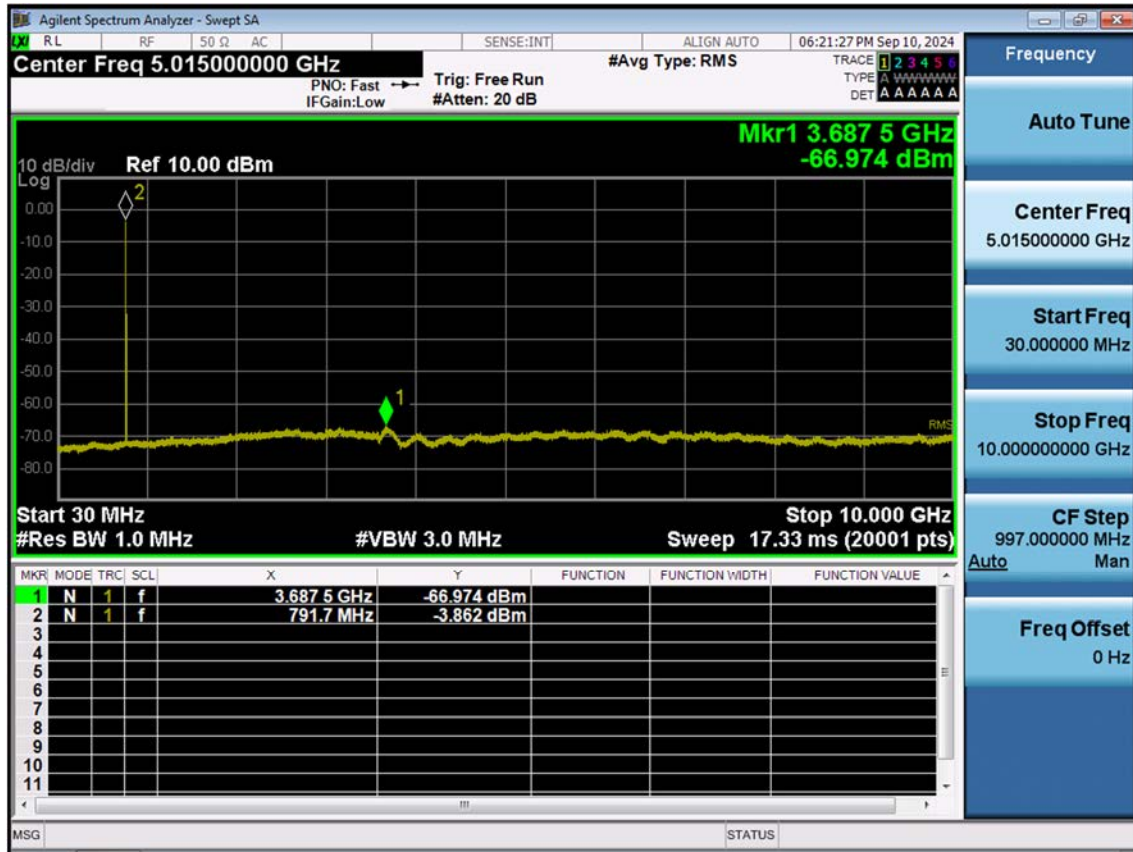
LTE B14_10 M_OBW_Mid_256QAM_FullRB



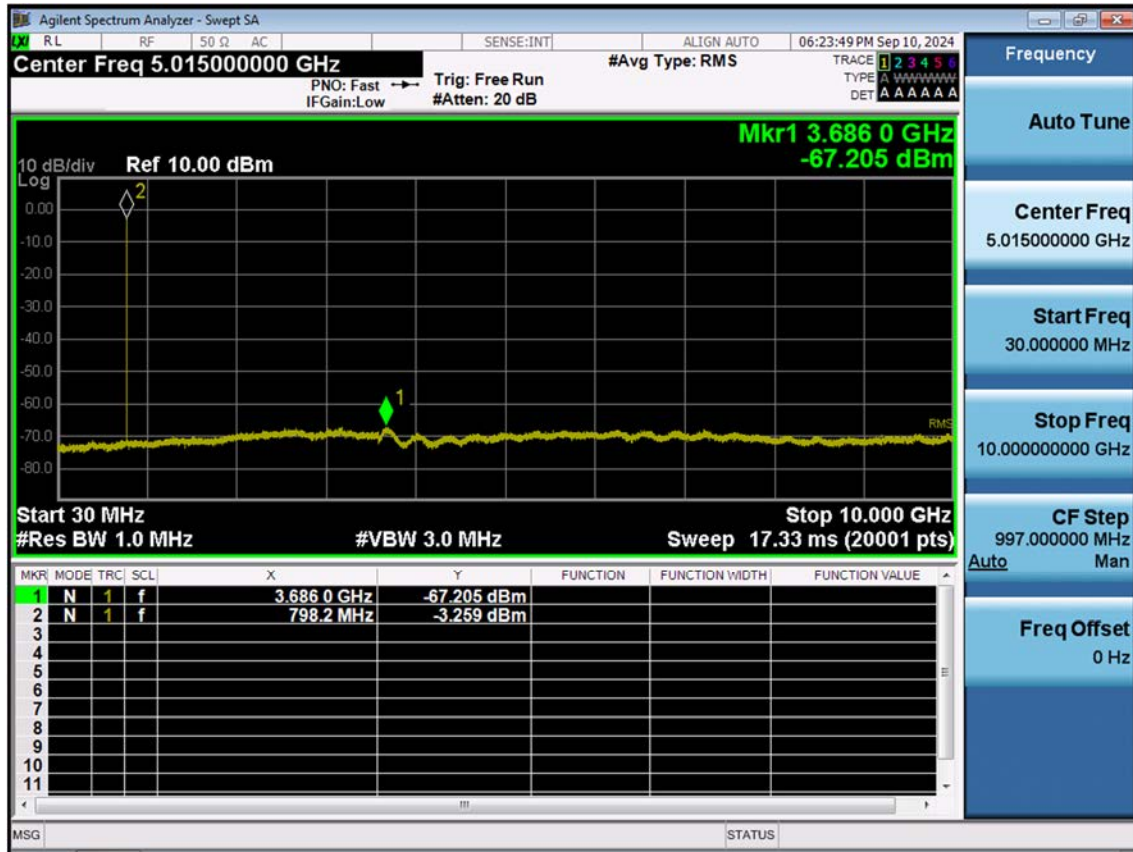
LTE B14_5 M_Conducted Spurious(30 M-10 G)_Low_QPSK_1RB



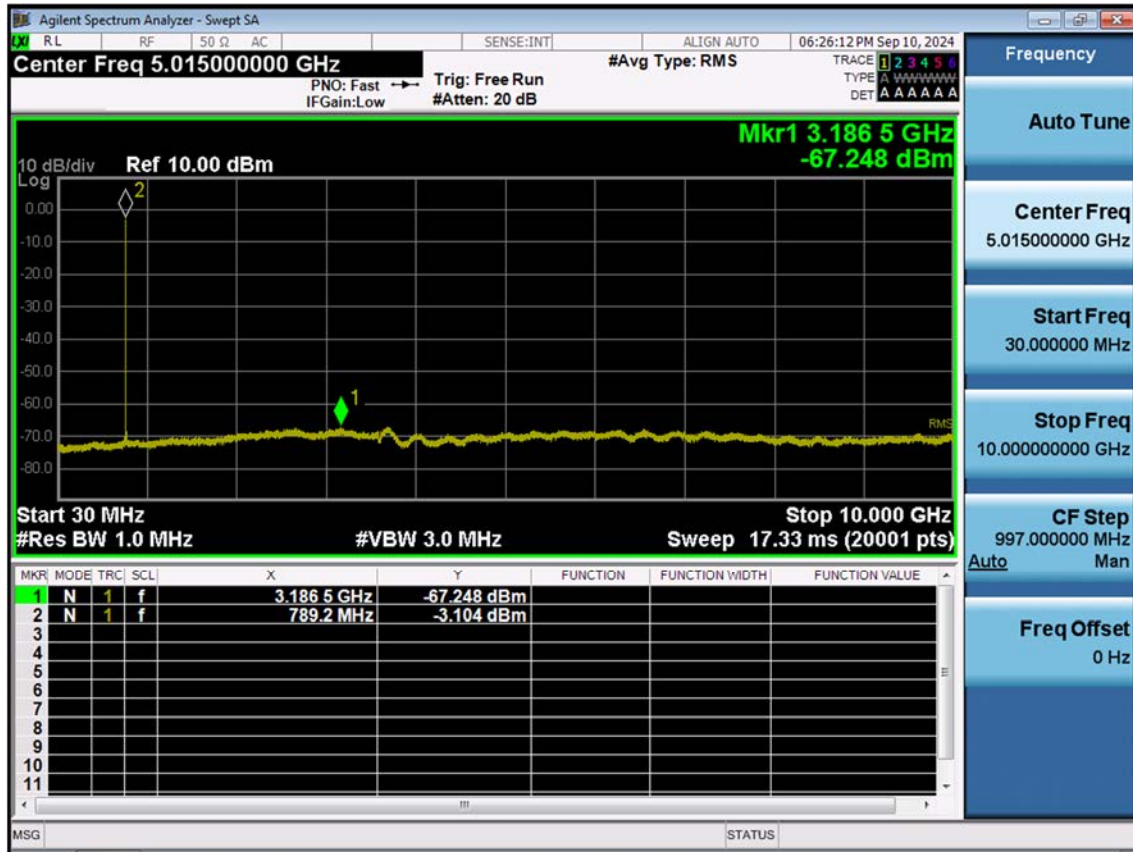
LTE B14_5 M_Conducted Spurious(30 M-10 G)_Mid_QPSK_1RB

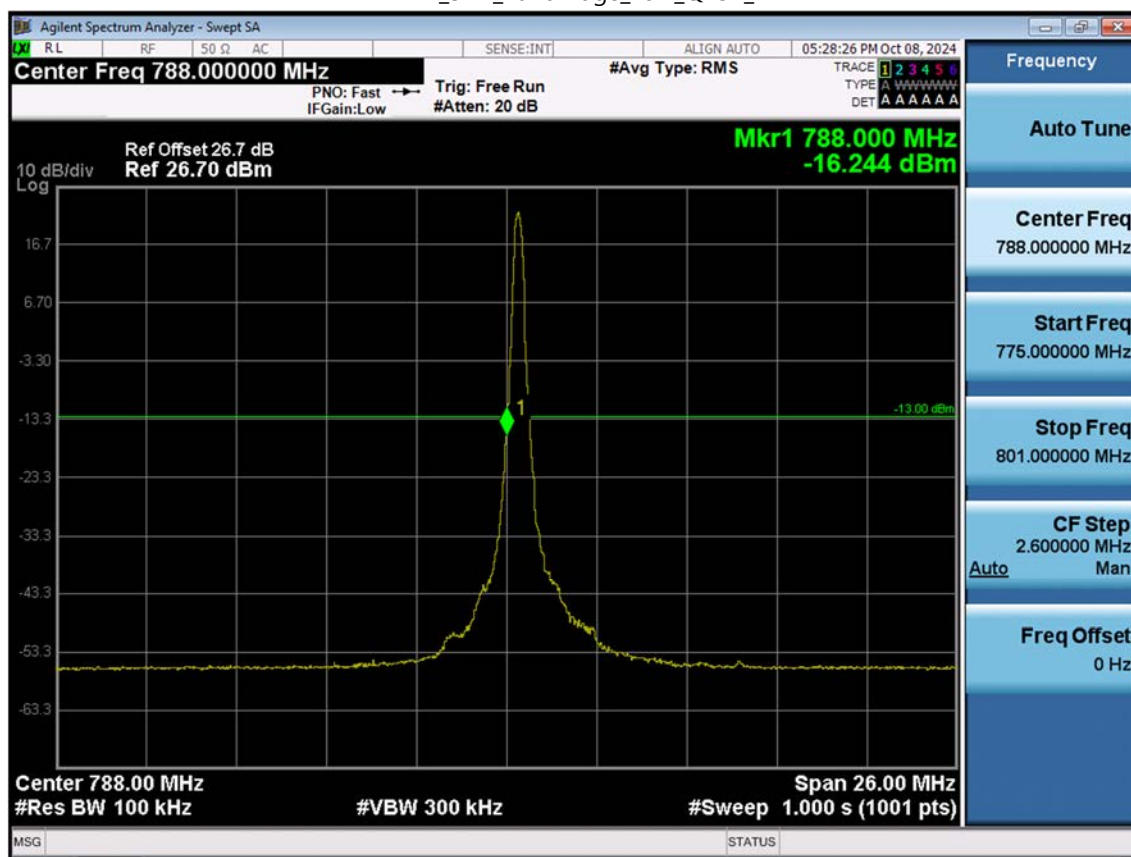


LTE B14_5 M_Conducted Spurious(30 M-10 G)_High_QPSK_1RB



LTE B14_10 M_Conducted Spurious(30 M-10 G)_Low_QPSK_1RB

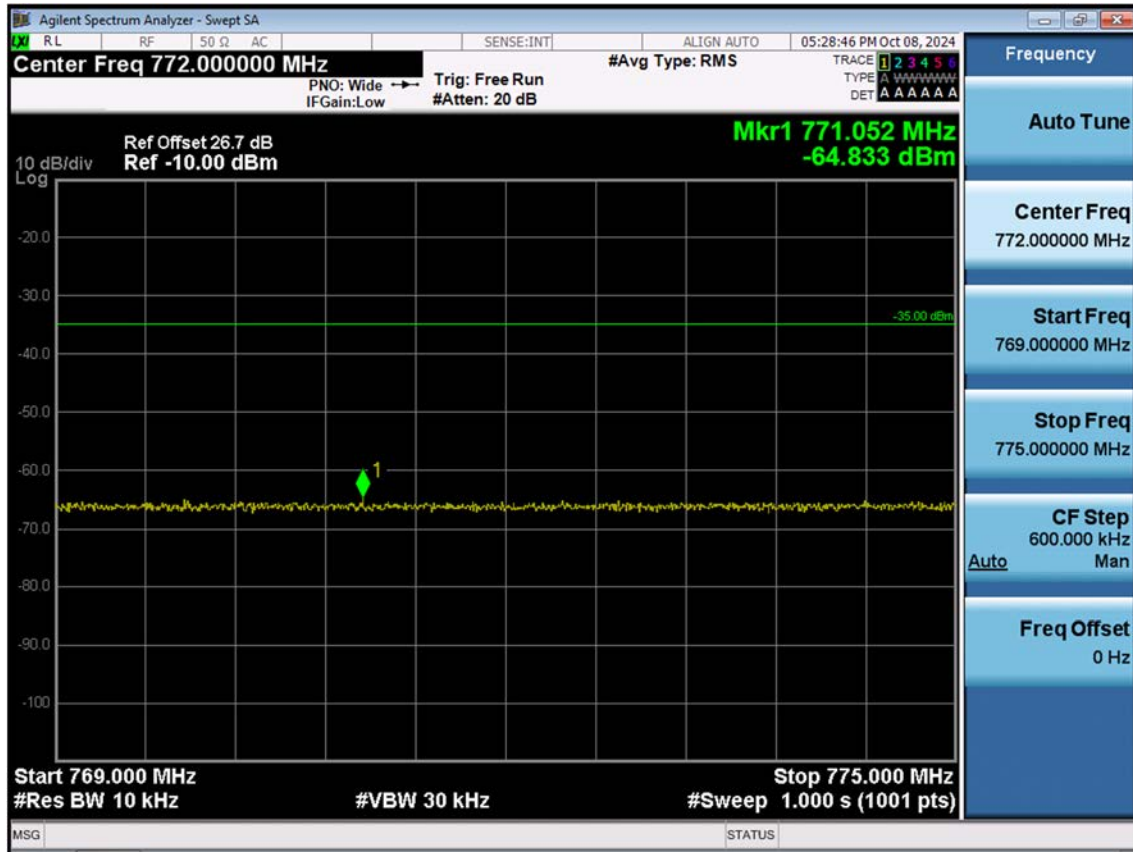




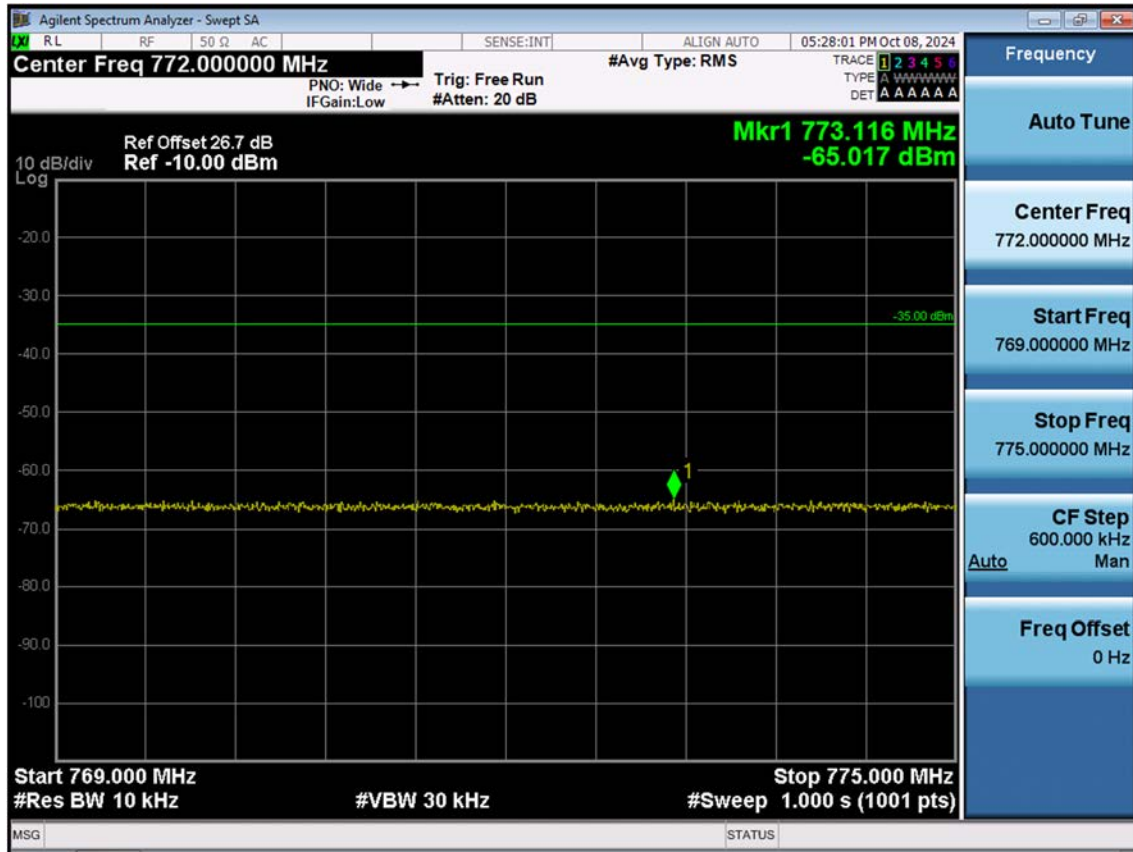
LTE B14_5 M_Band Edge_Low_QPSK_FullRB



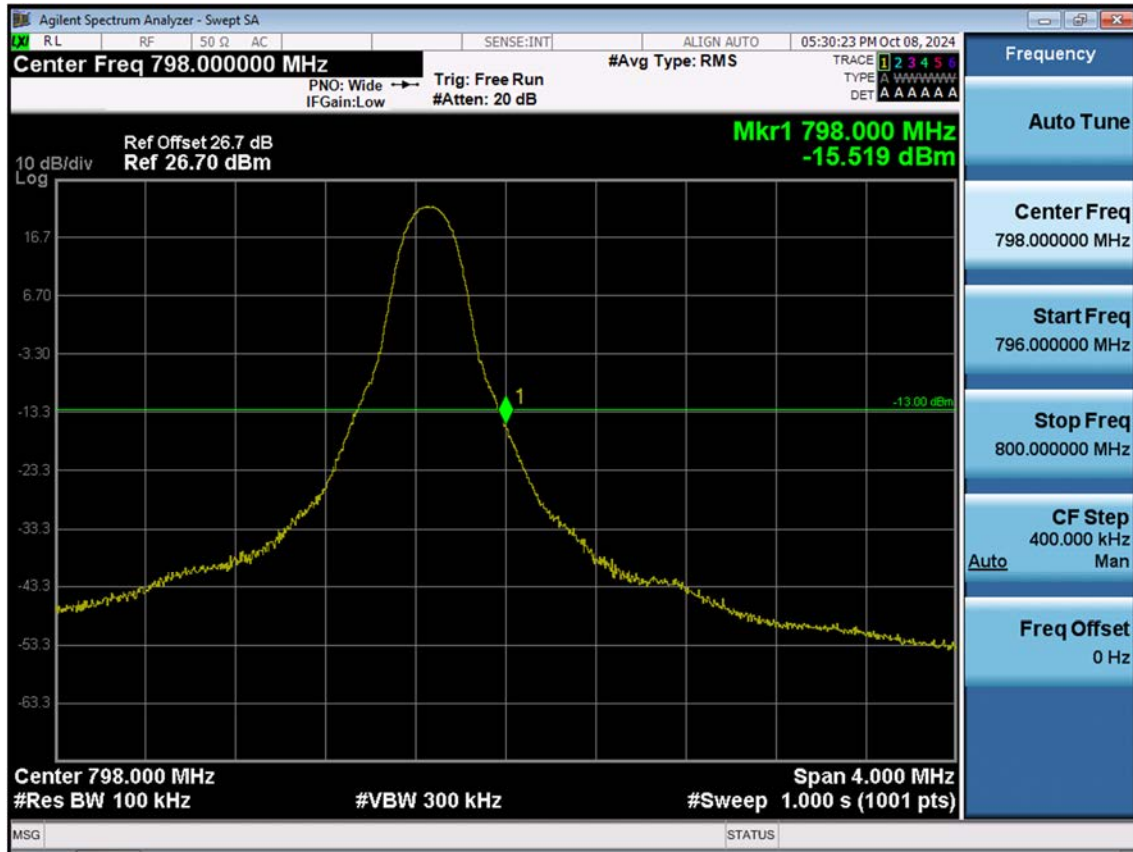
LTE B14_5 M_Extended Band Edge_Low_QPSK_1RB



LTE B14_5 M_Extended Band Edge_Low_QPSK_FullRB



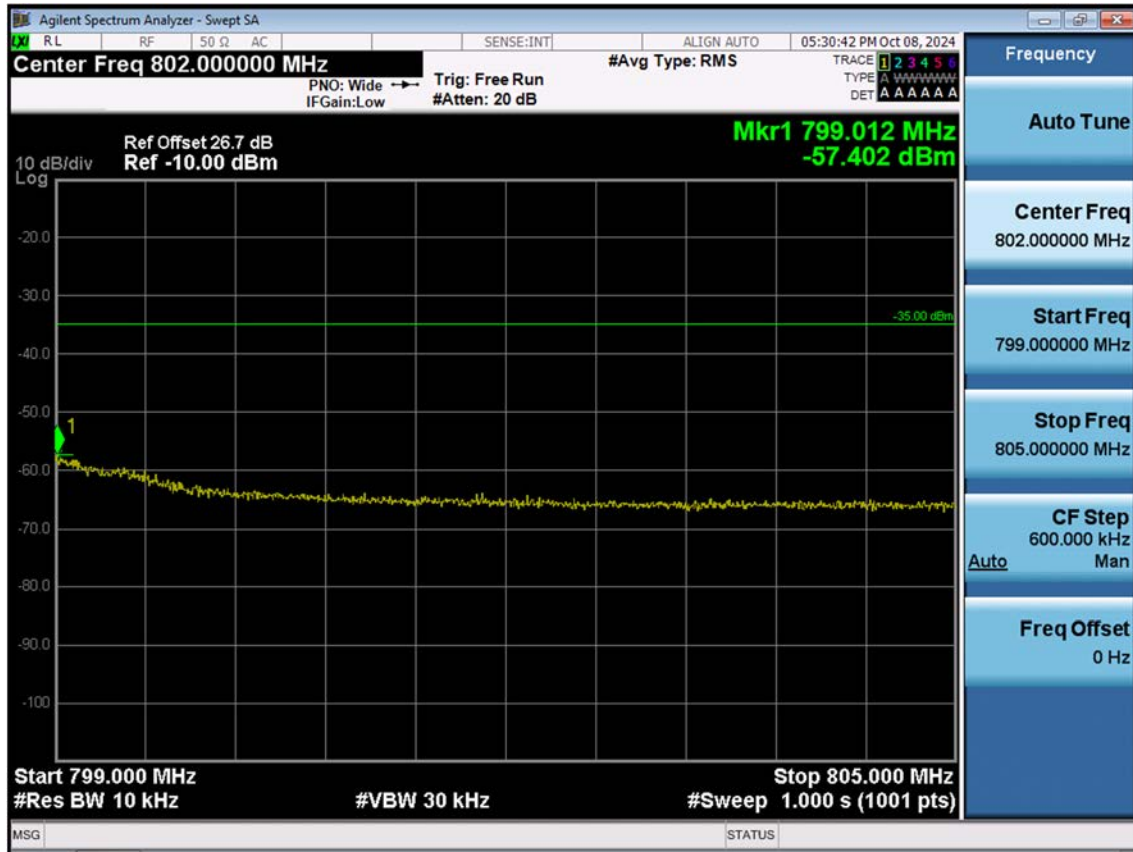
LTE B14_5 M_Band Edge_High_QPSK_1RB



LTE B14_5 M_Band Edge_High_QPSK_FullRB



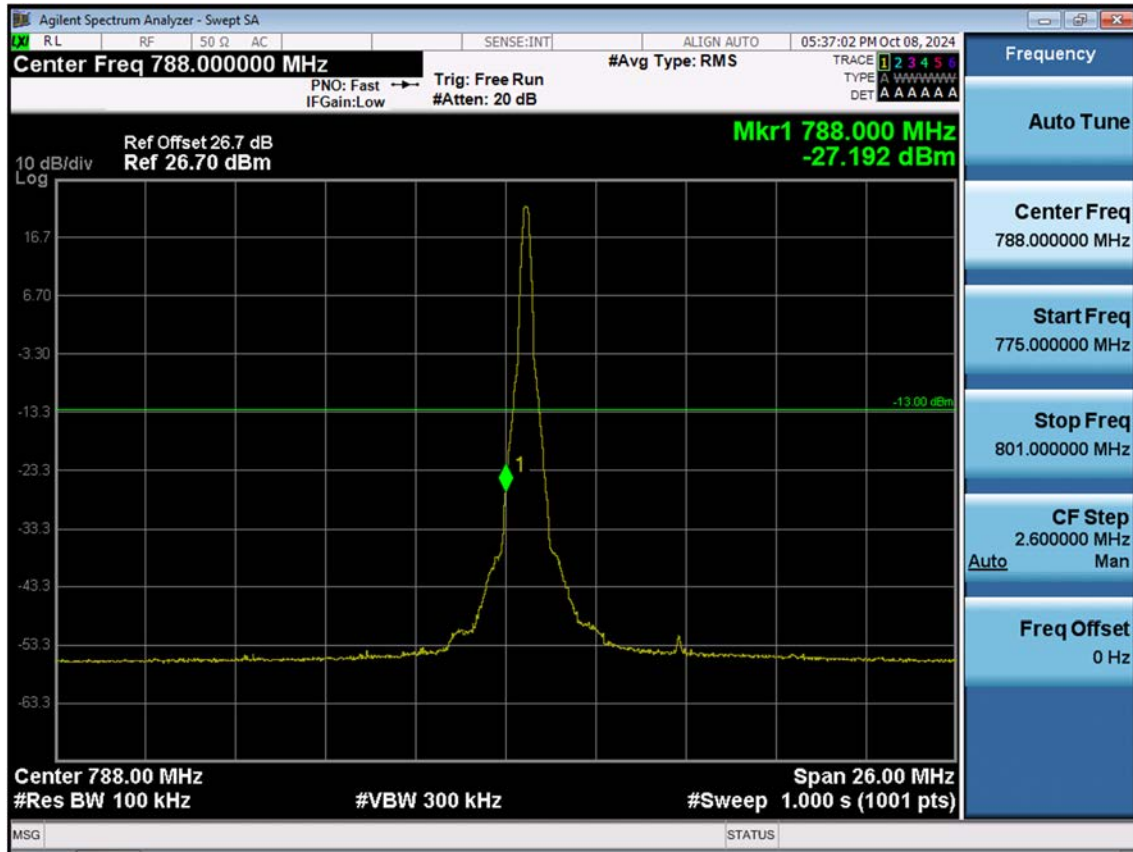
LTE B14_5 M_Extended Band Edge_High_QPSK_1RB



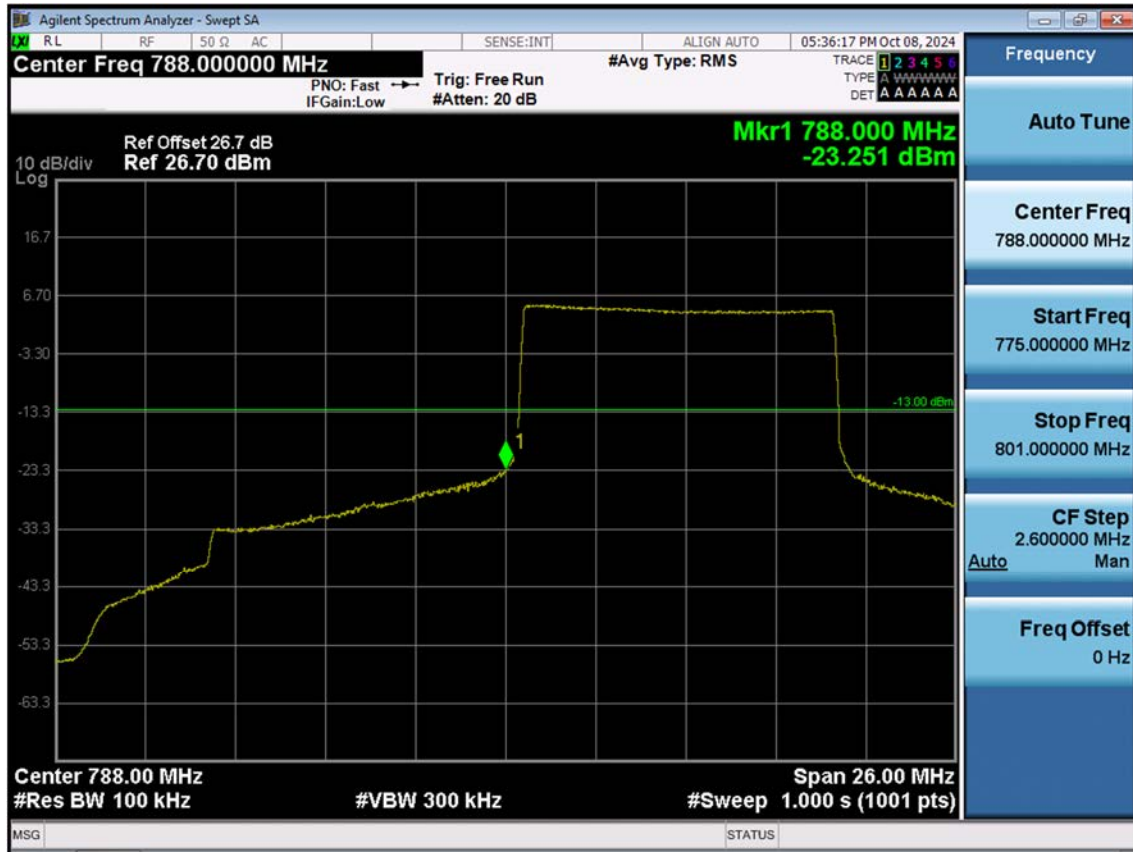
LTE B14_5 M_Extended Band Edge_High_QPSK_FullRB



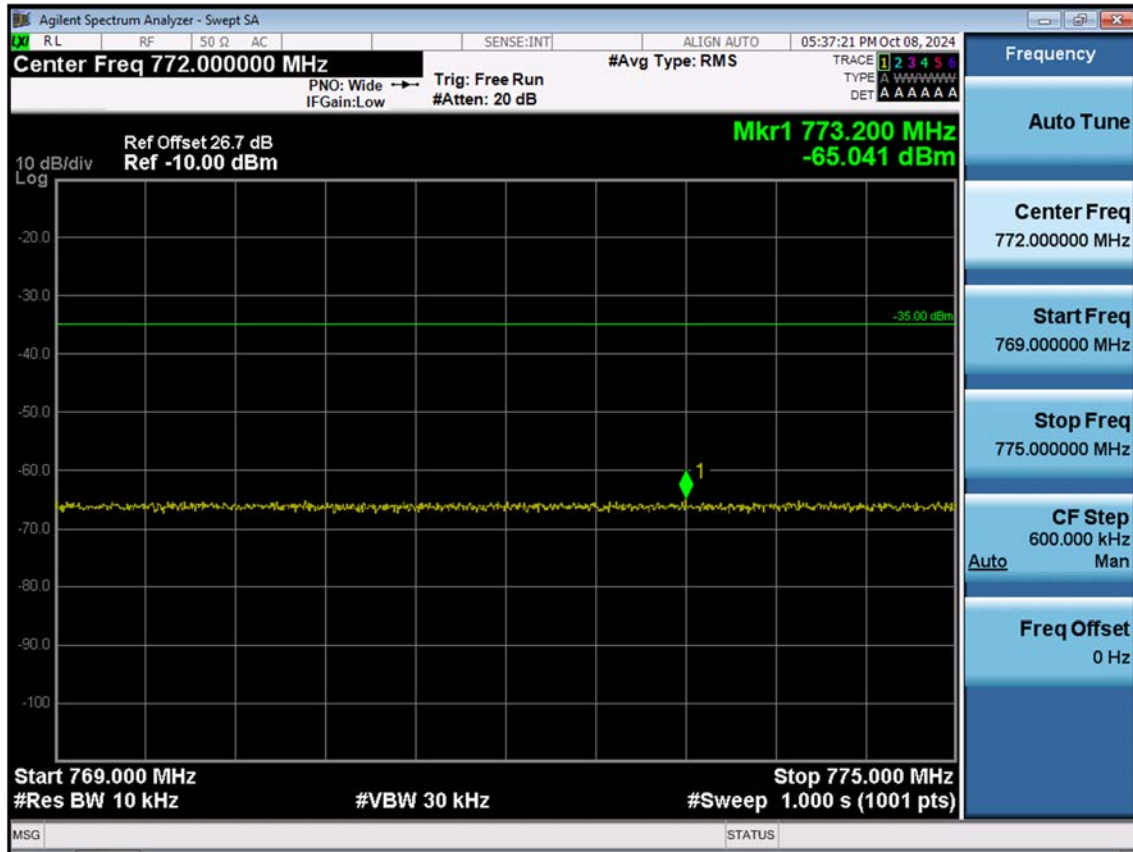
LTE B14_10 M_Band Edge_Low_QPSK_1RB



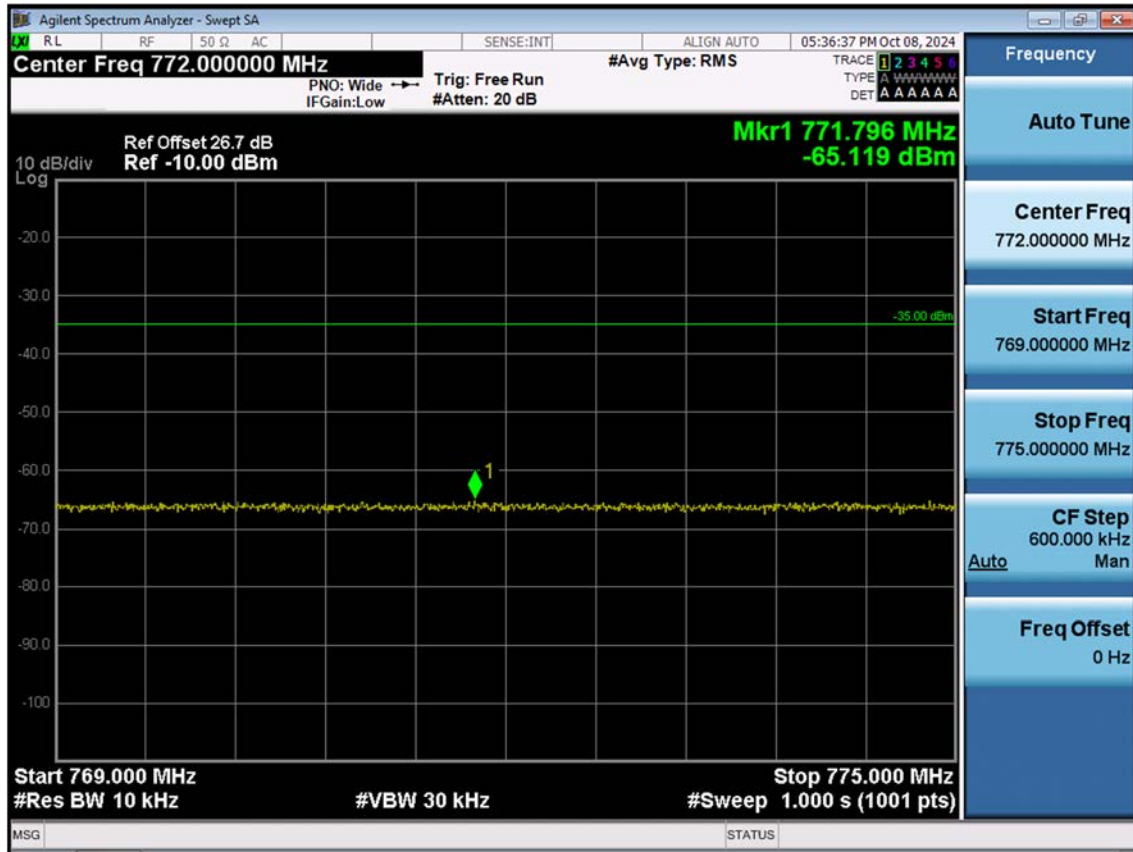
LTE B14_10 M_Band Edge_Low_QPSK_FullRB



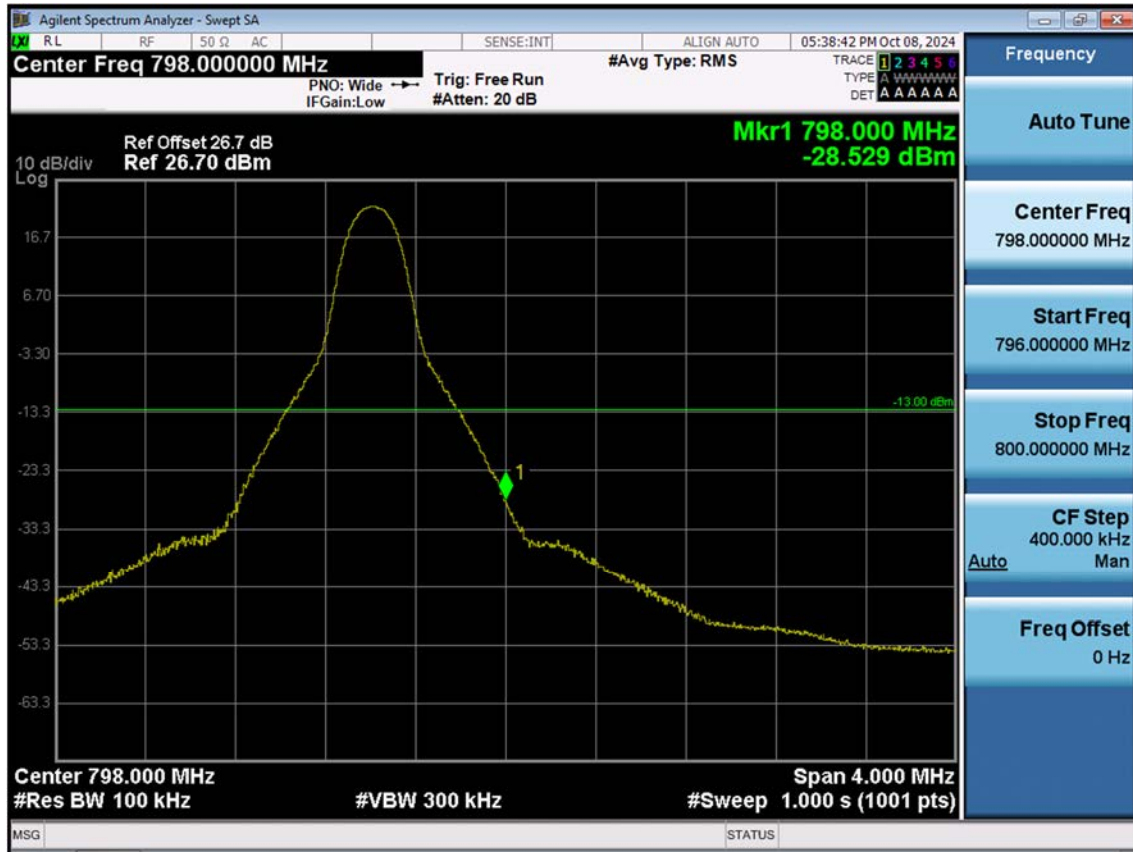
LTE B14_10 M_Extended Band Edge_Low_QPSK_1RB



LTE B14_10 M_Extended Band Edge_Low_QPSK_FullRB



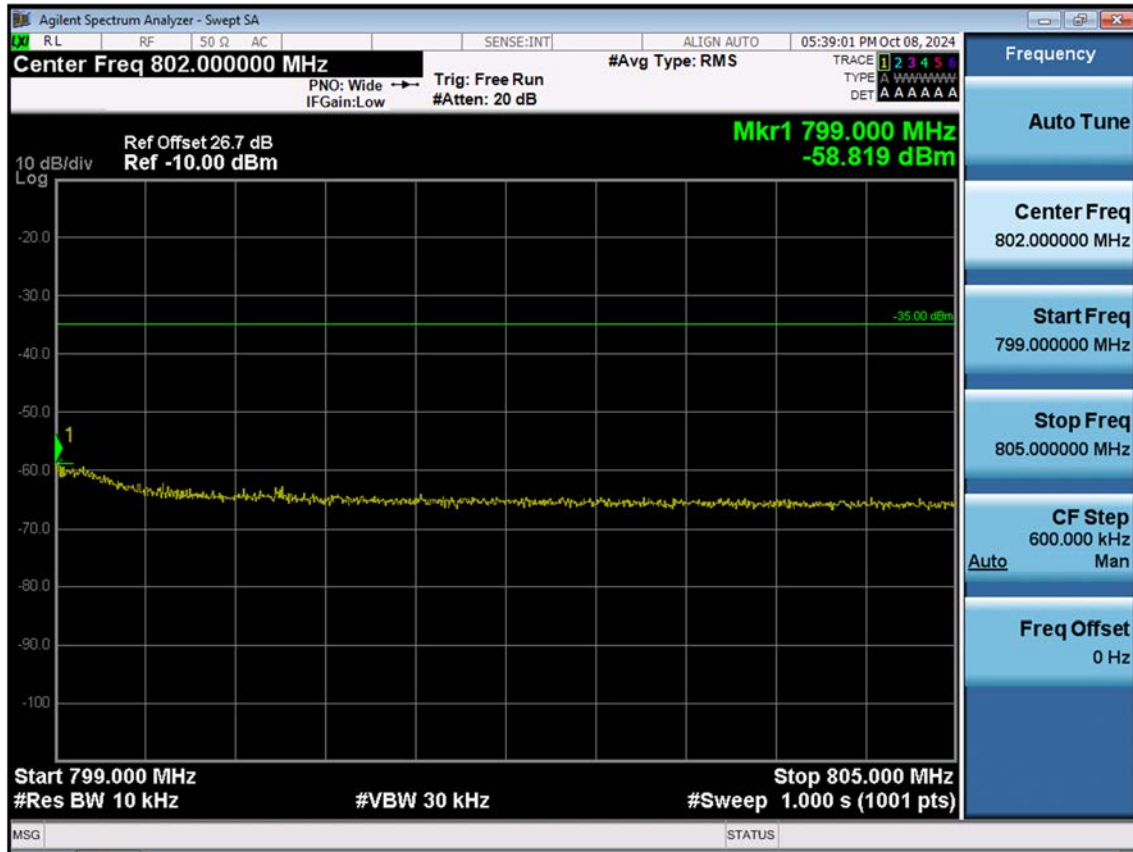
LTE B14_10 M_Band Edge_High_QPSK_1RB



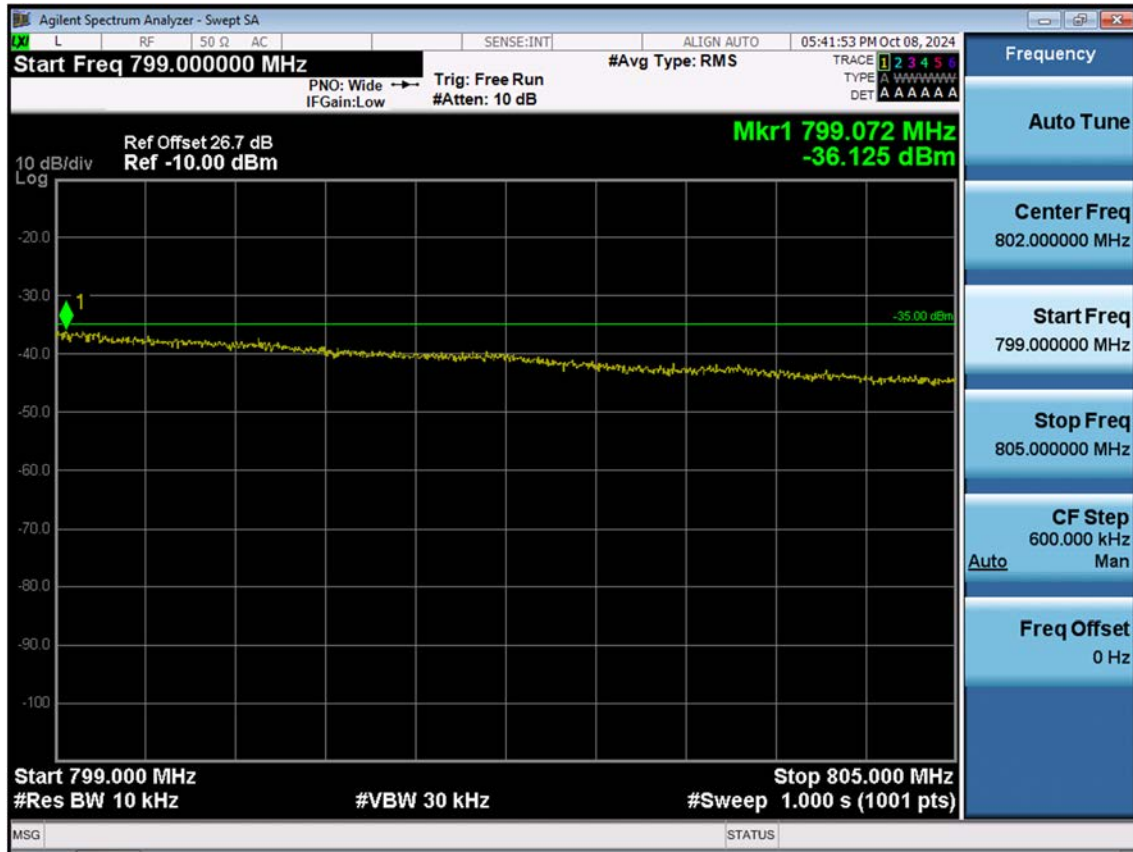
LTE B14_10 M_Band Edge_High_QPSK_FullRB



LTE B14_10 M_Extended Band Edge_High_QPSK_1RB



LTE B14_10 M_Extended Band Edge_High_QPSK_FullRB



12. ANNEX A_ TEST SETUP PHOTO

Please refer to test setup photo file no. as follows;

No.	Description
1	HCT-RF-2410-FC010-P